

## **Blackfin Embedded Processor**

## ADSP-BF504/ADSP-BF504F/ADSP-BF506F

#### **FEATURES**

Up to 400 MHz high performance Blackfin processor Two 16-bit MACs, two 40-bit ALUs, four 8-bit video ALUs, 40-bit shifter

RISC-like register and instruction model for ease of programming and compiler-friendly support

Advanced debug, trace, and performance monitoring

Accepts a range of supply voltages for internal and I/O operations. See Operating Conditions on Page 26

Internal 32M bit flash (available on ADSP-BF504F and ADSP-BF506F processors)

Internal ADC (available on ADSP-BF506F processor)

Off-chip voltage regulator interface

88-lead (12 mm imes 12 mm) LFCSP package for ADSP-BF504 and ADSP-BF504F processors

120-lead (14 mm × 14 mm) LQFP package for ADSP-BF506F processor

#### **MEMORY**

68K bytes of L1 SRAM (processor core-accessible) memory (See Table 1 on Page 3 for L1 and L3 memory size details)

External (interface-accessible) memory controller with glueless support for internal 32M bit flash and boot ROM

Flexible booting options from internal flash and SPI memory or from host devices including SPI, PPI, and UART

Memory management unit providing memory protection

#### **PERIPHERALS**

Two 32-bit up/down counters with rotary support Eight 32-bit timers/counters with PWM support

Two 3-phase 16-bit center-based PWM units

2 dual-channel, full-duplex synchronous serial ports (SPORTs), supporting eight stereo I<sup>2</sup>S channels

2 serial peripheral interface (SPI) compatible ports

2 UARTs with IrDA support

Parallel peripheral interface (PPI), supporting ITU-R 656 video data formats

Removable storage interface (RSI) controller for MMC, SD, SDIO, and CE-ATA

Internal ADC with 12 channels, 12 bits, and up to 2 MSPS

ADC controller module (ACM), providing a glueless interface between Blackfin processor and internal or external ADC

**Controller Area Network (CAN) controller** 

2-wire interface (TWI) controller

12 peripheral DMAs

2 memory-to-memory DMA channels

**Event handler with 52 interrupt inputs** 

35 general-purpose I/Os (GPIOs), with programmable hysteresis

Debug/JTAG interface

On-chip PLL capable of frequency multiplication

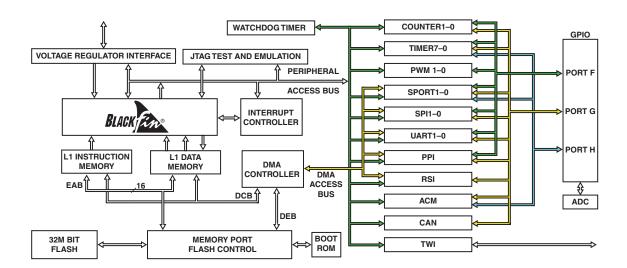


Figure 1. Processor Block Diagram

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| REVISION HISTORY   |   |       |
| 04/14—Rev. A to Rev. B   | Revised package diagram (Figure 93) to include U-Groo | ve in |
| Jpdated Development Tools  | Outline Dimensions                                    |       |
| Corrected RCKFE bit setting and description in                           | Package thickness changed from 0.75/0.80/0.85 to      |       |
| Table 9, The SPORTx Receive Configuration 1 Register                     | 0.75/0.85/0.90 in Figure 94 in Outline Dimensions     | 79    |
| SPORTx_RCR1)   |   |       |
| Jpdated footnote 6 in Operating Conditions                               |   |       |
| Updated Table 18 with revised data for static Current—IDD-DEEPSLEEP (mA) |   |       |

### **GENERAL DESCRIPTION**

The ADSP-BF50x processors are members of the Blackfin<sup>®</sup> family of products, incorporating the Analog Devices/Intel Micro Signal Architecture (MSA). Blackfin processors combine a dual-MAC state-of-the-art signal processing engine, the advantages of a clean, orthogonal RISC-like microprocessor instruction set, and single-instruction, multiple-data (SIMD) multimedia capabilities into a single instruction-set architecture.

The ADSP-BF50x processors are completely code compatible with other Blackfin processors. ADSP-BF50x processors offer performance up to 400 MHz and reduced static power consumption. Differences with respect to peripheral combinations are shown in Table 1.

**Table 1. Processor Comparison** 

|   | ADSP-BF504       | ADSP-BF504F      | ADSP-BF506F      |
|---|------------------|------------------|------------------|
| Feature   | ADS              | ADSI             | ADS              |
| Up/Down/Rotary Counters   | 2                | 2                | 2                |
| Timer/Counters with PWM   | 8                | 8                | 8                |
| 3-Phase PWM Units   | 2                | 2                | 2                |
| SPORTs  | 2                | 2                | 2                |
| SPIs  | 2                | 2                | 2                |
| UARTs   | 2                | 2                | 2                |
| Parallel Peripheral Interface   | 1                | 1                | 1                |
| Removable Storage Interface   | 1                | 1                | 1                |
| CAN   | 1                | 1                | 1                |
| TWI   | 1                | 1                | 1                |
| Internal 32M Bit Flash  | -                | 1                | 1                |
| ADC Control Module (ACM)  | 1                | 1                | 1                |
| Internal ADC  | -                | -                | 1                |
| GPIOs   | 35               | 35               | 35               |
| £1 Instruction SRAM   | 16K              | 16K              | 16K              |
| L1 Data SRAM/Cache L1 Data SRAM/Cache L1 Data SRAM/Cache L1 Data SRAM/Cache L1 Scratchpad | 16K              | 16K              | 16K              |
| £1 Data SRAM  | 16K              | 16K              | 16K              |
| ይ L1 Data SRAM/Cache  | 16K              | 16K              | 16K              |
| ਹੈ L1 Scratchpad  | 4K               | 4K               | 4K               |
| L3 Boot ROM   | 4K               | 4K               | 4K               |
| Maximum Speed Grade <sup>1</sup>  |                  | 400 MHz          |                  |
| Maximum System Clock Speed  |                  | 100 MHz          |                  |
| Package Options   | 88-Lead<br>LFCSP | 88-Lead<br>LFCSP | 120-Lead<br>LQFP |

<sup>&</sup>lt;sup>1</sup> For valid clock combinations, see Table 14, Table 15, Table 16, and Table 24.

By integrating a rich set of industry-leading system peripherals and memory, Blackfin processors are the platform of choice for next-generation applications that require RISC-like programmability, multimedia support, and leading-edge signal processing in one integrated package.

#### **PORTABLE LOW-POWER ARCHITECTURE**

Blackfin processors provide world-class power management and performance. They are produced with a low power and low voltage design methodology and feature on-chip dynamic power management, which provides the ability to vary both the voltage and frequency of operation to significantly lower overall power consumption. This capability can result in a substantial reduction in power consumption, compared with just varying the frequency of operation. This allows longer battery life for portable appliances.

#### SYSTEM INTEGRATION

The ADSP-BF50x processors are highly integrated system-on-achip solutions for the next generation of embedded industrial, instrumentation, and power/motion control applications. By combining industry-standard interfaces with a high performance signal processing core, cost-effective applications can be developed quickly, without the need for costly external components. The system peripherals include a watchdog timer; two 32-bit up/down counters with rotary support; eight 32-bit timers/counters with PWM support; six pairs of 3-phase 16-bit center-based PWM units; two dual-channel, full-duplex synchronous serial ports (SPORTs); two serial peripheral interface (SPI) compatible ports; two UARTs with IrDA® support; a parallel peripheral interface (PPI); a removable storage interface (RSI) controller; an internal ADC with 12 channels, 12 bits, up to 2 MSPS, and ACM controller; a controller area network (CAN) controller; a 2-wire interface (TWI) controller; and an internal 32M bit flash.

#### **PROCESSOR PERIPHERALS**

The ADSP-BF50x processors contain a rich set of peripherals connected to the core via several high-bandwidth buses, providing flexibility in system configuration as well as excellent overall system performance (see the block diagram on Page 1). These Blackfin processors contain high-speed serial and parallel ports, an interrupt controller for flexible management of interrupts from the on-chip peripherals or external sources, and power management control functions to tailor the performance and power characteristics of the processor and system to many application scenarios.

The SPORT, SPI, UART, PPI, and RSI peripherals are supported by a flexible DMA structure. There are also separate memory DMA channels dedicated to data transfers between the processor's various memory spaces, including boot ROM and internal 32M bit synchronous burst flash. Multiple on-chip buses running at up to 100 MHz provide enough bandwidth to keep the processor core running along with activity on all of the on-chip and external peripherals.

The ADSP-BF50x processors include an interface to an off-chip voltage regulator in support of the processor's dynamic power management capability.

#### **BLACKFIN PROCESSOR CORE**

As shown in Figure 2, the Blackfin processor core contains two 16-bit multipliers, two 40-bit accumulators, two 40-bit ALUs, four video ALUs, and a 40-bit shifter. The computation units process 8-, 16-, or 32-bit data from the register file.

The compute register file contains eight 32-bit registers. When performing compute operations on 16-bit operand data, the register file operates as 16 independent 16-bit registers. All operands for compute operations come from the multiported register file and instruction constant fields.

Each MAC can perform a 16-bit by 16-bit multiply in each cycle, accumulating the results into the 40-bit accumulators. Signed and unsigned formats, rounding, and saturation are supported.

The ALUs perform a traditional set of arithmetic and logical operations on 16-bit or 32-bit data. In addition, many special instructions are included to accelerate various signal processing tasks. These include bit operations such as field extract and population count, modulo  $2^{32}$  multiply, divide primitives, saturation and rounding, and sign/exponent detection. The set of video instructions include byte alignment and packing operations, 16-bit and 8-bit adds with clipping, 8-bit average operations,

and 8-bit subtract/absolute value/accumulate (SAA) operations. Also provided are the compare/select and vector search instructions.

For certain instructions, two 16-bit ALU operations can be performed simultaneously on register pairs (a 16-bit high half and 16-bit low half of a compute register). If the second ALU is used, quad 16-bit operations are possible.

The 40-bit shifter can perform shifts and rotates and is used to support normalization, field extract, and field deposit instructions.

The program sequencer controls the flow of instruction execution, including instruction alignment and decoding. For program flow control, the sequencer supports PC relative and indirect conditional jumps (with static branch prediction), and subroutine calls. Hardware is provided to support zero-overhead looping. The architecture is fully interlocked, meaning that the programmer need not manage the pipeline when executing instructions with data dependencies.

The address arithmetic unit provides two addresses for simultaneous dual fetches from memory. It contains a multiported register file consisting of four sets of 32-bit index, modify, length, and base registers (for circular buffering), and eight additional 32-bit pointer registers (for C-style indexed stack manipulation).

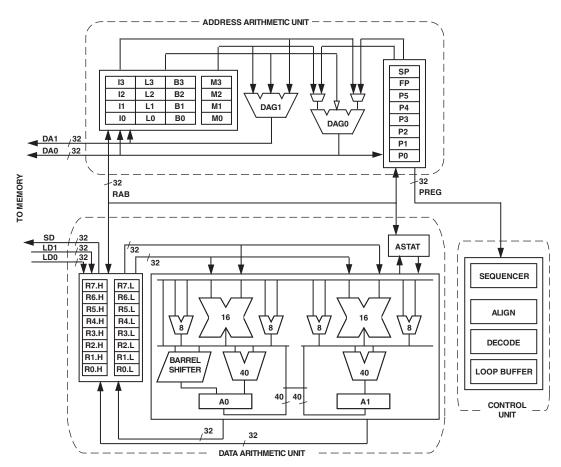


Figure 2. Blackfin Processor Core

Blackfin processors support a modified Harvard architecture in combination with a hierarchical memory structure. Level 1 (L1) memories are those that typically operate at the full processor speed with little or no latency. At the L1 level, the instruction memory holds instructions only. The data memory holds data, and a dedicated scratchpad data memory stores stack and local variable information.

In addition, multiple L1 memory blocks are provided, offering a configurable mix of SRAM and cache. The memory management unit (MMU) provides memory protection for individual tasks that may be operating on the core and can protect system registers from unintended access.

The architecture provides three modes of operation: user mode, supervisor mode, and emulation mode. User mode has restricted access to certain system resources, thus providing a protected software environment, while supervisor mode has unrestricted access to the system and core resources.

The Blackfin processor instruction set has been optimized so that 16-bit opcodes represent the most frequently used instructions, resulting in excellent compiled code density. Complex DSP instructions are encoded into 32-bit opcodes, representing fully featured multifunction instructions. Blackfin processors support a limited multi-issue capability, where a 32-bit instruction can be issued in parallel with two 16-bit instructions, allowing the programmer to use many of the core resources in a single instruction cycle.

The Blackfin processor assembly language uses an algebraic syntax for ease of coding and readability. The architecture has been optimized for use in conjunction with the C/C++ compiler, resulting in fast and efficient software implementations.

#### **MEMORY ARCHITECTURE**

The Blackfin processor views memory as a single unified 4G byte address space, using 32-bit addresses. All resources, including internal memory, external memory, and I/O control registers, occupy separate sections of this common address space. The memory portions of this address space are arranged in a hierarchical structure to provide a good cost/performance balance of some very fast, low latency core-accessible memory as cache or SRAM and to provide larger, lower cost and performance interface-accessible memory systems. See Figure 3.

The core-accessible L1 memory system is the highest performance memory available to the Blackfin processor. The interface-accessible memory system, accessed through the external bus interface unit (EBIU), provides access to the internal flash memory and boot ROM.

The memory DMA controller provides high bandwidth data movement capability. It can perform block transfers of code or data between the internal memory and the external memory spaces.

#### Internal (Core-Accessible) Memory

The processor has three blocks of core-accessible memory, providing high-bandwidth access to the core.

The first block is the L1 instruction memory, consisting of 32K bytes SRAM, of which 16K bytes can be configured as a four-way set-associative cache. This memory is accessed at full processor speed.

The second core-accessible memory block is the L1 data memory, consisting of 32K bytes of SRAM, of which 16K bytes may be configured as cache. This memory block is accessed at full processor speed.

The third memory block is 4K bytes of scratchpad SRAM, which runs at the same speed as the L1 memories, but this memory is only accessible as data SRAM and cannot be configured as cache memory.

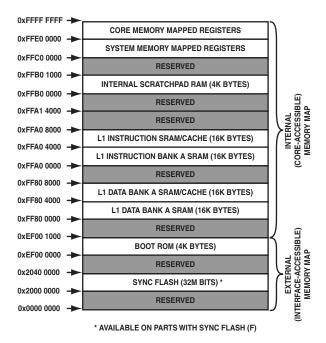


Figure 3. Internal/External Memory Map

#### External (Interface-Accessible) Memory

External memory is accessed via the EBIU memory port. This 16-bit interface provides a glueless connection to the internal flash memory and boot ROM. Internal flash memory ships from the factory in an erased state except for Block 0 of the parameter bank. Block 0 of the Flash memory parameter bank ships from the factory in an unknown state. An erase operation should be performed prior to programming this block.

#### **I/O Memory Space**

The processor does not define a separate I/O space. All resources are mapped through the flat 32-bit address space. On-chip I/O devices have their control registers mapped into memory-mapped registers (MMRs) at addresses near the top of the 4G byte address space. These are separated into two smaller blocks. One contains the control MMRs for all core functions, and the other contains the registers needed for setup and control of the on-chip peripherals outside of the core. The MMRs are accessible only in supervisor and emulation modes and appear as reserved space to on-chip peripherals.

#### **Booting**

The processor contains a small on-chip boot kernel, which configures the appropriate peripheral for booting. If the processor is configured to boot from boot ROM memory space, the processor starts executing from the on-chip boot ROM. For more information, see Booting Modes on Page 16.

#### **Event Handling**

The event controller on the processor handles all asynchronous and synchronous events to the processor. The processor provides event handling that supports both nesting and prioritization. Nesting allows multiple event service routines to be active simultaneously. Prioritization ensures that servicing of a higher priority event takes precedence over servicing of a lower priority event. The controller provides support for five different types of events:

- Emulation—An emulation event causes the processor to enter emulation mode, allowing command and control of the processor via the JTAG interface.
- Reset—This event resets the processor.
- Nonmaskable Interrupt (NMI)—The NMI event can be generated either by the software watchdog timer, by the NMI input signal to the processor, or by software. The NMI event is frequently used as a power-down indicator to initiate an orderly shutdown of the system.
- Exceptions—Events that occur synchronously to program flow (in other words, the exception is taken before the instruction is allowed to complete). Conditions such as data alignment violations and undefined instructions cause exceptions.
- Interrupts—Events that occur asynchronously to program flow. They are caused by input signals, timers, and other peripherals, as well as by an explicit software instruction.

Each event type has an associated register to hold the return address and an associated return-from-event instruction. When an event is triggered, an interrupt service routine (ISR) must save the state of the processor to the supervisor stack.

The processor event controller consists of two stages: the core event controller (CEC) and the system interrupt controller (SIC). The core event controller works with the system interrupt controller to prioritize and control all system events. Conceptually, interrupts from the peripherals enter into the SIC and are then routed directly into the general-purpose interrupts of the CEC.

#### **Core Event Controller (CEC)**

The CEC supports nine general-purpose interrupts (IVG15–7), in addition to the dedicated interrupt and exception events. Of these general-purpose interrupts, the two lowest-priority interrupts (IVG15–14) are recommended to be reserved for software interrupt handlers, leaving seven prioritized interrupt

inputs to support the peripherals of the processor. Table 2 describes the inputs to the CEC, identifies their names in the event vector table (EVT), and lists their priorities.

Table 2. Core Event Controller (CEC)

| Priority       |                              |                  |
|----------------|------------------------------|------------------|
| (0 is Highest) | <b>Event Class</b>           | <b>EVT Entry</b> |
| 0              | Emulation/Test Control       | EMU              |
| 1              | Reset                        | RST              |
| 2              | Nonmaskable Interrupt        | NMI              |
| 3              | Exception                    | EVX              |
| 4              | Reserved                     | _                |
| 5              | Hardware Error               | IVHW             |
| 6              | Core Timer                   | IVTMR            |
| 7              | General-Purpose Interrupt 7  | IVG7             |
| 8              | General-Purpose Interrupt 8  | IVG8             |
| 9              | General-Purpose Interrupt 9  | IVG9             |
| 10             | General-Purpose Interrupt 10 | IVG10            |
| 11             | General-Purpose Interrupt 11 | IVG11            |
| 12             | General-Purpose Interrupt 12 | IVG12            |
| 13             | General-Purpose Interrupt 13 | IVG13            |
| 14             | General-Purpose Interrupt 14 | IVG14            |
| 15             | General-Purpose Interrupt 15 | IVG15            |

#### System Interrupt Controller (SIC)

The system interrupt controller provides the mapping and routing of events from the many peripheral interrupt sources to the prioritized general-purpose interrupt inputs of the CEC. Although the processor provides a default mapping, the user can alter the mappings and priorities of interrupt events by writing the appropriate values into the interrupt assignment registers (SIC\_IARx). Table 3 describes the inputs into the SIC and the default mappings into the CEC.

Table 3. System Interrupt Controller (SIC)

| Peripheral Interrupt Source | General-Purpose<br>Interrupt (at Reset) | Peripheral<br>Interrupt ID | Default Core<br>Interrupt ID |      | SIC Registers      |
|-----------------------------|---|----------------------------|------------------------------|------|--------------------|
| PLL Wakeup Interrupt        | IVG7                                    | 0                          | 0                            | IAR0 | IMASKO, ISRO, IWRO |
| DMA Error (generic)         | IVG7                                    | 1                          | 0                            | IAR0 | IMASKO, ISRO, IWRO |
| PPI Status                  | IVG7                                    | 2                          | 0                            | IAR0 | IMASKO, ISRO, IWRO |
| SPORT0 Status               | IVG7                                    | 3                          | 0                            | IAR0 | IMASKO, ISRO, IWRO |
| SPORT1 Status               | IVG7                                    | 4                          | 0                            | IARO | IMASKO, ISRO, IWRO |
| UARTO Status                | IVG7                                    | 5                          | 0                            | IARO | IMASKO, ISRO, IWRO |
| UART1 Status                | IVG7                                    | 6                          | 0                            | IARO | IMASKO, ISRO, IWRO |
| SPI0 Status                 | IVG7                                    | 7                          | 0                            | IARO | IMASKO, ISRO, IWRO |
| SPI1 Status                 | IVG7                                    | 8                          | 0                            | IAR1 | IMASKO, ISRO, IWRO |
| CAN Status                  | IVG7                                    | 9                          | 0                            | IAR1 | IMASKO, ISRO, IWRO |
| RSI Mask 0 Interrupt        | IVG7                                    | 10                         | 0                            | IAR1 | IMASKO, ISRO, IWRO |
| Reserved                    | _                                       | 11                         | _                            | IAR1 | IMASKO, ISRO, IWRO |
| CNT0 Interrupt              | IVG8                                    | 12                         | 1                            | IAR1 | IMASKO, ISRO, IWRO |
| CNT1 Interrupt              | IVG8                                    | 13                         | 1                            | IAR1 | IMASKO, ISRO, IWRO |
| DMA Channel 0 (PPI Rx/Tx)   | IVG9                                    | 14                         | 2                            | IAR1 | IMASKO, ISRO, IWRO |
| DMA Channel 1 (RSI Rx/Tx)   | IVG9                                    | 15                         | 2                            | IAR1 | IMASKO, ISRO, IWRO |
| DMA Channel 2 (SPORT0 Rx)   | IVG9                                    | 16                         | 2                            | IAR2 | IMASKO, ISRO, IWRO |
| DMA Channel 3 (SPORT0 Tx)   | IVG9                                    | 17                         | 2                            | IAR2 | IMASKO, ISRO, IWRO |
| DMA Channel 4 (SPORT1 Rx)   | IVG9                                    | 18                         | 2                            | IAR2 | IMASKO, ISRO, IWRO |
| DMA Channel 5 (SPORT1 Tx)   | IVG9                                    | 19                         | 2                            | IAR2 | IMASKO, ISRO, IWRO |
| DMA Channel 6 (SPI0 Rx/Tx)  | IVG10                                   | 20                         | 3                            | IAR2 | IMASKO, ISRO, IWRO |
| DMA Channel 7 (SPI1 Rx/Tx)  | IVG10                                   | 21                         | 3                            | IAR2 | IMASKO, ISRO, IWRO |
| DMA Channel 8 (UARTO Rx)    | IVG10                                   | 22                         | 3                            | IAR2 | IMASKO, ISRO, IWRO |
| DMA Channel 9 (UART0 Tx)    | IVG10                                   | 23                         | 3                            | IAR2 | IMASKO, ISRO, IWRO |
| DMA Channel 10 (UART1 Rx)   | IVG10                                   | 24                         | 3                            | IAR3 | IMASKO, ISRO, IWRO |
| DMA Channel 11 (UART1 Tx)   | IVG10                                   | 25                         | 3                            | IAR3 | IMASKO, ISRO, IWRO |
| CAN Receive                 | IVG11                                   | 26                         | 4                            | IAR3 | IMASKO, ISRO, IWRO |
| CAN Transmit                | IVG11                                   | 27                         | 4                            | IAR3 | IMASKO, ISRO, IWRO |
| TWI                         | IVG11                                   | 28                         | 4                            | IAR3 | IMASKO, ISRO, IWRO |
| Port F Interrupt A          | IVG11                                   | 29                         | 4                            | IAR3 | IMASKO, ISRO, IWRO |
| Port F Interrupt B          | IVG11                                   | 30                         | 4                            | IAR3 | IMASKO, ISRO, IWRO |
| Reserved                    | _                                       | 31                         | _                            | IAR3 | IMASKO, ISRO, IWRO |
| Timer 0                     | IVG12                                   | 32                         | 5                            | IAR4 | IMASK1, ISR1, IWR1 |
| Timer 1                     | IVG12                                   | 33                         | 5                            | IAR4 | IMASK1, ISR1, IWR1 |
| Timer 2                     | IVG12                                   | 34                         | 5                            | IAR4 | IMASK1, ISR1, IWR1 |
| Timer 3                     | IVG12                                   | 35                         | 5                            | IAR4 | IMASK1, ISR1, IWR1 |
| Timer 4                     | IVG12                                   | 36                         | 5                            | IAR4 | IMASK1, ISR1, IWR1 |
| Timer 5                     | IVG12                                   | 37                         | 5                            | IAR4 | IMASK1, ISR1, IWR1 |
| Timer 6                     | IVG12                                   | 38                         | 5                            | IAR4 | IMASK1, ISR1, IWR1 |
| Timer 7                     | IVG12                                   | 39                         | 5                            | IAR4 | IMASK1, ISR1, IWR1 |
| Port G Interrupt A          | IVG12                                   | 40                         | 5                            | IAR5 | IMASK1, ISR1, IWR1 |
| Port G Interrupt B          | IVG12                                   | 41                         | 5                            | IAR5 | IMASK1, ISR1, IWR1 |
| MDMA Stream 0               | IVG13                                   | 42                         | 6                            | IAR5 | IMASK1, ISR1, IWR1 |

Table 3. System Interrupt Controller (SIC) (Continued)

| Peripheral Interrupt Source | General-Purpose<br>Interrupt (at Reset) | Peripheral<br>Interrupt ID | Default Core<br>Interrupt ID |      | SIC Registers      |
|-----------------------------|---|----------------------------|------------------------------|------|--------------------|
| MDMA Stream 1               | IVG13                                   | 43                         | 6                            | IAR5 | IMASK1, ISR1, IWR1 |
| Software Watchdog Timer     | IVG13                                   | 44                         | 6                            | IAR5 | IMASK1, ISR1, IWR1 |
| Port H Interrupt A          | IVG13                                   | 45                         | 6                            | IAR5 | IMASK1, ISR1, IWR1 |
| Port H Interrupt B          | IVG13                                   | 46                         | 6                            | IAR5 | IMASK1, ISR1, IWR1 |
| ACM Status Interrupt        | IVG7                                    | 47                         | 0                            | IAR5 | IMASK1, ISR1, IWR1 |
| ACM Interrupt               | IVG10                                   | 48                         | 3                            | IAR6 | IMASK1, ISR1, IWR1 |
| Reserved                    | _                                       | 49                         | _                            | IAR6 | IMASK1, ISR1, IWR1 |
| Reserved                    | _                                       | 50                         | _                            | IAR6 | IMASK1, ISR1, IWR1 |
| PWM0 Trip Interrupt         | IVG10                                   | 51                         | 3                            | IAR6 | IMASK1, ISR1, IWR1 |
| PWM0 Sync Interrupt         | IVG10                                   | 52                         | 3                            | IAR6 | IMASK1, ISR1, IWR1 |
| PWM1 Trip Interrupt         | IVG10                                   | 53                         | 3                            | IAR6 | IMASK1, ISR1, IWR1 |
| PWM1 Sync Interrupt         | IVG10                                   | 54                         | 3                            | IAR6 | IMASK1, ISR1, IWR1 |
| RSI Mask 1 Interrupt        | IVG10                                   | 55                         | 3                            | IAR6 | IMASK1, ISR1, IWR1 |
| Reserved                    | _                                       | 56 through 63              | _                            | _    | IMASK1, ISR1, IWR1 |

#### **Event Control**

The processor provides a very flexible mechanism to control the processing of events. In the CEC, three registers are used to coordinate and control events. Each register is 16 bits wide.

- CEC interrupt latch register (ILAT)—Indicates when
  events have been latched. The appropriate bit is set when
  the processor has latched the event and is cleared when the
  event has been accepted into the system. This register is
  updated automatically by the controller, but it may be written only when its corresponding IMASK bit is cleared.
- CEC interrupt mask register (IMASK)—Controls the
  masking and unmasking of individual events. When a bit is
  set in the IMASK register, that event is unmasked and is
  processed by the CEC when asserted. A cleared bit in the
  IMASK register masks the event, preventing the processor
  from servicing the event even though the event may be
  latched in the ILAT register. This register may be read or
  written while in supervisor mode. (Note that generalpurpose interrupts can be globally enabled and disabled
  with the STI and CLI instructions, respectively.)
- CEC interrupt pending register (IPEND)—The IPEND
  register keeps track of all nested events. A set bit in the
  IPEND register indicates the event is currently active or
  nested at some level. This register is updated automatically
  by the controller but may be read while in supervisor mode.

The SIC allows further control of event processing by providing three pairs of 32-bit interrupt control and status registers. Each register contains a bit, corresponding to each of the peripheral interrupt events shown in Table 3 on Page 7.

 SIC interrupt mask registers (SIC\_IMASKx)—Control the masking and unmasking of each peripheral interrupt event.
 When a bit is set in these registers, the corresponding peripheral event is unmasked and is forwarded to the CEC

- when asserted. A cleared bit in these registers masks the corresponding peripheral event, preventing the event from propagating to the CEC.
- SIC interrupt status registers (SIC\_ISRx)—As multiple
  peripherals can be mapped to a single event, these registers
  allow the software to determine which peripheral event
  source triggered the interrupt. A set bit indicates that the
  peripheral is asserting the interrupt, and a cleared bit indicates that the peripheral is not asserting the event.
- SIC interrupt wakeup enable registers (SIC\_IWRx)—By enabling the corresponding bit in these registers, a peripheral can be configured to wake up the processor should the core be idled or in sleep mode when the event is generated. For more information, see Dynamic Power Management on Page 13.

Because multiple interrupt sources can map to a single generalpurpose interrupt, multiple pulse assertions can occur simultaneously, before or during interrupt processing for an interrupt event already detected on this interrupt input. The IPEND register contents are monitored by the SIC as the interrupt acknowledgement.

The appropriate ILAT register bit is set when an interrupt rising edge is detected (detection requires two core clock cycles). The bit is cleared when the respective IPEND register bit is set. The IPEND bit indicates that the event has entered into the processor pipeline. At this point the CEC recognizes and queues the next rising edge event on the corresponding event input. The minimum latency from the rising edge transition of the general-purpose interrupt to the IPEND output asserted is three core clock cycles; however, the latency can be much higher, depending on the activity within and the state of the processor.

#### **FLASH MEMORY**

The ADSP-BF504F and ADSP-BF506F processors include an on-chip 32M bit (×16, multiple bank, burst) Flash memory. The features of this memory include:

- Synchronous/asynchronous read
  - · Synchronous burst read mode: 50 MHz
  - · Asynchronous/synchronous read mode
  - Random access times: 70 ns
- · Synchronous burst read suspend
- Memory blocks
  - · Multiple bank memory array: 4M bit banks
  - Parameter blocks (top location)
- Dual operations
  - Program erase in one bank while read in others
  - No delay between read and write operations
- · Block locking
  - All blocks locked at power-up
  - Any combination of blocks can be locked or locked down
- Security
  - 128-bit user programmable OTP cells
  - 64-bit unique device number
- Common Flash interface (CFI)
- 100,000 program/erase cycles per block

Flash memory ships from the factory in an erased state *except* for block 0 of the parameter bank. Block 0 of the Flash memory parameter bank ships from the factory in an unknown state. An erase operation should be performed prior to programming this block.

#### **DMA CONTROLLERS**

The processor has multiple, independent DMA channels that support automated data transfers with minimal overhead for the processor's core. DMA transfers can occur between the processor's internal memories and any of its DMA-capable peripherals. Additionally, DMA transfers can be accomplished between any of the DMA-capable peripherals and external devices connected to the external memory interface. DMA-capable peripherals include the SPORTs, SPI ports, UARTs, RSI, and PPI. Each individual DMA-capable peripheral has at least one dedicated DMA channel.

The processor DMA controller supports both one-dimensional (1-D) and two-dimensional (2-D) DMA transfers. DMA transfer initialization can be implemented from registers or from sets of parameters called descriptor blocks.

The 2-D DMA capability supports arbitrary row and column sizes up to 64K elements by 64K elements, and arbitrary row and column step sizes up to  $\pm 32$ K elements. Furthermore, the column step size can be less than the row step size, allowing

implementation of interleaved data streams. This feature is especially useful in video applications where data can be deinterleaved on the fly.

Examples of DMA types supported by the processor DMA controller include:

- A single, linear buffer that stops upon completion
- A circular, auto-refreshing buffer that interrupts on each full or fractionally full buffer
- 1-D or 2-D DMA using a linked list of descriptors
- 2-D DMA using an array of descriptors, specifying only the base DMA address within a common page

In addition to the dedicated peripheral DMA channels, there are two memory DMA channels, which are provided for transfers between the various memories of the processor system with minimal processor intervention. Memory DMA transfers can be controlled by a very flexible descriptor-based methodology or by a standard register-based autobuffer mechanism.

#### **WATCHDOG TIMER**

The processor includes a 32-bit timer that can be used to implement a software watchdog function. A software watchdog can improve system availability by forcing the processor to a known state through generation of a core and system reset, nonmaskable interrupt (NMI), or general-purpose interrupt, if the timer expires before being reset by software. The programmer initializes the count value of the timer, enables the appropriate interrupt, then enables the timer. Thereafter, the software must reload the counter before it counts to zero from the programmed value. This protects the system from remaining in an unknown state where software, which would normally reset the timer, has stopped running due to an external noise condition or software error.

If configured to generate a reset, the watchdog timer resets both the core and the processor peripherals. After a reset, software can determine whether the watchdog was the source of the hardware reset by interrogating a status bit in the watchdog timer control register.

The timer is clocked by the system clock (SCLK) at a maximum frequency of  $f_{\text{SCLK}}$ .

#### **TIMERS**

There are nine general-purpose programmable timer units in the processors. Eight timers have an external pin that can be configured either as a pulse width modulator (PWM) or timer output, as an input to clock the timer, or as a mechanism for measuring pulse widths and periods of external events. These timers can be synchronized to an external clock input to the several other associated PF pins, to an external clock input to the PPI\_CLK input pin, or to the internal SCLK.

The timer units can be used in conjunction with the two UARTs to measure the width of the pulses in the data stream to provide a software auto-baud detect function for the respective serial channels.

The timers can generate interrupts to the processor core providing periodic events for synchronization, either to the system clock or to a count of external signals.

In addition to the eight general-purpose programmable timers, a ninth timer is also provided. This extra timer is clocked by the internal processor clock and is typically used as a system tick clock for generation of operating system periodic interrupts.

## UP/DOWN COUNTERS AND THUMBWHEEL INTERFACES

Two 32-bit up/down counters are provided that can sense 2-bit quadrature or binary codes as typically emitted by industrial drives or manual thumbwheels. The counters can also operate in general-purpose up/down count modes. Then, count direction is either controlled by a level-sensitive input pin or by two edge detectors.

A third counter input can provide flexible zero marker support and can alternatively be used to input the push-button signal of thumb wheels. All three pins have a programmable debouncing circuit.

Internal signals forwarded to each timer unit enable these timers to measure the intervals between count events. Boundary registers enable auto-zero operation or simple system warning by interrupts when programmable count values are exceeded.

#### **3-PHASE PWM UNITS**

The two/dual 3-phase PWM generation units each feature:

- · 16-bit center-based PWM generation unit
- Programmable PWM pulse width
- Single/double update modes
- Programmable dead time and switching frequency
- Twos-complement implementation which permits smooth transition to full ON and full OFF states
- Possibility to synchronize the PWM generation to either externally-generated or internally-generated synchronization pulses
- Special provisions for BDCM operation (crossover and output enable functions)
- Wide variety of special switched reluctance (SR) operating modes
- Output polarity and clock gating control
- Dedicated asynchronous PWM shutdown signal

Each PWM block integrates a flexible and programmable 3-phase PWM waveform generator that can be programmed to generate the required switching patterns to drive a 3-phase voltage source inverter for ac induction motor (ACIM) or permanent magnet synchronous motor (PMSM) control. In addition, the PWM block contains special functions that considerably simplify the generation of the required PWM switching patterns for control of the electronically commutated motor (ECM) or brushless dc motor (BDCM). Software can enable a special mode for switched reluctance motors (SRM).

The six PWM output signals (per PWM unit) consist of three high-side drive signals (PWMx\_AH, PWMx\_BH, and PWMx\_CH) and three low-side drive signals (PWMx\_AL, PWMx\_BL, and PWMx\_CL). The polarity of the generated PWM signal can be set with software, so that either active HI or active LO PWM patterns can be produced.

The switching frequency of the generated PWM pattern is programmable using the 16-bit PWM\_TM register. The PWM generator can operate in single update mode or double update mode. In single update mode, the duty cycle values are programmable only once per PWM period, so that the resultant PWM patterns are symmetrical about the midpoint of the PWM period. In the double update mode, a second updating of the PWM registers is implemented at the midpoint of the PWM period. In this mode, it is possible to produce asymmetrical PWM patterns that produce lower harmonic distortion in 3-phase PWM inverters.

Pulses synchronous to the switching frequency can be generated internally and output on the PWMx\_SYNC pin. The PWM unit can also accept externally generated synchronization pulses through PWMx\_SYNC.

Each PWM unit features a dedicated asynchronous shutdown pin, PWMx\_TRIP, which (when brought low) instantaneously places all six PWM outputs in the OFF state.

#### **SERIAL PORTS**

The processors incorporate two dual-channel synchronous serial ports (SPORT0 and SPORT1) for serial and multiprocessor communications. The SPORTs support the following features:

- I<sup>2</sup>S capable operation.
- Bidirectional operation—Each SPORT has two sets of independent transmit and receive pins, enabling eight channels of I<sup>2</sup>S stereo audio.
- Buffered (8-deep) transmit and receive ports—Each port has a data register for transferring data words to and from other processor components and shift registers for shifting data in and out of the data registers.
- Clocking—Each transmit and receive port can either use an external serial clock or generate its own, in frequencies ranging from (f<sub>SCLK</sub>/131,070) Hz to (f<sub>SCLK</sub>/2) Hz.
- Word length—Each SPORT supports serial data words from 3 to 32 bits in length, transferred most significant bit first or least significant bit first.
- Framing—Each transmit and receive port can run with or without frame sync signals for each data word. Frame sync signals can be generated internally or externally, active high or low, and with either of two pulse widths and early or late frame sync.
- Companding in hardware—Each SPORT can perform
   A-law or μ-law companding according to ITU recommendation G.711. Companding can be selected on the transmit and/or receive channel of the SPORT without additional latencies.

- DMA operations with single-cycle overhead—Each SPORT can automatically receive and transmit multiple buffers of memory data. The processor can link or chain sequences of DMA transfers between a SPORT and memory.
- Interrupts—Each transmit and receive port generates an interrupt upon completing the transfer of a data word or after transferring an entire data buffer, or buffers, through DMA.
- Multichannel capability—Each SPORT supports 128 channels out of a 1024-channel window and is compatible with the H.100, H.110, MVIP-90, and HMVIP standards.

#### **SERIAL PERIPHERAL INTERFACE (SPI) PORTS**

The ADSP-BF50x processors have two SPI-compatible ports that enable the processor to communicate with multiple SPI-compatible devices.

The SPI interface uses three pins for transferring data: two data pins MOSI (Master Output-Slave Input) and MISO (Master Input-Slave Output) and a clock pin, serial clock (SCK). An SPI chip select input pin (\$\overline{SPIx}\_S\overline{S}\$) lets other SPI devices select the processor, and three SPI chip select output pins (\$\overline{SPIx}\_S\overline{SEL3}\_1\$) let the processor select other SPI devices. The SPI select pins are reconfigured general-purpose I/O pins. Using these pins, the SPI port provides a full-duplex, synchronous serial interface, which supports both master/slave modes and multimaster environments.

The SPI port's baud rate and clock phase/polarities are programmable, and it has an integrated DMA channel, configurable to support transmit or receive data streams. The SPI's DMA channel can only service unidirectional accesses at any given time.

The SPI port's clock rate is calculated as:

$$SPI\ Clock\ Rate = \frac{f_{SCLK}}{2 \times SPI\_BAUD}$$

Where the 16-bit SPI\_BAUD register contains a value of 2 to 65,535.

During transfers, the SPI port simultaneously transmits and receives by serially shifting data in and out on its two serial data lines. The serial clock line synchronizes the shifting and sampling of data on the two serial data lines.

#### **UART PORTS (UARTS)**

The ADSP-BF50x Blackfin processors provide two full-duplex universal asynchronous receiver/transmitter (UART) ports. Each UART port provides a simplified UART interface to other peripherals or hosts, enabling full-duplex, DMA-supported, asynchronous transfers of serial data. A UART port includes

support for five to eight data bits; one or two stop bits; and none, even, or odd parity. Each UART port supports two modes of operation:

- PIO (programmed I/O). The processor sends or receives data by writing or reading I/O-mapped UART registers.
   The data is double-buffered on both transmit and receive.
- DMA (direct memory access). The DMA controller transfers both transmit and receive data. This reduces the number and frequency of interrupts required to transfer data to and from memory. Each UART has two dedicated DMA channels, one for transmit and one for receive. These DMA channels have lower default priority than most DMA channels because of their relatively low service rates. Flexible interrupt timing options are available on the transmit side.

Each UART port's baud rate, serial data format, error code generation and status, and interrupts are programmable:

- Supporting bit rates ranging from (f<sub>SCLK</sub>/1,048,576) to (f<sub>SCLK</sub>) bits per second.
- Supporting data formats from 7 to 12 bits per frame.
- Both transmit and receive operations can be configured to generate maskable interrupts to the processor.

The UART port's clock rate is calculated as

$$UART\ Clock\ Rate = \frac{f_{SCLK}}{16^{(1-EDBO)} \times UART\ Divisor}$$

Where the 16-bit UART divisor comes from the UARTx\_DLH register (most significant 8 bits) and UARTx\_DLL register (least significant eight bits), and the EDBO is a bit in the UARTx\_GCTL register.

In conjunction with the general-purpose timer functions, auto-baud detection is supported.

The UARTs feature a pair of UAx\_RTS (request to send) and UAx\_CTS (clear to send) signals for hardware flow purposes. The transmitter hardware is automatically prevented from sending further data when the UAx\_CTS input is de-asserted. The receiver can automatically de-assert its UAx\_RTS output when the enhanced receive FIFO exceeds a certain high-water level. The capabilities of the UARTs are further extended with support for the Infrared Data Association (IrDA\*) Serial Infrared Physical Layer Link Specification (SIR) protocol.

#### **PARALLEL PERIPHERAL INTERFACE (PPI)**

The processor provides a parallel peripheral interface (PPI) that can connect directly to parallel A/D and D/A converters, video encoders and decoders, and other general-purpose peripherals. The PPI consists of a dedicated input clock pin, up to three frame synchronization pins, and up to 16 data pins. The input clock supports parallel data rates up to half the system clock rate and the synchronization signals can be configured as either inputs or outputs.

The PPI supports a variety of general-purpose and ITU-R 656 modes of operation. In general-purpose mode, the PPI provides half-duplex, bidirectional data transfer with up to 16 bits of data. Up to three frame synchronization signals are also provided. In ITU-R 656 mode, the PPI provides half-duplex bidirectional transfer of 8- or 10-bit video data. Additionally, on-chip decode of embedded start-of-line (SOL) and start-of-field (SOF) preamble packets is supported.

#### **General-Purpose Mode Descriptions**

The general-purpose modes of the PPI are intended to suit a wide variety of data capture and transmission applications. Three distinct submodes are supported:

- Input mode—Frame syncs and data are inputs into the PPI.
- Frame capture mode—Frame syncs are outputs from the PPI, but data are inputs.
- Output mode—Frame syncs and data are outputs from the PPI.

#### **Input Mode**

Input mode is intended for ADC applications, as well as video communication with hardware signaling. In its simplest form, PPI\_FS1 is an external frame sync input that controls when to read data. The PPI\_DELAY MMR allows for a delay (in PPI\_CLK cycles) between reception of this frame sync and the initiation of data reads. The number of input data samples is user programmable and defined by the contents of the PPI\_COUNT register. The PPI supports 8-bit and 10-bit through 16-bit data, programmable in the PPI\_CONTROL register.

### Frame Capture Mode

Frame capture mode allows the video source(s) to act as a slave (for frame capture for example). The ADSP-BF50x processors control when to read from the video source(s). PPI\_FS1 is an HSYNC output and PPI\_FS2 is a VSYNC output.

#### **Output Mode**

Output mode is used for transmitting video or other data with up to three output frame syncs. Typically, a single frame sync is appropriate for data converter applications, whereas two or three frame syncs could be used for sending video with hardware signaling.

#### ITU-R 656 Mode Descriptions

The ITU-R 656 modes of the PPI are intended to suit a wide variety of video capture, processing, and transmission applications. Three distinct submodes are supported:

- · Active video only mode
- · Vertical blanking only mode
- Entire field mode

#### **Active Video Mode**

Active video only mode is used when only the active video portion of a field is of interest and not any of the blanking intervals. The PPI does not read in any data between the end of active

video (EAV) and start of active video (SAV) preamble symbols, or any data present during the vertical blanking intervals. In this mode, the control byte sequences are not stored to memory; they are filtered by the PPI. After synchronizing to the start of Field 1, the PPI ignores incoming samples until it sees an SAV code. The user specifies the number of active video lines per frame (in PPI\_COUNT register).

#### Vertical Blanking Interval Mode

In this mode, the PPI only transfers vertical blanking interval (VBI) data.

#### **Entire Field Mode**

In this mode, the entire incoming bit stream is read in through the PPI. This includes active video, control preamble sequences, and ancillary data that may be embedded in horizontal and vertical blanking intervals. Data transfer starts immediately after synchronization to Field 1. Data is transferred to or from the synchronous channels through eight DMA engines that work autonomously from the processor core.

#### **RSI INTERFACE**

The removable storage interface (RSI) controller acts as the host interface for multimedia cards (MMC), secure digital memory cards (SD), secure digital input/output cards (SDIO), and CE-ATA hard disk drives. The following list describes the main features of the RSI controller.

- Support for a single MMC, SD memory, SDIO card or CE-ATA hard disk drive
- Support for 1-bit and 4-bit SD modes
- Support for 1-bit, 4-bit, and 8-bit MMC modes
- Support for 4-bit and 8-bit CE-ATA hard disk drives
- A ten-signal external interface with clock, command, and up to eight data lines
- Card detection using one of the data signals
- Card interface clock generation from SCLK
- SDIO interrupt and read wait features
- CE-ATA command completion signal recognition and disable

#### **CONTROLLER AREA NETWORK (CAN) INTERFACE**

The ADSP-BF50x processors provide a CAN controller that is a communication controller implementing the Controller Area Network (CAN) V2.0B protocol. This protocol is an asynchronous communications protocol used in both industrial and automotive control systems. CAN is well suited for control applications due to its capability to communicate reliably over a network since the protocol incorporates CRC checking, message error tracking, and fault node confinement.

The CAN controller is based on a 32-entry mailbox RAM and supports both the standard and extended identifier (ID) message formats specified in the CAN protocol specification, revision 2.0, part B.

Each mailbox consists of eight 16-bit data words. The data is divided into fields, which includes a message identifier, a time stamp, a byte count, up to 8 bytes of data, and several control bits. Each node monitors the messages being passed on the network. If the identifier in the transmitted message matches an identifier in one of its mailboxes, the module knows that the message was meant for it, passes the data into its appropriate mailbox, and signals the processor of message arrival with an interrupt.

The CAN controller can wake up the processor from sleep mode upon generation of a wake-up event, such that the processor can be maintained in a low-power mode during idle conditions. Additionally, a CAN wake-up event can wake up the on-chip internal voltage regulator from the powered-down hibernate state.

The electrical characteristics of each network connection are very stringent. Therefore, the CAN interface is typically divided into two parts: a controller and a transceiver. This allows a single controller to support different drivers and CAN networks. The ADSP-BF50x CAN module represents the controller part of the interface. This module's network I/O is a single transmit output and a single receive input, which connect to a line transceiver.

The CAN clock is derived from the processor system clock (SCLK) through a programmable divider and therefore does not require an additional crystal.

#### TWI CONTROLLER INTERFACE

The processors include a 2-wire interface (TWI) module for providing a simple exchange method of control data between multiple devices. The TWI is compatible with the widely used  $I^2C^{\circledR}$  bus standard. The TWI module offers the capabilities of simultaneous master and slave operation, support for both 7-bit addressing and multimedia data arbitration. The TWI interface utilizes two pins for transferring clock (SCL) and data (SDA) and supports the protocol at speeds up to 400K bits/sec. The TWI interface pins are compatible with 5 V logic levels.

Additionally, the TWI module is fully compatible with serial camera control bus (SCCB) functionality for easier control of various CMOS camera sensor devices.

#### **PORTS**

Because of the rich set of peripherals, the processor groups the many peripheral signals to three ports—Port F, Port G, and Port H. Most of the associated pins are shared by multiple signals. The ports function as multiplexer controls.

#### General-Purpose I/O (GPIO)

The processor has 35 bidirectional, general-purpose I/O (GPIO) pins allocated across three separate GPIO modules—PORTFIO, PORTGIO, and PORTHIO, associated with Port F, Port G, and Port H, respectively. Each GPIO-capable pin shares functionality with other processor peripherals via a multiplexing scheme; however, the GPIO functionality is the default state of the device upon power-up. Neither GPIO output nor input drivers are

active by default. Each general-purpose port pin can be individually controlled by manipulation of the port control, status, and interrupt registers:

- GPIO direction control register Specifies the direction of each individual GPIO pin as input or output.
- GPIO control and status registers The processor employs a "write one to modify" mechanism that allows any combination of individual GPIO pins to be modified in a single instruction, without affecting the level of any other GPIO pins. Four control registers are provided. One register is written in order to set pin values, one register is written in order to clear pin values, one register is written in order to toggle pin values, and one register is written in order to specify a pin value. Reading the GPIO status register allows software to interrogate the sense of the pins.
- GPIO interrupt mask registers The two GPIO interrupt mask registers allow each individual GPIO pin to function as an interrupt to the processor. Similar to the two GPIO control registers that are used to set and clear individual pin values, one GPIO interrupt mask register sets bits to enable interrupt function, and the other GPIO interrupt mask register clears bits to disable interrupt function. GPIO pins defined as inputs can be configured to generate hardware interrupts, while output pins can be triggered by software interrupts.
- GPIO interrupt sensitivity registers The two GPIO interrupt sensitivity registers specify whether individual pins are level- or edge-sensitive and specify—if edge-sensitive—whether just the rising edge or both the rising and falling edges of the signal are significant. One register selects the type of sensitivity, and one register selects which edges are significant for edge-sensitivity.

#### DYNAMIC POWER MANAGEMENT

The processor provides five operating modes, each with a different performance/power profile. In addition, dynamic power management provides the control functions to dynamically alter the processor core supply voltage, further reducing power dissipation. When configured for a 0 volt core supply voltage, the processor enters the hibernate state. Control of clocking to each of the processor peripherals also reduces power consumption. See Table 4 for a summary of the power settings for each mode.

#### Full-On Operating Mode—Maximum Performance

In the full-on mode, the PLL is enabled and is not bypassed, providing capability for maximum operational frequency. This is the power-up default execution state in which maximum performance can be achieved. The processor core and all enabled peripherals run at full speed.

## Active Operating Mode—Moderate Dynamic Power Savings

In the active mode, the PLL is enabled but bypassed. Because the PLL is bypassed, the processor's core clock (CCLK) and system clock (SCLK) run at the input clock (CLKIN) frequency. DMA access is available to appropriately configured L1 memories.

In the active mode, it is possible to disable the control input to the PLL by setting the PLL\_OFF bit in the PLL control register. This register can be accessed with a user-callable routine in the on-chip ROM called bfrom\_SysControl(). If disabled, the PLL control input must be re-enabled before transitioning to the full-on or sleep modes.

**Table 4. Power Settings** 

|            |                      |                 | Core            | System          | _             |
|------------|----------------------|-----------------|-----------------|-----------------|---------------|
| Mode/State | PLL                  | PLL<br>Bypassed | Clock<br>(CCLK) | Clock<br>(SCLK) | Core<br>Power |
| Full On    | Enabled              | No              | Enabled         | Enabled         | On            |
| Active     | Enabled/<br>Disabled | Yes             | Enabled         | Enabled         | On            |
| Sleep      | Enabled              | _               | Disabled        | Enabled         | On            |
| Deep Sleep | Disabled             | _               | Disabled        | Disabled        | On            |
| Hibernate  | Disabled             | _               | Disabled        | Disabled        | Off           |

For more information about PLL controls, see the "Dynamic Power Management" chapter in the *ADSP-BF50x Blackfin Processor Hardware Reference*.

#### Sleep Operating Mode—High Dynamic Power Savings

The sleep mode reduces dynamic power dissipation by disabling the clock to the processor core (CCLK). The PLL and system clock (SCLK), however, continue to operate in this mode. Typically, an external event wakes up the processor. When in the sleep mode, asserting a wakeup enabled in the SIC\_IWRx registers causes the processor to sense the value of the BYPASS bit in the PLL control register (PLL\_CTL). If BYPASS is disabled, the processor transitions to the full on mode. If BYPASS is enabled, the processor transitions to the active mode.

DMA accesses to L1 memory are not supported in sleep mode.

## Deep Sleep Operating Mode—Maximum Dynamic Power Savings

The deep sleep mode maximizes dynamic power savings by disabling the clocks to the processor core (CCLK) and to all synchronous peripherals (SCLK). Asynchronous peripherals may still be running but cannot access internal resources or external memory. This powered-down mode can only be exited by assertion of the reset pin (RESET). Assertion of RESET while in deep sleep mode causes the processor to transition to the full on mode.

#### Hibernate State—Maximum Static Power Savings

The hibernate state maximizes static power savings by disabling the voltage and clocks to the processor core (CCLK) and to all of the peripherals (SCLK). This setting sets the internal power supply voltage ( $V_{\rm DDINT}$ ) to 0 V to provide the lowest static power dissipation. Any critical information stored internally (for example, memory contents, register contents, and other information) must be written to a non-volatile storage device prior to removing power if the processor state is to be preserved.

Writing 0 to the HIBERNATE bit causes EXT\_WAKE to transition low, which can be used to signal an external voltage regulator to shut down.

Since  $V_{\rm DDEXT}$  can still be supplied in this mode, all of the external pins three-state, unless otherwise specified. This allows other devices that may be connected to the processor to still have power applied without drawing unwanted current.

The processor can be woken up by asserting the RESET pin. All hibernate wakeup events initiate the hardware reset sequence. Individual sources are enabled by the VR\_CTL register. The EXT\_WAKE signal indicates the occurrence of a wakeup event.

As long as  $V_{\rm DDEXT}$  is applied, the VR\_CTL register maintains its state during hibernation. All other internal registers and memories, however, lose their content in the hibernate state.

#### **Power Savings**

As shown in Table 5, the processor supports three different power domains, which maximizes flexibility while maintaining compliance with industry standards and conventions. By isolating the internal logic of the processor into its own power domain, separate from other I/O, the processor can take advantage of dynamic power management without affecting the other I/O devices. There are no sequencing requirements for the various power domains, but all domains must be powered according to the appropriate Specifications table for processor operating conditions; even if the feature/peripheral is not used.

**Table 5. Power Domains** 

| Power Domain                                 | <b>Power Supply</b>                   |
|--|---------------------------------------|
| All internal logic, except Memory            | $V_{DDINT}$                           |
| Flash Memory                                 | $V_{DDFLASH}$                         |
| All other I/O                                | $V_{DDEXT}$                           |
| ADC digital supply <sup>1</sup> (Logic, I/O) | DV <sub>DD</sub> , V <sub>DRIVE</sub> |
| ADC analog supply <sup>1</sup>               | $AV_{DD}$                             |

<sup>&</sup>lt;sup>1</sup>On ADSP-BF506F processor only.

The dynamic power management feature of the processor allows both the processor's input voltage ( $V_{DDINT}$ ) and clock frequency ( $f_{CCLK}$ ) to be dynamically controlled.

The power dissipated by a processor is largely a function of its clock frequency and the square of the operating voltage. For example, reducing the clock frequency by 25% results in a 25% reduction in dynamic power dissipation, while reducing the voltage by 25% reduces dynamic power dissipation by more than 40%. Further, these power savings are additive, in that if the clock frequency and supply voltage are both reduced, the power savings can be dramatic, as shown in the following equations.

Power Savings Factor

$$= \frac{f_{CCLKRED}}{f_{CCLKNOM}} \times \left(\frac{V_{DDINTRED}}{V_{DDINTNOM}}\right)^2 \times \left(\frac{T_{RED}}{T_{NOM}}\right)$$

% Power Savings =  $(1 - Power Savings Factor) \times 100\%$ 

where the variables in the equations are:

 $f_{CCLKNOM}$  is the nominal core clock frequency

 $f_{CCLKRED}$  is the reduced core clock frequency

 $V_{DDINTNOM}$  is the nominal internal supply voltage

 $V_{DDINTRED}$  is the reduced internal supply voltage

 $T_{NOM}$  is the duration running at  $f_{CCLKNOM}$ 

 $T_{RED}$  is the duration running at  $f_{CCLKRED}$ 

#### ADSP-BF50x VOLTAGE REGULATION

The ADSP-BF50x processors require an external voltage regulator to power the  $V_{\rm DDINT}$  domain. To reduce standby power consumption, the external voltage regulator can be signaled through EXT\_WAKE to remove power from the processor core. This signal is high-true for power-up and may be connected directly to the low-true shut-down input of many common regulators.

While in the hibernate state, all external supplies ( $V_{\rm DDEXT}$ ,  $V_{\rm DDFLASH}$ ) can still be applied, eliminating the need for external buffers. The external voltage regulator can be activated from this power down state by asserting the  $\overline{\rm RESET}$  pin, which then initiates a boot sequence. EXT\_WAKE indicates a wakeup to the external voltage regulator.

The power good  $(\overline{PG})$  input signal allows the processor to start only after the internal voltage has reached a chosen level. In this way, the startup time of the external regulator is detected after hibernation. For a complete description of the power good functionality, refer to the ADSP-BF50x Blackfin Processor Hardware Reference.

#### **CLOCK SIGNALS**

The processor can be clocked by an external crystal, a sine wave input, or a buffered, shaped clock derived from an external clock oscillator.

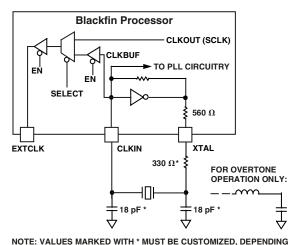
If an external clock is used, it should be a TTL-compatible signal and must not be halted, changed, or operated below the specified frequency during normal operation. This signal is connected to the processor's CLKIN pin. When an external clock is used, the XTAL pin must be left unconnected.

Alternatively, because the processor includes an on-chip oscillator circuit, an external crystal may be used. For fundamental frequency operation, use the circuit shown in Figure 4. A parallel-resonant, fundamental frequency, microprocessor-grade crystal is connected across the CLKIN and XTAL pins. The on-chip resistance between CLKIN and the XTAL pin is in the 500 k $\Omega$  range. Further parallel resistors are typically not recommended. The two capacitors and the series resistor shown in Figure 4 fine tune phase and amplitude of the sine frequency.

The capacitor and resistor values shown in Figure 4 are typical values only. The capacitor values are dependent upon the crystal manufacturers' load capacitance recommendations and the PCB physical layout. The resistor value depends on the drive level specified by the crystal manufacturer. The user should verify the customized values based on careful investigations on multiple devices over temperature range.

A third-overtone crystal can be used for frequencies above 25 MHz. The circuit is then modified to ensure crystal operation only at the third overtone by adding a tuned inductor circuit as shown in Figure 4. A design procedure for third-overtone operation is discussed in detail in (EE-168) Using Third Overtone Crystals with the ADSP-218x DSP on the Analog Devices website (www.analog.com)—use site search on "EE-168."

The Blackfin core runs at a different clock rate than the on-chip peripherals. As shown in Figure 5, the core clock (CCLK) and system peripheral clock (SCLK) are derived from the input clock (CLKIN) signal. An on-chip PLL is capable of multiplying the CLKIN signal by a programmable multiplication factor (bounded by specified minimum and maximum VCO frequencies). The default multiplier is 6×, but it can be modified by a software instruction sequence.



NOTE: VALUES MARKED WITH \* MUST BE CUSTOMIZED, DEPENDING ON THE CRYSTAL AND LAYOUT. PLEASE ANALYZE CAREFULLY. FOR FREQUENCIES ABOVE 33 MHz, THE SUGGESTED CAPACITOR VALUE OF 18 pF SHOULD BE TREATED AS A MAXIMUM, AND THE SUGGESTED RESISTOR VALUE SHOULD BE REDUCED TO 0  $\Omega$ .

Figure 4. External Crystal Connections

On-the-fly frequency changes can be effected by simply writing to the PLL\_DIV register. The maximum allowed CCLK and SCLK rates depend on the applied voltages  $V_{\rm DDINT}$  and  $V_{\rm DDEXT}$ ; the VCO is always permitted to run up to the CCLK frequency specified by the part's speed grade. The EXTCLK pin can be configured to output either the SCLK frequency or the input buffered CLKIN frequency, called CLKBUF. When configured to output SCLK (CLKOUT), the EXTCLK pin acts as a reference signal in many timing specifications. While active by default, it can be disabled using the EBIU\_AMGCTL register.

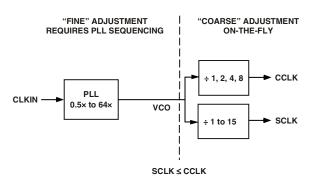


Figure 5. Frequency Modification Methods

All on-chip peripherals are clocked by the system clock (SCLK). The system clock frequency is programmable by means of the SSEL3–0 bits of the PLL\_DIV register. The values programmed into the SSEL fields define a divide ratio between the PLL output (VCO) and the system clock. SCLK divider values are 1 through 15. Table 6 illustrates typical system clock ratios.

Note that the divisor ratio must be chosen to limit the system clock frequency to its maximum of  $f_{SCLK}$ . The SSEL value can be changed dynamically without any PLL lock latencies by writing the appropriate values to the PLL divisor register (PLL\_DIV).

**Table 6. Example System Clock Ratios** 

| Signal Name | Divider Ratio | Example Frequ<br>(MHz) | uency Ratios |
|-------------|---------------|------------------------|--------------|
| SSEL3-0     | VCO/SCLK      | vco                    | SCLK         |
| 0001        | 1:1           | 50                     | 50           |
| 0110        | 6:1           | 300                    | 50           |
| 1010        | 10:1          | 400                    | 40           |

The core clock (CCLK) frequency can also be dynamically changed by means of the CSEL1–0 bits of the PLL\_DIV register. Supported CCLK divider ratios are 1, 2, 4, and 8, as shown in Table 7. This programmable core clock capability is useful for fast core frequency modifications.

Table 7. Core Clock Ratios

| Signal Name | Divider Ratio | Example Frequ<br>(MHz) | uency Ratios |
|-------------|---------------|------------------------|--------------|
| CSEL1-0     | VCO/CCLK      | vco                    | CCLK         |
| 00          | 1:1           | 300                    | 300          |
| 01          | 2:1           | 300                    | 150          |
| 10          | 4:1           | 400                    | 100          |
| 11          | 8:1           | 200                    | 25           |

The maximum CCLK frequency both depends on the part's speed grade and depends on the applied  $V_{\rm DDINT}$  voltage. See Table 14 for details. The maximal system clock rate (SCLK) depends on the applied  $V_{\rm DDINT}$  and  $V_{\rm DDEXT}$  voltages (see Table 16).

#### **BOOTING MODES**

The processor has several mechanisms (listed in Table 8) for automatically loading internal and external memory after a reset. The boot mode is defined by the BMODE input pins dedicated to this purpose. There are two categories of boot modes. In master boot modes, the processor actively loads data from parallel or serial memories. In slave boot modes, the processor receives data from external host devices.

**Table 8. Booting Modes** 

| BMODE2-0 | Description  |
|----------|--|
| 000      | Idle/No Boot   |
| 001      | Boot from internal parallel flash in async mode <sup>1</sup> |
| 010      | Boot from internal parallel flash in sync mode <sup>1</sup>  |
| 011      | Boot through SPI0 master from SPI memory                     |
| 100      | Boot through SPI0 slave from host device                     |
| 101      | Boot through PPI from host                                   |
| 110      | Reserved   |
| 111      | Boot through UARTO slave from host device                    |

 $<sup>^{\</sup>rm 1}{\rm This}$  boot mode applies to ADSP-BF504F and ADSP-BF506F processors only.

The boot modes listed in Table 8 provide a number of mechanisms for automatically loading the processor's internal and external memories after a reset. By default, all boot modes use the slowest meaningful configuration settings. Default settings can be altered via the initialization code feature at boot time. Some boot modes require a boot host wait (HWAIT) signal, which is a GPIO output signal that is driven and toggled by the boot kernel at boot time. If pulled high through an external pullup resistor, the HWAIT signal behaves active high and will be driven low when the processor is ready for data. Conversely, when pulled low, HWAIT is driven high when the processor is ready for data. When the boot sequence completes, the HWAIT pin can be used for other purposes. The BMODE pins of the reset configuration register, sampled during power-on resets and software-initiated resets, implement the modes shown in Table 8.

- IDLE State / No Boot (BMODE = 0x0)—In this mode, the boot kernel transitions the processor into Idle state. The processor can then be controlled through JTAG for recovery, debug, or other functions.
- Boot from stacked parallel flash in 16-bit asynchronous mode (BMODE = 0x1)—In this mode, conservative timing parameters are used to communicate with the flash device. The boot kernel communicates with the flash device asynchronously.
- Boot from stacked parallel flash in 16-bit synchronous mode (BMODE = 0x2)—In this mode, fast timing parameters are used to communicate with the flash device. The boot kernel configures the flash device for synchronous burst communication and boots from the flash synchronously.

- Boot from serial SPI memory, EEPROM or flash (BMODE = 0x3)—8-, 16-, 24-, or 32-bit addressable devices are supported. The processor uses the PF13 GPIO pin to select a single SPI EEPROM/flash device (connected to the SPI0 interface) and submits a read command and successive address bytes (0x00) until a valid 8-, 16-, 24-, or 32-bit addressable device is detected. Pull-up resistors are required on the \$\overline{SPI0}\_{SEL1}\$ and MISO pins. By default, a value of 0x85 is written to the SPI BAUD register.
- Boot from SPI host device (BMODE = 0x4)—The processor operates in SPI slave mode and is configured to receive the bytes of the LDR file from an SPI host (master) agent. The HWAIT signal must be interrogated by the host before every transmitted byte. A pull-up resistor is required on the SPI0\_SS input. A pull-down on the serial clock (SCK) may improve signal quality and booting robustness.
- Boot from PPI host device (BMODE = 0x5)—The processor operates in PPI slave mode and is configured to receive the bytes of the LDR file from a PPI host (master) agent.
- Boot from UARTO host on Port G (BMODE = 0x7)—
   Using an autobaud handshake sequence, a boot-stream formatted program is downloaded by the host. The host selects a bit rate within the UART clocking capabilities.
  - When performing the autobaud detection, the UART expects an "@" (0x40) character (eight bits data, one start bit, one stop bit, no parity bit) on the UA0\_RX pin to determine the bit rate. The UART then replies with an acknowledgement composed of 4 bytes (0xBF, the value of UART0\_DLL, the value of UART0\_DLH, then 0x00). The host can then download the boot stream. The processor deasserts the UA0\_RTS output to hold off the host; UA0\_CTS functionality is not enabled at boot time.

For each of the boot modes, a 16 byte header is first read from an external memory device. The header specifies the number of bytes to be transferred and the memory destination address. Multiple memory blocks may be loaded by any boot sequence. Once all blocks are loaded, program execution commences from the address stored in the EVT1 register.

The boot kernel differentiates between a regular hardware reset and a wakeup-from-hibernate event to speed up booting in the later case. Bits 6-4 in the system reset configuration (SYSCR) register can be used to bypass the pre-boot routine and/or boot kernel in case of a software reset. They can also be used to simulate a wakeup-from-hibernate boot in the software reset case.

The boot process can be further customized by "initialization code." This is a piece of code that is loaded and executed prior to the regular application boot. Typically, this is used to speed up booting by managing the PLL, clock frequencies, wait states, or serial bit rates.

The boot ROM also features C-callable functions that can be called by the user application at run time. This enables second-stage boot or boot management schemes to be implemented with ease.

#### INSTRUCTION SET DESCRIPTION

The Blackfin processor family assembly language instruction set employs an algebraic syntax designed for ease of coding and readability. The instructions have been specifically tuned to provide a flexible, densely encoded instruction set that compiles to a very small final memory size. The instruction set also provides fully featured multifunction instructions that allow the programmer to use many of the processor core resources in a single instruction. Coupled with many features more often seen on microcontrollers, this instruction set is very efficient when compiling C and C++ source code. In addition, the architecture supports both user (algorithm/application code) and supervisor (O/S kernel, device drivers, debuggers, ISRs) modes of operation, allowing multiple levels of access to core processor resources.

The assembly language, which takes advantage of the processor's unique architecture, offers the following advantages:

- Seamlessly integrated DSP/MCU features are optimized for both 8-bit and 16-bit operations.
- A multi-issue load/store modified-Harvard architecture, which supports two 16-bit MAC or four 8-bit ALU + two load/store + two pointer updates per cycle.
- All registers, I/O, and memory are mapped into a unified 4G byte memory space, providing a simplified programming model.
- Microcontroller features, such as arbitrary bit and bit-field manipulation, insertion, and extraction; integer operations on 8-, 16-, and 32-bit data-types; and separate user and supervisor stack pointers.
- Code density enhancements, which include intermixing of 16-bit and 32-bit instructions (no mode switching, no code segregation). Frequently used instructions are encoded in 16 bits.

#### **DEVELOPMENT TOOLS**

Analog Devices supports its processors with a complete line of software and hardware development tools, including integrated development environments (which include CrossCore® Embedded Studio and/or VisualDSP++®), evaluation products, emulators, and a wide variety of software add-ins.

#### Integrated Development Environments (IDEs)

For C/C++ software writing and editing, code generation, and debug support, Analog Devices offers two IDEs.

The newest IDE, CrossCore Embedded Studio, is based on the Eclipse™ framework. Supporting most Analog Devices processor families, it is the IDE of choice for future processors, including multicore devices. CrossCore Embedded Studio seamlessly integrates available software add-ins to support real time operating systems, file systems, TCP/IP stacks, USB stacks, algorithmic software modules, and evaluation hardware board support packages. For more information visit www.analog.com/cces.

The other Analog Devices IDE, VisualDSP++, supports processor families introduced prior to the release of CrossCore Embedded Studio. This IDE includes the Analog Devices VDK real time operating system and an open source TCP/IP stack. For more information visit www.analog.com/visualdsp. Note that VisualDSP++ will not support future Analog Devices processors.

#### **EZ-KIT Lite Evaluation Board**

For processor evaluation, Analog Devices provides wide range of EZ-KIT Lite<sup>®</sup> evaluation boards. Including the processor and key peripherals, the evaluation board also supports on-chip emulation capabilities and other evaluation and development features. Also available are various EZ-Extenders<sup>®</sup>, which are daughter cards delivering additional specialized functionality, including audio and video processing. For more information visit www.analog.com and search on "ezkit" or "ezextender".

#### **EZ-KIT Lite Evaluation Kits**

For a cost-effective way to learn more about developing with Analog Devices processors, Analog Devices offer a range of EZ-KIT Lite evaluation kits. Each evaluation kit includes an EZ-KIT Lite evaluation board, directions for downloading an evaluation version of the available IDE(s), a USB cable, and a power supply. The USB controller on the EZ-KIT Lite board connects to the USB port of the user's PC, enabling the chosen IDE evaluation suite to emulate the on-board processor in-circuit. This permits the customer to download, execute, and debug programs for the EZ-KIT Lite system. It also supports in-circuit programming of the on-board Flash device to store user-specific boot code, enabling standalone operation. With the full version of Cross-Core Embedded Studio or VisualDSP++ installed (sold separately), engineers can develop software for supported EZ-KITs or any custom system utilizing supported Analog Devices processors.

#### Software Add-Ins for CrossCore Embedded Studio

Analog Devices offers software add-ins which seamlessly integrate with CrossCore Embedded Studio to extend its capabilities and reduce development time. Add-ins include board support packages for evaluation hardware, various middleware packages, and algorithmic modules. Documentation, help, configuration dialogs, and coding examples present in these add-ins are viewable through the CrossCore Embedded Studio IDE once the add-in is installed.

#### **Board Support Packages for Evaluation Hardware**

Software support for the EZ-KIT Lite evaluation boards and EZ-Extender daughter cards is provided by software add-ins called Board Support Packages (BSPs). The BSPs contain the required drivers, pertinent release notes, and select example code for the given evaluation hardware. A download link for a specific BSP is located on the web page for the associated EZ-KIT or EZ-Extender product. The link is found in the *Product Download* area of the product web page.

#### Middleware Packages

Analog Devices separately offers middleware add-ins such as real time operating systems, file systems, USB stacks, and TCP/IP stacks. For more information see the following web pages:

- www.analog.com/ucos3
- www.analog.com/ucfs
- www.analog.com/ucusbd
- www.analog.com/lwip

#### **Algorithmic Modules**

To speed development, Analog Devices offers add-ins that perform popular audio and video processing algorithms. These are available for use with both CrossCore Embedded Studio and VisualDSP++. For more information visit <a href="https://www.analog.com">www.analog.com</a> and search on "Blackfin software modules" or "SHARC software modules".

#### Designing an Emulator-Compatible DSP Board (Target)

For embedded system test and debug, Analog Devices provides a family of emulators. On each JTAG DSP, Analog Devices supplies an IEEE 1149.1 JTAG Test Access Port (TAP). In-circuit emulation is facilitated by use of this JTAG interface. The emulator accesses the processor's internal features via the processor's TAP, allowing the developer to load code, set breakpoints, and view variables, memory, and registers. The processor must be halted to send data and commands, but once an operation is completed by the emulator, the DSP system is set to run at full speed with no impact on system timing. The emulators require the target board to include a header that supports connection of the DSP's JTAG port to the emulator.

For details on target board design issues including mechanical layout, single processor connections, signal buffering, signal termination, and emulator pod logic, see the *EE-68*: *Analog Devices JTAG Emulation Technical Reference* on the Analog Devices website (www.analog.com)—use site search on "EE-68." This document is updated regularly to keep pace with improvements to emulator support.

#### **ADC AND ACM INTERFACE**

This section describes the ADC and ACM interface. System designers should also consult the *ADSP-BF50x Blackfin Processor Hardware Reference* for additional information.

The ADC control module (ACM) provides an interface that synchronizes the controls between the processor and the internal analog-to-digital converter (ADC) module. The ACM is available on the ADSP-BF504, ADSP-BF504F, and ADSP-BF506F processors, and the ADC is available on the ADSP-BF506F processor only. The analog-to-digital conversions are initiated by the processor, based on external or internal events.

The ACM allows for flexible scheduling of sampling instants and provides precise sampling signals to the ADC.

The ACM synchronizes the ADC conversion process; generating the ADC controls, the ADC conversion start signal, and other signals. The actual data acquisition from the ADC is done by the SPORT peripherals.

The serial interface on the ADC allows the part to be directly connected to the ADSP-BF504, ADSP-BF504F, and ADSP-BF506F processors using serial interface protocols.

Figure 6 shows how to connect an external ADC to the ACM and one of the two SPORTs on the ADSP-BF504 or ADSP-BF504F processors.

#### ADSP-BF504/ADSP-BF504F DRxSEC DRxPRI **SPORTX** RCLKx -RFSx SPORT SELECT ACLK MUX CS ACM\_A[2:0] ACM SGLDIFF ACM\_RANGE RANGE SGL/DIFF A[2:0] **ADC** $\overline{\mathsf{cs}}$ (EXTERNAL) **ADSCLK** $\mathbf{D}_{\mathbf{OUT}}\mathbf{A}$ $D_{OUT}B$

Figure 6. ADC (External), ACM, and SPORT Connections

The ADC is integrated into the ADSP-BF506F product. Figure 7 shows how to connect the internal ADC to the ACM and to one of the two SPORTs on the ADSP-BF506F processor.

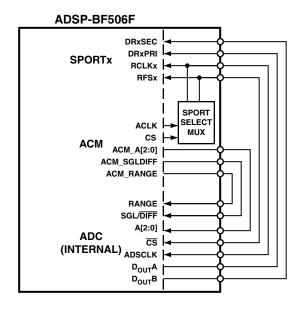


Figure 7. ADC (Internal), ACM, and SPORT Connections

The ADSP-BF504, ADSP-BF504F, and ADSP-BF506F processors interface directly to the ADC without any glue logic required. The availability of secondary receive registers on the serial ports of the Blackfin processors means only one serial port is necessary to read from both  $D_{\rm OUT}$  pins simultaneously. Figure 7 (ADC (Internal), ACM, and SPORT Connections) shows both  $D_{\rm OUT}A$  and  $D_{\rm OUT}B$  of the ADC connected to one of the processor's serial ports. The SPORTx Receive Configuration 1 register and SPORTx Receive Configuration 2 register should be set up as outlined in Table 9 (The SPORTx Receive Configuration 1 Register (SPORTx\_RCR1)) and Table 10 (The SPORTx Receive Configuration 2 Register (SPORTx\_RCR2)).

Table 9. The SPORTx Receive Configuration 1 Register (SPORTx\_RCR1)

| Setting         | Description                            |
|-----------------|--|
| RCKFE = 0       | Sample data with falling edge of RSCLK |
| LRFS = 1        | Active low frame signal                |
| RFSR = 1        | Frame every word                       |
| IRFS = 0        | External RFS used                      |
| RLSBIT = 0      | Receive MSB first                      |
| RDTYPE = 00     | Zero fill                              |
| IRCLK = 0       | External receive clock                 |
| RSPEN = 1       | Receive enabled                        |
| TFSR = RFSR = 1 |  |

**NOTE:** The SPORT must be enabled with the following settings: external clock, external frame sync, and active low frame sync.

Table 10. The SPORTx Receive Configuration 2 Register (SPORTx RCR2)

| Setting     | Description   |
|-------------|---|
| RXSE = 1    | Secondary side enabled  |
| SLEN = 1111 | 16-bit data-word (or may be set to 1101 for 14-bit data-word) |

To implement the power-down modes, SLEN should be set to 1001 to issue an 8-bit SCLK burst. A Blackfin driver for the ADC is available to download at www.analog.com.

#### **INTERNAL ADC**

An ADC is integrated into the ADSP-BF506F product. All ADC signals are connected out to package pins to enable maximum interconnect flexibility in mixed signal applications.

The internal ADC is a dual, 12-bit, high speed, low power, successive approximation ADC that operates from a single 2.7 V to 5.25 V power supply and features throughput rates up to 2 MSPS. The device contains two ADCs, each preceded by a 3-channel multiplexer, and a low noise, wide bandwidth trackand-hold amplifier that can handle input frequencies in excess of 30 MHz.

Figure 8 shows the functional block diagram of the internal ADC. The ADC features include:

- Dual 12-bit, 3-channel ADC
- Throughput rate: up to 2 MSPS
- Specified for  $DV_{DD}$  and  $AV_{DD}$  of 2.7 V to 5.25 V
- · Pin-configurable analog inputs
  - 12-channel single-ended inputs or
  - 6-channel fully differential inputs or
  - 6-channel pseudo differential inputs
- Accurate on-chip voltage reference: 2.5 V
- Dual conversion with read 437.5 ns, 32 MHz ADSCLK
- High speed serial interface
  - SPI-/QSPI™-/MICROWIRE™-/DSP-compatible
- Low power shutdown mode

The conversion process and data acquisition use standard control inputs allowing easy interfacing to microprocessors or DSPs. The input signal is sampled on the falling edge of  $\overline{\text{CS}}$ ; conversion is also initiated at this point. The conversion time is determined by the ADSCLK frequency. There are no pipelined delays associated with the part.

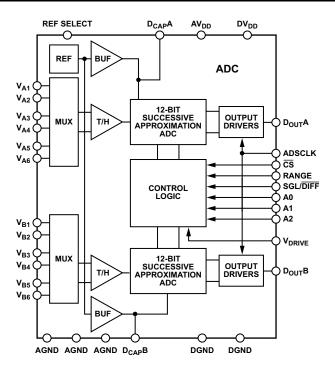


Figure 8. ADC (Internal) Functional Block Diagram

The internal ADC uses advanced design techniques to achieve very low power dissipation at high throughput rates. The part also offers flexible power/throughput rate management when operating in normal mode as the quiescent current consumption is so low.

The analog input range for the part can be selected to be a 0 V to  $V_{REF}$  (or  $2 \times V_{REF}$ ) range, with either straight binary or twos complement output coding. The internal ADC has an on-chip 2.5 V reference that can be overdriven when an external reference is preferred.

Additional highlights of the internal ADC include:

- Two complete ADC functions allow simultaneous sampling and conversion of two channels—Each ADC has three fully/pseudo differential pairs, or six single-ended channels, as programmed. The conversion result of both channels is simultaneously available on separate data lines, or in succession on one data line if only one serial connection is available.
- High throughput with low power consumption
- The internal ADC offers both a standard 0 V to  $V_{\text{REF}}$  input range and a  $2\times V_{\text{REF}}$  input range.

#### **ADC APPLICATION HINTS**

The following sections provide application hints for using the ADC.

#### **Grounding and Layout Considerations**

The analog and digital supplies to the ADC are independent and separately pinned out to minimize coupling between the analog and digital sections of the device. The printed circuit board (PCB) that houses the ADC should be designed so that the analog and digital sections are separated and confined to certain areas of the board. This design facilitates the use of ground planes that can be easily separated.

To provide optimum shielding for ground planes, a minimum etch technique is generally best. All AGND pins should be sunk in the AGND plane. Digital and analog ground planes should be joined in only one place. If the ADC is in a system where multiple devices require an AGND to DGND connection, the connection should still be made at one point only, a star ground point that should be established as close as possible to the ground pins on the ADC.

Avoid running digital lines under the device as this couples noise onto the die. Avoid running digital lines in the area of the AGND pad as this couples noise onto the ADC die and into the AGND plane. The power supply lines to the ADC should use as large a trace as possible to provide low impedance paths and reduce the effects of glitches on the power supply line.

To avoid radiating noise to other sections of the board, fast switching signals, such as clocks, should be shielded with digital ground, and clock signals should never run near the analog inputs. Avoid crossover of digital and analog signals. To reduce the effects of feed through within the board, traces on opposite sides of the board should run at right angles to each other.

Good decoupling is also important. All analog supplies should be decoupled with 10  $\mu F$  tantalum capacitors in parallel with 0.1  $\mu F$  capacitors to GND. To achieve the best results from these decoupling components, they must be placed as close as possible to the device, ideally right up against the device. The 0.1  $\mu F$  capacitors should have low effective series resistance (ESR) and effective series inductance (ESI), such as the common ceramic types or surface-mount types. These low ESR and ESI capacitors provide a low impedance path to ground at high frequencies to handle transient currents due to internal logic switching.

#### **ADDITIONAL INFORMATION**

The following publications that describe the ADSP-BF50x processors (and related processors) can be ordered from any Analog Devices sales office or accessed electronically on our website:

- Getting Started With Blackfin Processors
- ADSP-BF50x Blackfin Processor Hardware Reference (volumes 1 and 2)
- Blackfin Processor Programming Reference
- ADSP-BF50x Blackfin Processor Anomaly List

#### **RELATED SIGNAL CHAINS**

A *signal chain* is a series of signal-conditioning electronic components that receive input (data acquired from sampling either real-time phenomena or from stored data) in tandem, with the output of one portion of the chain supplying input to the next. Signal chains are often used in signal processing applications to gather and process data or to apply system controls based on analysis of real-time phenomena. For more information about this term and related topics, see the "signal chain" entry in Wikipedia or the Glossary of EE Terms on the Analog Devices website.

Analog Devices eases signal processing system development by providing signal processing components that are designed to work together well. A tool for viewing relationships between specific applications and related components is available on the www.analog.com website.

The Application Signal Chains page in the Circuits from the Lab™ site (http:\\www.analog.com\signalchains) provides:

- Graphical circuit block diagram presentation of signal chains for a variety of circuit types and applications
- Drill down links for components in each chain to selection guides and application information
- Reference designs applying best practice design techniques

### **SIGNAL DESCRIPTIONS**

Signal definitions for the ADSP-BF50x processors are listed in Table 11. All pins for the ADC (ADSP-BF506F processor only) are listed in Table 12.

In order to maintain maximum function and reduce package size and pin count, some pins have multiple, multiplexed functions. In cases where pin function is reconfigurable, the default state is shown in plain text, while the alternate functions are shown in italics.

During and immediately after reset, all processor signals (not ADC signals) are three-stated with the following exceptions: EXT\_WAKE is driven high and XTAL is driven in conjunction with CLKIN to create a crystal oscillator circuit. During

hibernate, all signals are three-stated with the following exceptions: EXT\_WAKE is driven low and XTAL is driven to a solid logic level.

During and immediately after reset, all I/O pins have their input buffers disabled until enabled by user software with the exception of the pins that need pull-ups or pull-downs, as noted in Table 11.

Adding a parallel termination to CLKOUT may prove useful in further enhancing signal integrity. Be sure to verify overshoot/undershoot and signal integrity specifications on actual hardware.

Table 11. Processor—Signal Descriptions

| Signal Name   | Type | Function   | Driver<br>Type |
|---|------|--|----------------|
| Port F: GPIO and Multiplexed Peripherals            | 7.   |  |                |
| PF0/TSCLK0/UA0_RX/TMR6/CUD0                         | I/O  | GPIO/SPORT0 TX Serial CLK/UART0 RX/Timer6/Count Up Dir 0                 | C              |
| PF1/RSCLK0/UA0_TX/TMR5/CDG0                         | I/O  | GPIO/SPORT0 RX Serial CLK/UART0 TX/Timer5/Count Down Dir 0               | C              |
| PF2/DT0PRI/PWM0_BH/PPI_D8/CZM0                      | I/O  | GPIO/SPORT0 TX Pri Data/PWM0 Drive B Hi/PPI Data 8/Counter Zero Marker 0 | C              |
| PF3/TFS0/PWM0_BL/PPI_D9/CDG0                        | I/O  | GPIO/SPORT0 TX Frame Sync/PWM0 Drive B Lo/PPI Data 9/Count Down Dir 0    | C              |
| PF4/RFS0/PWM0_CH/PPI_D10/TACLK0                     | I/O  | GPIO/SPORT0 RX Frame Sync/PWM0 Drive C Hi/PPI Data 10/Alt Timer CLK 0    | C              |
| PF5/DR0PRI/PWM0_CL/PPI_D11/TACLK1                   | I/O  | GPIO/SPORT0 Pri RX Data/PWM0 Drive C Lo/PPI Data 11/Alt Timer CLK 1      | С              |
| PF6/UA1_TX/PWM0_TRIP/PPI_D12                        | I/O  | GPIO/UART1 TX/PWM0 TRIP/PPI Data 12                                      | С              |
| PF7/UA1_RX/PWM0_SYNC/PPI_D13/TACI3                  | I/O  | GPIO/UART1 RX/PWM0 SYNC/PPI Data 13/Alt Capture In 3                     | C              |
| PF8/ <del>UA1_RTS</del> /DT0SEC/PPI_D7              | I/O  | GPIO/UART1 RTS/SPORT0 TX Sec Data/PPI Data 7                             | C              |
| PF9/ <del>UA1_CTS</del> /DR0SEC/PPI_D6/CZM0         | I/O  | GPIO/UART1 CTS/SPORT0 Sec RX Data/PPI Data 6/Counter Zero Marker 0       | С              |
| PF10/SPI0_SCK/TMR2/PPI_D5                           | I/O  | GPIO/SPI0 SCK/Timer2/PPI Data 5  | C              |
| PF11/SPI0_MISO/PWM0_TRIP/PPI_D4/TACLK2              | I/O  | GPIO/SPI0 MISO/PWM0 TRIP/PPI Data 4/Alt Timer CLK 2                      | C              |
| PF12/SPI0_MOSI/PWM0_SYNC/PPI_D3                     | I/O  | GPIO/SPI0 MOSI/PWM0 SYNC/PPI Data 3                                      | С              |
| PF13/ <u>SPI0_SEL1</u> /TMR3/PPI_D2/ <u>SPI0_SS</u> | I/O  | GPIO/SPI0 Slave Select 1/Timer3/PPI Data 2/SPI0 Slave Select In          | C              |
| PF14/SPI0_SEL2/PWM0_AH/PPI_D1                       | I/O  | GPIO/SPI0 Slave Select 2/PWM0 AH/PPI Data 1                              | C              |
| PF15/SPI0_SEL3/PWM0_AL/PPI_D0                       | I/O  | GPIO/SPIO Slave Select 3/PWM0 AL/PPI Data 0                              | C              |
| Port G: GPIO and Multiplexed Peripherals            |      |  |                |
| PG0/SPI1_SEL3/TMRCLK/PPI_CLK/UA1_RX/TACI4           | I/O  | GPIO/SPI1 Slave Select 3/Timer CLK/PPI Clock/UART1 RX/Alt Capture In 4   | C              |
| PG1/SPI1_SEL2/PPI_FS3/CAN_RX/TACI5                  | I/O  | GPIO/SPI1 Slave Select 2/PPI FS3/CAN RX/Alt Capture In 5                 | C              |
| PG2/SPI1_SEL1/TMR4/CAN_TX/SPI1_SS                   | I/O  | GPIO/SPI1 Slave Select 1/Timer4/CAN TX/SPI1 Slave Select In              | C              |
| PG3/HWAIT/SPI1_SCK/DT1SEC/UA1_TX                    | I/O  | GPIO/HWAIT/SPI1 SCK/SPORT1 TX Sec Data/UART1 TX                          | C              |
| PG4/SPI1_MOSI/DR1SEC/PWM1_SYNC/TACLK6               | I/O  | GPIO/SPI1 MOSI/SPORT1 Sec RX Data/PWM1 SYNC/Alt Timer CLK 6              | C              |
| PG5/SPI1_MISO/TMR7/PWM1_TRIP                        | I/O  | GPIO/SPI1 MISO/Timer7/PWM1 TRIP  | C              |
| PG6/ACM_SGLDIFF/SD_D3/PWM1_AH                       | I/O  | GPIO/ADC CM SGL DIFF/SD Data 3/PWM1 Drive A Hi                           | C              |
| PG7/ACM_RANGE/SD_D2/PWM1_AL                         | I/O  | GPIO/ADC CM RANGE/SD Data 2/PWM1 Drive A Lo                              | C              |
| PG8/DR1SEC/SD_D1/PWM1_BH                            | I/O  | GPIO/SPORT1 Sec RX Data/SD Data 1/PWM1 Drive B Hi                        | C              |
| PG9/DR1PRI/SD_D0/PWM1_BL                            | I/O  | GPIO/SPORT1 Pri RX Data/SD Data 0/PWM1 Drive B Lo                        | C              |
| PG10/RFS1/SD_CMD/PWM1_CH/TACI6                      | I/O  | GPIO/SPORT1 RX Frame Sync/SD CMD/PWM1 Drive C Hi/Alt Capture In 6        | C              |
| PG11/RSCLK1/SD_CLK/PWM1_CL/TACLK7                   | I/O  | GPIO/SPORT1 RX Serial CLK/SD CLK/PWM1 Drive C Lo/Alt Timer CLK 7         | C              |
| PG12/UA0_RX/SD_D4/PPI_D15/TACI2                     | I/O  | GPIO/UART0 RX/SD Data 4/PPI Data 15/Alt Capture In 2                     | C              |
| PG13/UA0_TX/SD_D5/PPI_D14/CZM1                      | I/O  | GPIO/UART0 TX/SD Data 5/PPI Data 14/Counter Zero Marker 1                | C              |

Table 11. Processor—Signal Descriptions (Continued)

| Signal Name                              | Туре       | Function   | Driver<br>Type |
|--|------------|--|----------------|
| PG14/UA0_RTS/SD_D6/TMR0/PPI_FS1/CUD1     | I/O        | GPIO/UART0 RTS/SD Data 6/Timer0/PPI FS1/Count Up Dir 1   | C              |
| PG15/UA0_CTS/SD_D7/TMR1/PPI_FS2/CDG1     | I/O        | GPIO/UART0 CTS/SD Data 7/Timer1/PPI FS2/Count Down Dir 1   | С              |
| Port H: GPIO and Multiplexed Peripherals |            |  |                |
| PH0/ACM_A2/DT1PRI/SPI0_SEL3/WAKEUP       | I/O        | GPIO/ADC CM A2/SPORT1 TX Pri Data/SPI0 Slave Select 3/Wake-up Input  | С              |
| PH1/ACM_A1/TFS1/SPI1_SEL3/TACLK3         | I/O        | GPIO/ADC CM A1/SPORT1 TX Frame Sync/SPI1 Slave Select 3/Alt Timer CLK 3  | С              |
| PH2/ACM_A0/TSCLK1/SPI1_SEL2/TACI7        | I/O        | GPIO/ADC CM A0/SPORT1 TX Serial CLK/SPI1 Slave Select 2/Alt Capture In 7   | С              |
| TWI (2-Wire Interface) Port              |            |  |                |
| SCL                                      | I/O<br>5 V | TWI Serial Clock (This signal is an open-drain output and requires a pull-up resistor. Consult version 2.1 of the I <sup>2</sup> C specification for the proper resistor value.) | D              |
| SDA                                      | I/O<br>5 V | TWI Serial Data (This signal is an open-drain output and requires a pull-up resistor. Consult version 2.1 of the I <sup>2</sup> C specification for the proper resistor value.)  | D              |
| JTAG Port                                |            |  |                |
| TCK                                      | - 1        | JTAG CLK   |                |
| TDO                                      | 0          | JTAG Serial Data Out   | C              |
| TDI                                      | - 1        | JTAG Serial Data In  |                |
| TMS                                      | - 1        | JTAG Mode Select   |                |
| TRST                                     | I          | JTAG Reset<br>(This signal should be pulled low if the JTAG port is not used.)   |                |
| EMU                                      | 0          | Emulation Output   | С              |
| Clock                                    |            |  |                |
| CLKIN                                    | I          | CLK/Crystal In   |                |
| XTAL                                     | 0          | Crystal Output   |                |
| EXTCLK                                   | 0          | Clock Output   | В              |
| Mode Controls                            |            |  |                |
| RESET                                    | I          | Reset  |                |
| NMI                                      | I          | Nonmaskable Interrupt<br>(This signal should be pulled high when not used.)  |                |
| BMODE2-0                                 | - 1        | Boot Mode Strap 2-0  |                |
| ADSP-BF50x Voltage Regulation I/F        |            |  |                |
| EXT_WAKE                                 | 0          | Wake up Indication   | C              |
| PG                                       | I          | Power Good   |                |
| Power Supplies                           |            | ALL SUPPLIES MUST BE POWERED See Operating Conditions on Page 26.  |                |
| $V_{DDEXT}$                              | Р          | I/O Power Supply   |                |
| $V_{	extsf{DDINT}}$                      | Р          | Internal Power Supply  |                |
| $V_{DDFLASH}$                            | Р          | Flash Memory Power Supply  |                |
| GND                                      | G          | Ground for All Supplies  |                |

Table 12. ADC—Signal Descriptions (ADSP-BF506F Processor Only)

| Signal Name  | Туре | Function   |
|--|------|--|
| DGND   | G    | Digital Ground. This is the ground reference point for all digital circuitry on the internal ADC. Both DGND pins should connect to the DGND plane of a system. The DGND and AGND voltages should ideally be at the same potential and must not be more than 0.3 V apart, even on a transient basis.  |
| REF SELECT   |      | Internal/External Reference Selection. Logic input. If this pin is tied to DGND, the on-chip 2.5 V reference is used as the reference source for both ADC A and ADC B. In addition, Pin $D_{CAP}A$ and Pin $D_{CAP}B$ must be tied to decoupling capacitors. If the REF SELECT pin is tied to a logic high, an external reference can be supplied to the internal ADC through the $D_{CAP}A$ and/or $D_{CAP}B$ pins.   |
| $AV_DD$  |      | Analog Supply Voltage, 2.7 V to 5.25 V. This is the only supply voltage for all analog circuitry on the internal ADC. The $AV_{DD}$ and $DV_{DD}$ voltages should ideally be at the same potential and must not be more than 0.3 V apart, even on a transient basis. This supply should be decoupled to AGND.  |
| D <sub>CAP</sub> A, D <sub>CAP</sub> B (V <sub>REF</sub> ) | I    | Decoupling Capacitor Pins. Decoupling capacitors (470 nF recommended) are connected to these pins to decouple the reference buffer for each respective ADC. Provided the output is buffered, the on-chip reference can be taken from these pins and applied externally to the rest of a system. The range of the external reference is dependent on the analog input range selected.   |
| AGND   |      | Analog Ground. Ground reference point for all analog circuitry on the internal ADC. All analog input signals and any external reference signal should be referred to this AGND voltage. All three of these AGND pins should connect to the AGND plane of a system. The AGND and DGND voltages ideally should be at the same potential and must not be more than 0.3 V apart, even on a transient basis.  |
| $V_{A1}$ to $V_{A6}$                                       | I    | Analog Inputs of ADC A. These may be programmed as six single-ended channels or three true differential analog input channel pairs. See Table 53 (Analog Input Type and Channel Selection).  |
| $V_{B1}$ to $V_{B6}$                                       | I    | Analog Inputs of ADC B. These may be programmed as six single-ended channels or three true differential analog input channel pairs. See Table 53 (Analog Input Type and Channel Selection).  |
| RANGE  |      | Analog Input Range Selection. Logic input. The polarity on this pin determines the input range of the analog input channels. If this pin is tied to a logic low, the analog input range is $0 \text{ V}$ to $V_{REF}$ . If this pin is tied to a logic high when $\overline{CS}$ goes low, the analog input range is $2 \times V_{REF}$ . For details, see Table 53 (Analog Input Type and Channel Selection).   |
| SGL/DIFF   | I    | Logic Input. This pin selects whether the analog inputs are configured as differential pairs or single ended. A logic low selects differential operation while a logic high selects single-ended operation. For details, see Table 53 (Analog Input Type and Channel Selection).   |
| A0 to A2   |      | Multiplexer Select. Logic inputs. These inputs are used to select the pair of channels to be simultaneously converted, such as Channel 1 of both ADC A and ADC B, Channel 2 of both ADC A and ADC B, and so on. The pair of channels selected may be two single-ended channels or two differential pairs. The logic states of these pins need to be set up prior to the acquisition time and subsequent falling edge of $\overline{\text{CS}}$ to correctly set up the multiplexer for that conversion. For further details, see Table 53 (Analog Input Type and Channel Selection). |
| CS   |      | Chip Select. Active low logic input. This input provides the dual function of initiating conversions on the internal ADC and framing the serial data transfer. When connecting $\overline{CS}$ to a processor signal that is three-stated during reset and/or hibernate, adding a pull-up resistor may prove useful to avoid random ADC operation.   |
| ADSCLK   |      | Serial Clock. Logic input. A serial clock input provides the ADSCLK for accessing the data from the internal ADC. This clock is also used as the clock source for the conversion process.  |

Table 12. ADC—Signal Descriptions (ADSP-BF506F Processor Only) (Continued)

| Signal Name                            | Туре | Function  |
|--|------|---|
| D <sub>OUT</sub> A, D <sub>OUT</sub> B | 0    | Serial Data Outputs. The data output is supplied to each pin as a serial data stream. The bits are clocked out on the falling edge of the ADSCLK input and 14 ADSCLKs are required to access the data. The data simultaneously appears on both pins from the simultaneous conversions of both ADCs. The data stream consists of two leading zeros followed by the 12 bits of conversion data. The data is provided MSB first. If $\overline{CS}$ is held low for 16 ADSCLK cycles rather than 14, then two trailing zeros will appear after the 12 bits of data. If $\overline{CS}$ is held low for a further 16 ADSCLK cycles on either $D_{OUT}A$ or $D_{OUT}B$ , the data from the other ADC follows on the $D_{OUT}$ pin. This allows data from a simultaneous conversion on both ADCs to be gathered in serial format on either $D_{OUT}A$ or $D_{OUT}B$ using only one serial port. For more information, see the ADC—Serial Interface section. |
| V <sub>DRIVE</sub>                     | Р    | Logic Power Supply Input. The voltage supplied at this pin determines at what voltage the digital I/O interface operates. This pin should be decoupled to DGND. The voltage at this pin may be different than that at $AV_{DD}$ and $DV_{DD}$ but should never exceed either by more than 0.3 V.  |
| $DV_DD$                                | Р    | Digital Supply Voltage, 2.7 V to 5.25 V. This is the supply voltage for all digital circuitry on the internal ADC. The DV <sub>DD</sub> and AV <sub>DD</sub> voltages should ideally be at the same potential and must not be more than 0.3 V apart even on a transient basis. This supply should be decoupled to DGND.   |

### **SPECIFICATIONS**

Specifications are subject to change without notice.

#### **OPERATING CONDITIONS**

| Paramete                  | er                                       | Conditions   | Min                           | Nominal | Max                         | Unit |
|---------------------------|--|--|-------------------------------|---------|-----------------------------|------|
| V <sub>DDINT</sub>        | Internal Supply Voltage                  | Industrial Models  | 1.14                          |         | 1.47                        | ٧    |
|                           | Internal Supply Voltage                  | Commercial Models  | 1.10                          |         | 1.47                        | ٧    |
|                           | Internal Supply Voltage                  | Automotive Models  | 1.33                          |         | 1.47                        | ٧    |
| V <sub>DDEXT</sub> 1, 2   | External Supply Voltage                  | 1.8 V I/O, ADSP-BF504, Nonautomotive and Non Flash Models                    | 1.7                           | 1.8     | 1.9                         | V    |
|                           | External Supply Voltage                  | 2.5 V I/O, ADSP-BF504, Nonautomotive and Non Flash Models                    | 2.25                          | 2.5     | 2.75                        | V    |
|                           | External Supply Voltage                  | 3.3 V I/O, ADSP-BF50x, All Models  | 2.7                           | 3.3     | 3.6                         | ٧    |
| V <sub>DDFLASH</sub> 1, 3 | <sup>3</sup> Flash Memory Supply Voltage |  | 1.7                           | 1.8     | 2.0                         | ٧    |
| $V_{IH}$                  | High Level Input Voltage <sup>4, 5</sup> | $V_{DDEXT} = 1.90 \text{ V}$   | 1.2                           |         |                             | ٧    |
|                           | High Level Input Voltage <sup>4, 6</sup> | $V_{DDEXT} = 2.75 \text{ V}$   | 1.7                           |         |                             | ٧    |
|                           | High Level Input Voltage <sup>4, 6</sup> | $V_{DDEXT} = 3.6 \text{ V}$  | 2.0                           |         |                             | ٧    |
| $V_{\text{IHTWI}}$        | High Level Input Voltage⁵                | $V_{DDEXT} = 1.90 \text{ V}/2.75 \text{ V}/3.6 \text{ V}$                    | $0.7 \times V_{BUSTWI}^{7,8}$ |         | $V_{\text{BUSTWI}}^{7,8}$   | ٧    |
| $V_{IL}$                  | Low Level Input Voltage <sup>4, 5</sup>  | $V_{DDEXT} = 1.7 V$  |                               |         | 0.6                         | ٧    |
|                           | Low Level Input Voltage <sup>4, 6</sup>  | $V_{DDEXT} = 2.25 \text{ V}$   |                               |         | 0.7                         | ٧    |
|                           | Low Level Input Voltage <sup>4, 6</sup>  | $V_{DDEXT} = 3.0 \text{ V}$  |                               |         | 0.8                         | ٧    |
| $V_{\text{ILTWI}}$        | Low Level Input Voltage⁵                 | $V_{DDEXT} = minimum$  |                               |         | $0.3 \times V_{BUSTWI}^{8}$ | ٧    |
| T <sub>J</sub>            | Junction Temperature                     | 88-Lead LFCSP @ $T_{AMBIENT} = -40^{\circ}C$ to $+85^{\circ}C$               | -40                           |         | +105                        | °C   |
|                           | Junction Temperature                     | 88-Lead LFCSP @ $T_{AMBIENT} = 0^{\circ}C$ to $+70^{\circ}C$                 | 0                             |         | +90                         | °C   |
|                           | Junction Temperature                     | 120-Lead LQFP @ $T_{AMBIENT} = -40$ °C to +85°C                              | -40                           |         | +105                        | °C   |
|                           | Junction Temperature                     | 120-Lead LQFP @ $T_{AMBIENT} = 0^{\circ}C$ to $+70^{\circ}C$                 | 0                             |         | +90                         | °C   |
|                           | Junction Temperature                     | 88-Lead LFCSP @ $T_{AMBIENT} = -40^{\circ}\text{C to} + 105^{\circ}\text{C}$ | -40                           |         | +125                        | °C   |

<sup>&</sup>lt;sup>1</sup> Must remain powered (even if the associated function is not used).

Table 13 shows settings for TWI\_DT in the NONGPIO\_DRIVE register. Set this register prior to using the TWI port.

Table 13. TWI\_DT Field Selections and V<sub>DDEXT</sub>/V<sub>BUSTWI</sub>

| TWI_DT         | V <sub>DDEXT</sub> Nominal | V <sub>BUSTWI</sub> Minimum | V <sub>BUSTWI</sub> Nominal | V <sub>BUSTWI</sub> Maximum | Unit |
|----------------|----------------------------|-----------------------------|-----------------------------|-----------------------------|------|
| 000 (default)  | 3.3                        | 2.97                        | 3.3                         | 3.63                        | V    |
| 001            | 1.8                        | 1.7                         | 1.8                         | 1.98                        | V    |
| 010            | 2.5                        | 2.97                        | 3.3                         | 3.63                        | V    |
| 011            | 1.8                        | 2.97                        | 3.3                         | 3.63                        | V    |
| 100            | 3.3                        | 4.5                         | 5                           | 5.5                         | V    |
| 101            | 1.8                        | 2.25                        | 2.5                         | 2.75                        | V    |
| 110            | 2.5                        | 2.25                        | 2.5                         | 2.75                        | V    |
| 111 (reserved) | _                          | _                           | _                           | _                           | _    |

<sup>21.8</sup> V and 2.5 V I/O are supported only on ADSP-BF504 nonautomotive models. All ADSP-BF50x flash and automotive models support 3.3 V I/O only.

<sup>&</sup>lt;sup>3</sup> For ADSP-BF504, V<sub>DDFLASH</sub> pins should be connected to GND.

<sup>&</sup>lt;sup>4</sup> Parameter value applies to all input and bidirectional pins, except SDA and SCL.

<sup>&</sup>lt;sup>5</sup> Bidirectional pins (PF15–0, PG15–0, PH15–0) and input pins (TCK, TDI, TMS,  $\overline{TRST}$ , CLKIN,  $\overline{RESET}$ ,  $\overline{NMI}$ , and BMODE2–0) of the ADSP-BF50x processors are 2.5 V tolerant (always accept up to 2.7 V maximum V<sub>IH</sub>). Voltage compliance (on outputs, V<sub>OH</sub>) is limited by the V<sub>DDEXT</sub> supply voltage.

<sup>&</sup>lt;sup>6</sup> Bidirectional pins (PF15-0, PG15-0, PH2-0) and input pins (TCK, TDI, TMS, TRST, CLKIN, RESET, NMI, and BMODE2-0) of the ADSP-BF50x processors are 3.3 V tolerant (always accept up to 3.6 V maximum V<sub>IH</sub>). Voltage compliance (on outputs, V<sub>OH</sub>) is limited by the V<sub>DDEXT</sub> supply voltage.

<sup>&</sup>lt;sup>7</sup> The V<sub>IHTIWI</sub> min and max value vary with the selection in the TWI\_DT field of the NONGPIO\_DRIVE register. See V<sub>BUSTWI</sub> min and max values in Table 13.

 $<sup>^8\,\</sup>mathrm{SDA}$  and SCL are pulled up to  $V_{BUSTWI}.$  See Table 13.

#### ADSP-BF50x Clock Related Operating Conditions

Table 14 describes the core clock timing requirements for the ADSP-BF50x processors. Take care in selecting MSEL, SSEL, and CSEL ratios so as not to exceed the maximum core clock and system clock (see Table 16). Table 15 describes phase-locked loop operating conditions.

Table 14. Core Clock (CCLK) Requirements—ADSP-BF50x Processors—All Speed Grades

|            |   |                        |                        | Max CCLK  |      |
|------------|---|------------------------|------------------------|-----------|------|
| Paramete   | 1   | Min V <sub>DDINT</sub> | Nom V <sub>DDINT</sub> | Frequency | Unit |
| $f_{CCLK}$ | Core Clock Frequency (All Models)                   | 1.33 V                 | 1.400 V                | 400       | MHz  |
|            | Core Clock Frequency (Industrial/Commercial Models) | 1.16 V                 | 1.225 V                | 300       | MHz  |
|            | Core Clock Frequency (Industrial Models Only)       | 1.14 V                 | 1.200 V                | 200       | MHz  |
|            | Core Clock Frequency (Commercial Models Only)       | 1.10 V                 | 1.150 V                | 200       | MHz  |

Table 15. Phase-Locked Loop Operating Conditions

| Parameter        |   | Min | Max                           | Unit |
|------------------|---|-----|-------------------------------|------|
| f <sub>VCO</sub> | Voltage Controlled Oscillator (VCO) Frequency<br>(Commercial/Industrial Models) | 72  | Instruction Rate <sup>1</sup> | MHz  |
|                  | Voltage Controlled Oscillator (VCO) Frequency (Automotive Models)               | 84  | Instruction Rate <sup>1</sup> | MHz  |

<sup>&</sup>lt;sup>1</sup> For more information, see Ordering Guide on Page 81.

Table 16. Maximum SCLK Conditions for ADSP-BF50x Processors

| Parameter         |   | <b>V</b> <sub>DDEXT</sub> = 1.8 <b>V</b> /2.5 <b>V</b> /3.3 <b>V Nominal</b> | Unit |
|-------------------|---|--|------|
| $f_{\text{SCLK}}$ | CLKOUT/SCLK Frequency (V <sub>DDINT</sub> ≥ 1.16 V) | 100  | MHz  |
|                   | CLKOUT/SCLK Frequency (V <sub>DDINT</sub> < 1.16 V) | 80   | MHz  |

### **ELECTRICAL CHARACTERISTICS**

| Parameter                             |   | Test Conditions   | Min  | Typical | Max   | Unit             |
|---------------------------------------|---|---|------|---------|---|------------------|
| V <sub>OH</sub>                       | High Level Output Voltage   | $V_{DDEXT} = 1.7 \text{ V, } I_{OH} = -0.5 \text{ mA}$  | 1.35 |         |   | V                |
|                                       | High Level Output Voltage   | $V_{DDEXT} = 2.25 \text{ V, } I_{OH} = -0.5 \text{ mA}$   | 2.0  |         |   | V                |
|                                       | High Level Output Voltage   | $V_{DDEXT} = 3.0 \text{ V, } I_{OH} = -0.5 \text{ mA}$  | 2.4  |         |   | V                |
| $V_{OL}$                              | Low Level Output Voltage  | $V_{DDEXT} = 1.7 \text{ V}/2.25 \text{ V}/3.0 \text{ V},$<br>$I_{OL} = 2.0 \text{ mA}$  |      |         | 0.4   | V                |
| I <sub>IH</sub>                       | High Level Input Current <sup>1</sup>   | $V_{DDEXT} = 3.6 \text{ V}, V_{IN} = 3.6 \text{ V}$   |      |         | 10.0  | μΑ               |
| $I_{\rm IL}$                          | Low Level Input Current <sup>1</sup>  | $V_{DDEXT} = 3.6 \text{ V}, V_{IN} = 0 \text{ V}$   |      |         | 10.0  | μΑ               |
| $I_{\mathrm{IHP}}$                    | High Level Input Current JTAG <sup>2</sup>                                      | $V_{DDEXT} = 3.6 \text{ V}, V_{IN} = 3.6 \text{ V}$   |      |         | 75.0  | μΑ               |
| $I_{OZH}$                             | Three-State Leakage Current <sup>3</sup>  | $V_{DDEXT} = 3.6 \text{ V}, V_{IN} = 3.6 \text{ V}$   |      |         | 10.0  | μΑ               |
| I <sub>OZHTWI</sub>                   | Three-State Leakage Current <sup>4</sup>  | $V_{DDEXT} = 3.0 \text{ V}, V_{IN} = 5.5 \text{ V}$   |      |         | 10.0  | μΑ               |
| $I_{OZL}$                             | Three-State Leakage Current <sup>3</sup>  | $V_{DDEXT} = 3.6 \text{ V}, V_{IN} = 0 \text{ V}$   |      |         | 10.0  | μΑ               |
| C <sub>IN</sub>                       | Input Capacitance <sup>5,6</sup>  | $\begin{split} f_{\text{IN}} &= 1 \text{ MHz, } T_{\text{AMBIENT}} = 25^{\circ}\text{C,} \\ V_{\text{IN}} &= 2.5 \text{ V} \end{split}$ |      | 5       | 8   | pF               |
| C <sub>INTWI</sub>                    | Input Capacitance <sup>4,6</sup>  | $\begin{split} f_{\text{IN}} &= 1 \text{ MHz, } T_{\text{AMBIENT}} = 25^{\circ}\text{C,} \\ V_{\text{IN}} &= 2.5 \text{ V} \end{split}$ |      |         | 10  | pF               |
| I <sub>DDDEEPSLEEP</sub> <sup>7</sup> | V <sub>DDINT</sub> Current in Deep Sleep Mode                                   | $V_{DDINT} = 1.2 \text{ V, } f_{CCLK} = 0 \text{ MHz,} $<br>$f_{SCLK} = 0 \text{ MHz, } T_{J} = 25^{\circ}\text{C,} $<br>ASF = 0.00     |      | 1.85    |   | mA               |
| I <sub>DDSLEEP</sub>                  | V <sub>DDINT</sub> Current in Sleep Mode  | $V_{DDINT} = 1.2 \text{ V}, f_{SCLK} = 25 \text{ MHz},$<br>$T_J = 25^{\circ}\text{C}$   |      | 2.1     |   | mA               |
| I <sub>DD-IDLE</sub>                  | V <sub>DDINT</sub> Current in Idle  | $V_{DDINT} = 1.2 \text{ V, } f_{CCLK} = 50 \text{ MHz,}$<br>$T_{J} = 25^{\circ}\text{C, ASF} = 0.42$                                    |      | 18      |   | mA               |
| I <sub>DD-TYP</sub>                   | V <sub>DDINT</sub> Current  | $V_{DDINT} = 1.40 \text{ V}, f_{CCLK} = 400 \text{ MHz}, $<br>$T_{J} = 25^{\circ}\text{C}, \text{ ASF} = 1.00$                          |      | 104     |   | mA               |
|                                       | V <sub>DDINT</sub> Current  | $V_{DDINT} = 1.225 \text{ V}, f_{CCLK} = 300 \text{ MHz}, $<br>$T_{J} = 25^{\circ}\text{C}, \text{ ASF} = 1.00$                         |      | 69      |   | mA               |
|                                       | V <sub>DDINT</sub> Current  | $V_{DDINT} = 1.2 \text{ V, } f_{CCLK} = 200 \text{ MHz,}$<br>$T_{J} = 25^{\circ}\text{C, ASF} = 1.00$                                   |      | 51      |   | mA               |
| I <sub>DDHIBERNATE</sub> <sup>8</sup> | Hibernate State Current   | $V_{DDEXT}$ = 3.30 V,<br>$V_{DDFLASH}$ = 1.8 V, $T_J$ = 25°C,<br>CLKIN = 0 MHz ( $V_{DDINT}$ = 0 V)                                     |      | 40      |   | μА               |
| I <sub>DDSLEEP</sub> 9                | V <sub>DDINIT</sub> Current in Sleep Mode                                       | $f_{CCLK} = 0 \text{ MHz}, f_{SCLK} > 0 \text{ MHz}$  |      |         | Table 18 + $(.16 \times V_{DDINT} \times f_{SCLK})$                         | mA <sup>10</sup> |
| I <sub>DDDEEPSLEEP</sub> 9            | V <sub>DDINT</sub> Current in Deep Sleep Mode                                   | $f_{CCLK} = 0 \text{ MHz}, f_{SCLK} = 0 \text{ MHz}$  |      |         | Table 18  | mA               |
| I <sub>DDINT</sub> <sup>9</sup>       | V <sub>DDINT</sub> Current  | $f_{CCLK} > 0 \text{ MHz}, f_{SCLK} \ge 0 \text{ MHz}$  |      |         | Table 18 + $(Table 19 \times ASF) + (.16 \times V_{DDINT} \times f_{SCLK})$ | mA               |
| I <sub>DDFLASH1</sub>                 | Flash Memory Supply Current 1 — Asynchronous Read (5 MHz NORCLK <sup>11</sup> ) |   |      | 10      | 20  | mA               |
|                                       | Flash Memory Supply Current 1   | 4 Word  |      | 18      | 20  | mA               |
|                                       | — Synchronous Read (50 MHz  | 8 Word  |      | 20      | 22  | mA               |
|                                       | NORCLK <sup>11</sup> )  | 16 Word   |      | 25      | 27  | mA               |
|                                       |   | Continuous  |      | 28      | 30  | mA               |

| Parameter             | r   | <b>Test Conditions</b>                                       | Min | Typical | Max | Unit |
|-----------------------|---|--|-----|---------|-----|------|
| I <sub>DDFLASH2</sub> | Flash Memory Supply Current 2 — Reset/Powerdown                         |  |     | 15      | 50  | μΑ   |
| I <sub>DDFLASH3</sub> | Flash Memory Supply Current 3 — Standby                                 |  |     | 15      | 50  | μΑ   |
| I <sub>DDFLASH4</sub> | Flash Memory Supply Current 4 — Automatic Standby                       |  |     | 15      | 50  | μΑ   |
| I <sub>DDFLASH5</sub> | Flash Memory Supply Current 5<br>— Program                              |  |     | 15      | 40  | mA   |
|                       | Flash Memory Supply Current 5<br>— Erase                                |  |     | 15      | 40  | mA   |
| I <sub>DDFLASH6</sub> | Flash Memory Supply Current 6 — Dual Operations                         | Program/Erase in one bank, asynchronous read in another bank |     | 25      | 60  | mA   |
|                       |   | Program/Erase in one bank, synchronous read in another bank  |     | 43      | 70  | mA   |
| I <sub>DDFLASH7</sub> | Flash Memory Supply Current 7<br>— Program/Erase Suspended<br>(Standby) |  |     | 15      | 50  | μΑ   |

<sup>&</sup>lt;sup>1</sup> Applies to input pins.

 $<sup>^2</sup>$  Applies to JTAG input pins (TCK, TDI, TMS,  $\overline{\text{TRST}}\text{)}.$ 

<sup>&</sup>lt;sup>3</sup> Applies to three-statable pins.

<sup>&</sup>lt;sup>4</sup> Applies to bidirectional pins SCL and SDA.

<sup>&</sup>lt;sup>5</sup> Applies to all signal pins, except SCL and SDA.

<sup>&</sup>lt;sup>6</sup>Guaranteed, but not tested.

<sup>&</sup>lt;sup>7</sup> See the ADSP-BF50x Blackfin Processor Hardware Reference Manual for definition of sleep, deep sleep, and hibernate operating modes.

 $<sup>^8</sup>$  Applies to  $V_{\mbox{\scriptsize DDEXT}}$  supply only. Clock inputs are tied high or low.

<sup>&</sup>lt;sup>9</sup>Guaranteed maximum specifications.

 $<sup>^{10}</sup>$ Unit for  $V_{DDINT}$  is V (Volts). Unit for  $f_{SCLK}$  is MHz. Example: 1.4 V, 75 MHz would be  $0.16 \times 1.4 \times 75 = 16.8$  mA adder.

 $<sup>^{11}\</sup>mbox{See}$  the ADSP-BF50x Blackfin Processor Hardware Reference Manual for definition of NORCLK.

#### **Total Power Dissipation**

Total power dissipation has two components:

- 1. Static, including leakage current
- 2. Dynamic, due to transistor switching characteristics

Many operating conditions can also affect power dissipation, including temperature, voltage, operating frequency, and processor activity. Electrical Characteristics on Page 28 shows the current dissipation for internal circuitry ( $V_{\rm DDINT}$ ).  $I_{\rm DDDEEPSLEEP}$  specifies static power dissipation as a function of voltage ( $V_{\rm DDINT}$ ) and temperature (see Table 18), and  $I_{\rm DDINT}$  specifies the total power specification for the listed test conditions, including the dynamic component as a function of voltage ( $V_{\rm DDINT}$ ) and frequency (Table 19).

There are two parts to the dynamic component. The first part is due to transistor switching in the core clock (CCLK) domain. This part is subject to an Activity Scaling Factor (ASF) which represents application code running on the processor core and L1 memories (Table 17).

The ASF is combined with the CCLK Frequency and  $V_{\rm DDINT}$  dependent data in Table 19 to calculate this part. The second part is due to transistor switching in the system clock (SCLK) domain, which is included in the  $I_{\rm DDINT}$  specification equation.

Table 17. Activity Scaling Factors (ASF)<sup>1</sup>

| I <sub>DDINT</sub> Power Vector | Activity Scaling Factor (ASF) |
|---------------------------------|-------------------------------|
| I <sub>DD-PEAK</sub>            | 1.27                          |
| I <sub>DD-HIGH</sub>            | 1.24                          |
| I <sub>DD-TYP</sub>             | 1.00                          |
| I <sub>DD-APP</sub>             | 0.85                          |
| I <sub>DD-NOP</sub>             | 0.71                          |
| I <sub>DD-IDLE</sub>            | 0.42                          |

 $<sup>^1</sup>$  See Estimating Power for ASDP-BF534/BF536/BF537 Blackfin Processors (EE-297). The power vector information also applies to the ADSP-BF50x processors.

Table 18. Static Current—I<sub>DD-DEEPSLEEP</sub> (mA)

| T <sub>J</sub> (°C) <sup>1</sup> | Voltage (V <sub>DDINT</sub> ) <sup>1</sup> |        |        |        |        |        |        |        |        |  |  |
|----------------------------------|--|--------|--------|--------|--------|--------|--------|--------|--------|--|--|
|                                  | 1.10 V                                     | 1.15 V | 1.20 V | 1.25 V | 1.30 V | 1.35 V | 1.40 V | 1.45 V | 1.50 V |  |  |
| -40                              | 0.20                                       | 0.23   | 0.26   | 0.29   | 0.31   | 0.34   | 0.37   | 0.40   | 0.43   |  |  |
| -20                              | 0.30                                       | 0.34   | 0.38   | 0.43   | 0.47   | 0.51   | 0.55   | 0.59   | 0.63   |  |  |
| 0                                | 0.50                                       | 0.57   | 0.63   | 0.70   | 0.77   | 0.83   | 0.90   | 0.97   | 1.03   |  |  |
| 25                               | 0.90                                       | 1.03   | 1.17   | 1.30   | 1.43   | 1.57   | 1.70   | 1.83   | 1.97   |  |  |
| 40                               | 1.30                                       | 1.50   | 1.70   | 1.90   | 2.10   | 2.30   | 2.50   | 2.70   | 2.90   |  |  |
| 55                               | 2.00                                       | 2.30   | 2.60   | 2.90   | 3.20   | 3.50   | 3.80   | 4.10   | 4.40   |  |  |
| 70                               | 3.00                                       | 3.47   | 3.93   | 4.40   | 4.87   | 5.33   | 5.80   | 6.27   | 6.73   |  |  |
| 85                               | 4.60                                       | 5.23   | 5.87   | 6.50   | 7.13   | 7.77   | 8.40   | 9.03   | 9.67   |  |  |
| 100                              | 6.80                                       | 7.67   | 8.53   | 9.40   | 10.27  | 11.13  | 12.00  | 12.87  | 13.73  |  |  |
| 105                              | 7.80                                       | 8.77   | 9.73   | 10.70  | 11.67  | 12.63  | 13.60  | 14.57  | 15.53  |  |  |
| 125                              | 12.50                                      | 14.00  | 15.50  | 17.00  | 18.50  | 20.00  | 21.50  | 23.00  | 24.50  |  |  |

<sup>&</sup>lt;sup>1</sup>Valid frequency and voltage ranges are model-specific. See Operating Conditions on Page 26.

Table 19. Dynamic Current in CCLK Domain (mA, with ASF = 1.0)<sup>1</sup>

| f <sub>CCLK</sub><br>(MHz) <sup>2</sup> | Voltage (V <sub>DDINT</sub> ) <sup>2</sup> |        |        |        |        |        |        |        |        |  |
|---|--|--------|--------|--------|--------|--------|--------|--------|--------|--|
|   | 1.10 V                                     | 1.15 V | 1.20 V | 1.25 V | 1.30 V | 1.35 V | 1.40 V | 1.45 V | 1.50 V |  |
| 400                                     | N/A  | N/A    | N/A    | N/A    | 84.46  | 88.30  | 92.39  | 96.35  | 100.49 |  |
| 350                                     | N/A  | N/A    | N/A    | N/A    | 74.30  | 77.93  | 81.39  | 84.94  | 88.61  |  |
| 300                                     | N/A  | N/A    | 58.58  | 61.46  | 64.49  | 67.59  | 70.71  | 73.76  | 77.04  |  |
| 250                                     | 43.76                                      | 46.22  | 48.64  | 51.09  | 53.61  | 56.19  | 58.93  | 61.56  | 64.22  |  |
| 200                                     | 35.26                                      | 37.37  | 39.29  | 41.33  | 43.40  | 45.54  | 47.79  | 49.88  | 52.18  |  |
| 150                                     | 26.71                                      | 28.38  | 29.87  | 31.46  | 33.09  | 34.83  | 36.56  | 38.22  | 39.95  |  |
| 100                                     | 18.04                                      | 19.20  | 20.25  | 21.46  | 22.61  | 23.83  | 25.13  | 26.39  | 27.72  |  |

<sup>&</sup>lt;sup>1</sup> The values are not guaranteed as standalone maximum specifications. They must be combined with static current per the equations of Electrical Characteristics on Page 28.

<sup>&</sup>lt;sup>2</sup>Valid frequency and voltage ranges are model-specific. See Operating Conditions on Page 26 and ADSP-BF50x Clock Related Operating Conditions on Page 27.

#### PROCESSOR—ABSOLUTE MAXIMUM RATINGS

Stresses greater than those listed in Table 20 may cause permanent damage to the device. These are stress ratings only. Functional operation of the device at these or any other conditions greater than those indicated in the operational sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

Table 20. Absolute Maximum Ratings

| Parameter   | Rating                    |
|---|---------------------------|
| Internal Supply Voltage (V <sub>DDINT</sub> )                       | -0.3 V to +1.5 V          |
| External (I/O) Supply Voltage (V <sub>DDEXT</sub> )                 | -0.3 V to +3.8 V          |
| Input Voltage <sup>1, 2</sup>                                       | -0.5 V to +3.6 V          |
| Input Voltage <sup>1, 2, 3</sup>                                    | -0.5 V to +5.5 V          |
| Output Voltage Swing  | -0.5 V to                 |
|   | V <sub>DDEXT</sub> +0.5 V |
| I <sub>OH</sub> /I <sub>OL</sub> Current per Pin Group <sup>4</sup> | 76 mA (max)               |
| Storage Temperature Range   | -65°C to +150°C           |
| Junction Temperature While Biased                                   | +110°C                    |
| (Nonautomotive Models)  |                           |
| Junction Temperature While Biased                                   | +125°C                    |
| (Automotive Models)   |                           |

<sup>&</sup>lt;sup>1</sup> Applies to 100% transient duty cycle. For other duty cycles see Table 21.

Table 21. Maximum Duty Cycle for Input Transient Voltage<sup>1</sup>

| V <sub>IN</sub> Min (V) <sup>2</sup> | V <sub>IN</sub> Max (V) <sup>2</sup> | Maximum Duty Cycle <sup>3</sup> |
|--------------------------------------|--------------------------------------|---------------------------------|
| -0.50                                | +3.80                                | 100%                            |
| -0.70                                | +4.00                                | 40%                             |
| -0.80                                | +4.10                                | 25%                             |
| -0.90                                | +4.20                                | 15%                             |
| -1.00                                | +4.30                                | 10%                             |

 $<sup>^{\</sup>rm 1}$  Applies to all signal pins with the exception of CLKIN, XTAL, EXT\_WAKE.

Table 22 specifies the maximum total source/sink ( $I_{OH}/I_{OL}$ ) current for a group of pins. Permanent damage can occur if this value is exceeded. To understand this specification, if pins PG5, PG6, PG7, PG8, and PG9 from group 5 in the Total Current Pin Groups table, each were sourcing or sinking 2 mA each, the total current for those pins would be 10 mA. This would allow up to 66 mA total that could be sourced or sunk by the remaining pins in the group without damaging the device. For a list of all groups and their pins, see the Total Current Pin Groups table. Note that the  $V_{\rm OL}$  and  $V_{\rm OL}$  specifications have separate per-pin maximum current requirements, see the Electrical Characteristics table.

Table 22. Total Current Pin Groups

| Group | Pins in Group                          |
|-------|--|
| 1     | PF10, PF11                             |
| 2     | PF12, PF13, PF14, PF15                 |
| 3     | PG0                                    |
| 4     | PG1, PG2, PG3, PG4                     |
| 5     | PG5, PG6, PG7, PG8, PG9, PG10, PG11    |
| 6     | PG12, PG13, PG14, PG15, SDA, SCL       |
| 7     | EMU, EXT_WAKE, PG                      |
| 8     | PF0, PF1, PH0, PH1, PH2                |
| 9     | EXTCLK                                 |
| 10    | PF2, PF3, PF4, PF5, PF6, PF7, PF8, PF9 |

 $<sup>^2</sup>$  Applies only when  $V_{\rm DDEXT}$  is within specifications. When  $V_{\rm DDEXT}$  is outside specifications, the range is  $V_{\rm DDEXT} \pm 0.2~V.$ 

<sup>&</sup>lt;sup>3</sup> Applies to pins SCL and SDA.

<sup>&</sup>lt;sup>4</sup>For more information, see description preceding Table 22.

<sup>&</sup>lt;sup>2</sup> The individual values cannot be combined for analysis of a single instance of overshoot or undershoot. The worst case observed value must fall within one of the voltages specified, and the total duration of the overshoot or undershoot (exceeding the 100% case) must be less than or equal to the corresponding duty cycle.

<sup>&</sup>lt;sup>3</sup> Duty cycle refers to the percentage of time the signal exceeds the value for the 100% case. The is equivalent to the measured duration of a single instance of overshoot or undershoot as a percentage of the period of occurrence.

#### **ESD SENSITIVITY**



### ESD (electrostatic discharge) sensitive device.

Charged devices and circuit boards can discharge without detection. Although this product features patented or proprietary circuitry, damage may occur on devices subjected to high energy ESD. Therefore, proper ESD precautions should be taken to avoid performance degradation or loss of functionality.

#### **PACKAGE INFORMATION**

The information presented in Figure 9 and Table 23 provides details about the package branding for the ADSP-BF50x processors.



Figure 9. Product Information on Package

Table 23. Package Brand Information<sup>1</sup>

| Brand Key  | Field Description          |
|------------|----------------------------|
| ADSP-BF50x | Product Name <sup>2</sup>  |
| t          | Temperature Range          |
| рр         | Package Type               |
| Z          | RoHS Compliant Designation |
| ccc        | See Ordering Guide         |
| VVVVV.X    | Assembly Lot Code          |
| n.n        | Silicon Revision           |
| #          | RoHS Compliance Designator |
| yyww       | Date Code                  |

<sup>&</sup>lt;sup>1</sup> Nonautomotive only. For branding information specific to Automotive products, contact Analog Devices Inc.

<sup>&</sup>lt;sup>2</sup> See product names in the Ordering Guide on Page 81.

#### PROCESSOR—TIMING SPECIFICATIONS

Specifications subject to change without notice.

#### Clock and Reset Timing

Table 24 and Figure 10 describe clock and reset operations. Per the CCLK and SCLK timing specifications in Table 14 to Table 16, combinations of CLKIN and clock multipliers must not select core/peripheral clocks in excess of the processor's speed grade. Table 25 and Figure 11 describe clock out timing.

Table 24. Clock and Reset Timing

| Parameter            |  | Min                  | Max | Unit |
|----------------------|--|----------------------|-----|------|
| Timing Requirements  |  |                      |     |      |
| $f_{CKIN}$           | CLKIN Frequency <sup>1, 2, 3, 4</sup> (Commercial/Industrial Models) | 12                   | 50  | MHz  |
|                      | CLKIN Frequency <sup>1, 2, 3, 4</sup> (Automotive Models)            | 14                   | 50  | MHz  |
| t <sub>CKINL</sub>   | CLKIN Low Pulse <sup>1</sup>   | 10                   |     | ns   |
| t <sub>CKINH</sub>   | CLKIN High Pulse <sup>1</sup>  | 10                   |     | ns   |
| t <sub>WRST</sub>    | RESET Asserted Pulse Width Low <sup>5</sup>                          | $11 \times t_{CKIN}$ |     | ns   |
| Switching Ch         | paracteristic  |                      |     |      |
| t <sub>BUFDLAY</sub> | CLKIN to CLKBUF <sup>6</sup> Delay                                   |                      | 11  | ns   |

<sup>&</sup>lt;sup>1</sup> Applies to PLL bypass mode and PLL non bypass mode.

<sup>&</sup>lt;sup>6</sup> The ADSP-BF504/ADSP-BF504F/ADSP-BF506F processor does not have a dedicated CLKBUF pin. Rather, the EXTCLK pin may be programmed to serve as CLKBUF or CLKOUT. This parameter applies when EXTCLK is programmed to output CLKBUF.

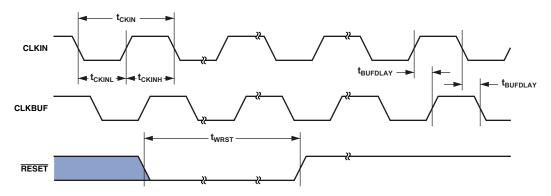


Figure 10. Clock and Reset Timing

<sup>&</sup>lt;sup>2</sup> Combinations of the CLKIN frequency and the PLL clock multiplier must not exceed the allowed  $f_{VCO}$ ,  $f_{CCLK}$ , and  $f_{SCLK}$  settings discussed in Table 14 on Page 27 through Table 16 on Page 27.

 $<sup>^3\,</sup> The\ t_{CKIN}$  period (see Figure 10) equals  $1/f_{CKIN}.$ 

<sup>&</sup>lt;sup>4</sup> If the DF bit in the PLL\_CTL register is set, the minimum f<sub>CKIN</sub> specification is 24 MHz for commercial/industrial models and 28 MHz for automotive models.

<sup>&</sup>lt;sup>5</sup> Applies after power-up sequence is complete. See Table 26 and Figure 12 for power-up reset timing.

Table 25. Clock Out Timing

|                    |   |     | $V_{DDEXT} = 1.8 V$ |     | $V_{DDEXT} = 2.5 \text{ V}/3.3 \text{ V}$ |      |    |  |
|--------------------|---|-----|---------------------|-----|---|------|----|--|
| Parameter          |   | Min | Max                 | Min | Max                                       | Unit |    |  |
| Switching          | Characteristics                           |     |                     |     |   |      |    |  |
| $t_{\text{SCLK}}$  | CLKOUT <sup>1</sup> Period <sup>2,3</sup> |     | 10                  |     | 10  |      | ns |  |
| $t_{\text{SCLKH}}$ | CLKOUT <sup>1</sup> Width High            |     | 4                   |     | 4   |      | ns |  |
| $t_{SCLKL}$        | CLKOUT <sup>1</sup> Width Low             |     | 4                   |     | 4   |      | ns |  |

<sup>&</sup>lt;sup>1</sup> The ADSP-BF504/ADSP-BF504F/ADSP-BF506F processor does not have a dedicated CLKOUT pin. Rather, the EXTCLK pin may be programmed to serve as CLKBUF or CLKOUT. This parameter applies when EXTCLK is programmed to output CLKOUT.

 $<sup>^3\,\</sup>mbox{The}\ t_{SCLK}$  value does not account for the effects of jitter.

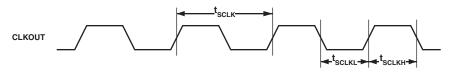
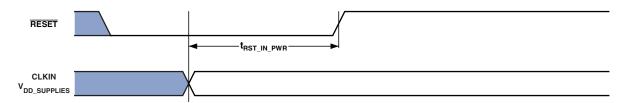


Figure 11. Clock Out Timing

Table 26. Power-Up Reset Timing

| Paramete   | r  | Min                      | Unit |    |
|------------|--|--------------------------|------|----|
| Timing Rec | nuirement $\overline{\text{RESET}}$ Deasserted after the $V_{\text{DDINT}}$ , $V_{\text{DDEXT}}$ , $V_{\text{DDFLASH}}$ , and CLKIN Pins are Stable and Within Specification | 3500 × t <sub>CKIN</sub> |      | ns |



In Figure 12,  $V_{\text{DD\_SUPPLIES}}$  is  $V_{\text{DDINT}}$ ,  $V_{\text{DDEXT}}$ , and  $V_{\text{DDFLASH}}$ .

Figure 12. Power-Up Reset Timing

 $<sup>^2</sup>$  The  $t_{SCLK}$  value is the inverse of the  $f_{SCLK}$  specification. Reduced supply voltages affect the best-case value of 10 ns listed here.

#### **Parallel Peripheral Interface Timing**

Table 27 and Figure 14 on Page 35, Figure 20 on Page 40, and Figure 22 on Page 41 describe parallel peripheral interface operations.

Table 27. Parallel Peripheral Interface Timing

| •                   |  | V                       | <sub>DDEXT</sub> = 1.8 V | V <sub>DDE</sub>        | $_{XT} = 2.5 \text{ V}/3.3 \text{ V}$ |      |
|---------------------|--|-------------------------|--------------------------|-------------------------|---------------------------------------|------|
| Paramete            | er   | Min                     | Max                      | Min                     | Max                                   | Unit |
| Timing Re           | quirements   |                         |                          |                         |                                       |      |
| $t_{\text{PCLKW}}$  | PPI_CLK Width <sup>1</sup>   | t <sub>SCLK</sub> – 1.5 |                          | t <sub>SCLK</sub> - 1.5 | 5                                     | ns   |
| t <sub>PCLK</sub>   | PPI_CLK Period <sup>1</sup>  | $2 \times t_{SCLK}$ –   | 1.5                      | $2 \times t_{SCLK}$     | -1.5                                  | ns   |
| Timing Re           | quirements—GP Input and Frame Capture Modes  |                         |                          |                         |                                       |      |
| $t_{\text{PSUD}}$   | External Frame Sync Startup Delay <sup>2</sup>   | $4 \times t_{PCLK}$     |                          | $4 \times t_{PCLK}$     |                                       | ns   |
| t <sub>SFSPE</sub>  | External Frame Sync Setup Before PPI_CLK (Nonsampling Edge for Rx, Sampling Edge for Tx) | 6.7                     |                          | 6.7                     |                                       | ns   |
| t <sub>HFSPE</sub>  | External Frame Sync Hold After PPI_CLK   | 1.5                     |                          | 1.5                     |                                       | ns   |
| t <sub>SDRPE</sub>  | Receive Data Setup Before PPI_CLK  | 4.1                     |                          | 3.5                     |                                       | ns   |
| t <sub>HDRPE</sub>  | Receive Data Hold After PPI_CLK  | 2                       |                          | 1.6                     |                                       | ns   |
| Switching           | Characteristics—GP Output and Frame Capture Modes  |                         |                          |                         |                                       |      |
| t <sub>DFSPE</sub>  | Internal Frame Sync Delay After PPI_CLK  |                         | 8.7                      |                         | 8.0                                   | ns   |
| t <sub>HOFSPE</sub> | Internal Frame Sync Hold After PPI_CLK   | 1.7                     |                          | 1.7                     |                                       | ns   |
| t <sub>DDTPE</sub>  | Transmit Data Delay After PPI_CLK  |                         | 8.7                      |                         | 8.0                                   | ns   |
| t <sub>HDTPE</sub>  | Transmit Data Hold After PPI_CLK   | 2.3                     |                          | 1.9                     |                                       | ns   |

<sup>&</sup>lt;sup>1</sup> PPI\_CLK frequency cannot exceed f<sub>SCLK</sub>/2

<sup>&</sup>lt;sup>2</sup> The PPI port is fully enabled 4 PPI clock cycles after the PAB write to the PPI port enable bit. Only after the PPI port is fully enabled are external frame syncs and data words guaranteed to be received correctly by the PPI peripheral.

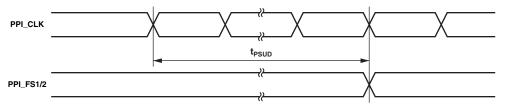


Figure 13. PPI with External Frame Sync Timing

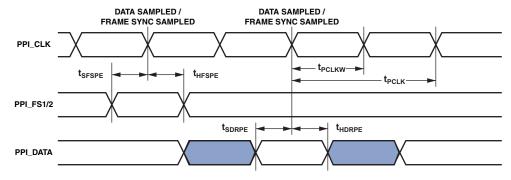


Figure 14. PPI GP Rx Mode with External Frame Sync Timing

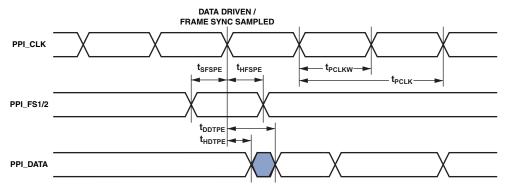


Figure 15. PPI GP Tx Mode with External Frame Sync Timing

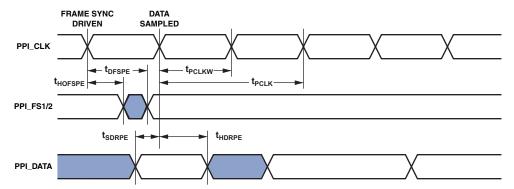


Figure 16. PPI GP Rx Mode with Internal Frame Sync Timing

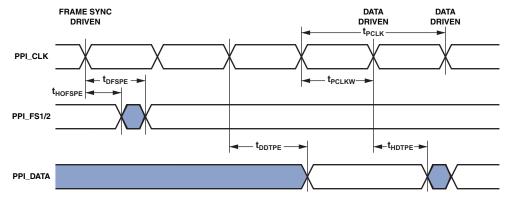


Figure 17. PPI GP Tx Mode with Internal Frame Sync Timing

## **RSI Controller Timing**

Table 28 and Figure 18 describe RSI Controller Timing. Table 29 and Figure 19 describe RSI controller (high speed) timing.

### **Table 28. RSI Controller Timing**

| Para            | meter  | Min              | Max | Unit |
|-----------------|--|------------------|-----|------|
| Timin           | g Requirements                               |                  |     |      |
| $t_{ISU}$       | Input Setup Time                             | 5.75             |     | ns   |
| $t_{\text{IH}}$ | Input Hold Time                              | 2                |     | ns   |
| Switc           | hing Characteristics                         |                  |     |      |
| $f_{PP}^{-1}$   | Clock Frequency Data Transfer Mode           | 0                | 25  | MHz  |
| $f_{OD}$        | Clock Frequency Identification Mode          | 100 <sup>2</sup> | 400 | kHz  |
| $t_WL$          | Clock Low Time                               | 10               |     | ns   |
| $t_{WH}$        | Clock High Time                              | 10               |     | ns   |
| $t_{TLH}$       | Clock Rise Time                              |                  | 10  | ns   |
| $t_{THL}$       | Clock Fall Time                              |                  | 10  | ns   |
| $t_{ODLY}$      | Output Delay Time During Data Transfer Mode  |                  | 14  | ns   |
| $t_{ODLY}$      | Output Delay Time During Identification Mode |                  | 50  | ns   |

 $<sup>^{1}\,</sup>t_{_{PP}}=1/f_{_{PP}}.$ 

<sup>&</sup>lt;sup>2</sup> Specification can be 0 kHz, which means to stop the clock. The given minimum frequency range is for cases where a continuous clock is required.

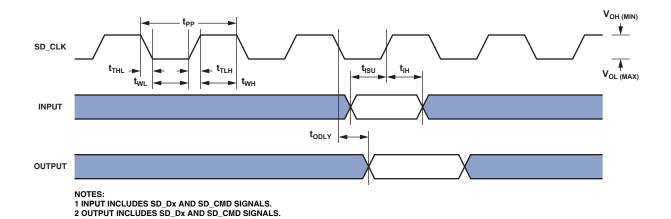
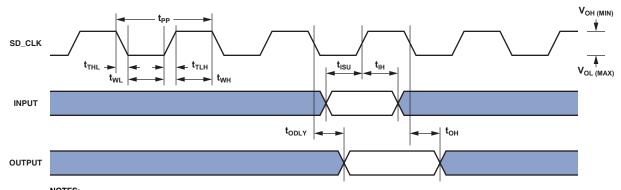


Figure 18. RSI Controller Timing

Table 29. RSI Controller Timing (High Speed Mode)

| Parar           | neter                                       | Min  | Max | Unit |
|-----------------|---|------|-----|------|
| Timin           | g Requirements                              |      |     |      |
| $t_{ISU}$       | Input Setup Time                            | 5.75 |     | ns   |
| $t_{\text{IH}}$ | Input Hold Time                             | 2    |     | ns   |
| Switch          | ning Characteristics                        |      |     |      |
| $f_{PP}^{-1}$   | Clock Frequency Data Transfer Mode          | 0    | 50  | MHz  |
| $t_WL$          | Clock Low Time                              | 7    |     | ns   |
| $t_{WH}$        | Clock High Time                             | 7    |     | ns   |
| $t_{TLH}$       | Clock Rise Time                             |      | 3   | ns   |
| $t_{THL}$       | Clock Fall Time                             |      | 3   | ns   |
| $t_{ODLY}$      | Output Delay Time During Data Transfer Mode |      | 2.5 | ns   |
| t <sub>OH</sub> | Output Hold Time                            | 2.5  |     | ns   |

 $<sup>^{1}</sup>$   $t_{pp} = 1/f_{pp}$ .



NOTES: 1 INPUT INCLUDES SD\_Dx AND SD\_CMD SIGNALS. 2 OUTPUT INCLUDES SD\_Dx AND SD\_CMD SIGNALS.

Figure 19. RSI Controller Timing (High-Speed Mode)

#### **Serial Ports**

Table 30 through Table 33 on Page 41 and Figure 20 on Page 40 through Figure 22 on Page 41 describe serial port operations.

Table 30. Serial Ports—External Clock

|                     |   | V                   | 7 <sub>DDEXT</sub> = 1.8 V | V <sub>DDEX</sub>   | <sub>T</sub> = 2.5 V/3.3 V |      |
|---------------------|---|---------------------|----------------------------|---------------------|----------------------------|------|
| Paramete            | er  | Min                 | Max                        | Min                 | Max                        | Unit |
| Timing Re           | quirements  |                     |                            |                     |                            |      |
| t <sub>SFSE</sub>   | TFSx/RFSx Setup Before TSCLKx/RSCLKx <sup>1</sup>                                 | 3.0                 |                            | 3.0                 |                            | ns   |
| t <sub>HFSE</sub>   | TFSx/RFSx Hold After TSCLKx/RSCLKx <sup>1</sup>                                   | 3.0                 |                            | 3.0                 |                            | ns   |
| t <sub>SDRE</sub>   | Receive Data Setup Before RSCLKx <sup>1,2</sup>                                   | 3.0                 |                            | 3.0                 |                            | ns   |
| $t_{\text{HDRE}}$   | Receive Data Hold After RSCLKx <sup>1,2</sup>                                     | 3.5                 |                            | 3.0                 |                            | ns   |
| t <sub>SCLKEW</sub> | TSCLKx/RSCLKx Width   | 4.5                 |                            | 4.5                 |                            | ns   |
| t <sub>SCLKE</sub>  | TSCLKx/RSCLKx Period  | $2 \times t_{SCLK}$ |                            | $2 \times t_{SCLK}$ |                            | ns   |
| Switching           | Characteristics   |                     |                            |                     |                            |      |
| t <sub>DFSE</sub>   | TFSx/RFSx Delay After TSCLKx/RSCLKx (Internally Generated TFSx/RFSx) <sup>3</sup> |                     | 10.0                       |                     | 10.0                       | ns   |
| t <sub>HOFSE</sub>  | TFSx/RFSx Hold After TSCLKx/RSCLKx (Internally Generated TFSx/RFSx) <sup>3</sup>  | 0.0                 |                            | 0.0                 |                            | ns   |
| t <sub>DDTE</sub>   | Transmit Data Delay After TSCLKx <sup>3</sup>                                     |                     | 11.0                       |                     | 10.0                       | ns   |
| t <sub>HDTE</sub>   | Transmit Data Hold After TSCLKx <sup>3</sup>                                      | 0.0                 |                            | 0.0                 |                            | ns   |

<sup>&</sup>lt;sup>1</sup> Referenced to sample edge.

Table 31. Serial Ports—Internal Clock

|                     |   | v    | $V_{\text{DDEXT}} = 1.8 \text{ V}$ | $V_{\text{ddex}}$ | $_{T}$ = 2.5 V/3.3 V |      |
|---------------------|---|------|------------------------------------|-------------------|----------------------|------|
| Paramete            | er  | Min  | Max                                | Min               | Max                  | Unit |
| Timing Red          | quirements  |      |                                    |                   |                      |      |
| $t_{SFSI}$          | TFSx/RFSx Setup Before TSCLKx/RSCLKx <sup>1</sup>                                 | 11.0 |                                    | 9.6               |                      | ns   |
| t <sub>HFSI</sub>   | TFSx/RFSx Hold After TSCLKx/RSCLKx <sup>1</sup>                                   | -1.5 |                                    | -1.5              |                      | ns   |
| t <sub>SDRI</sub>   | Receive Data Setup Before RSCLKx <sup>1,2</sup>                                   | 11.5 |                                    | 10.0              |                      | ns   |
| $t_{HDRI}$          | Receive Data Hold After RSCLKx <sup>1,2</sup>                                     | -1.5 |                                    | -1.5              |                      | ns   |
| Switching           | Characteristics   |      |                                    |                   |                      |      |
| t <sub>SCLKIW</sub> | TSCLKx/RSCLKx Width   | 7.0  |                                    | 8.0               |                      | ns   |
| t <sub>DFSI</sub>   | TFSx/RFSx Delay After TSCLKx/RSCLKx (Internally Generated TFSx/RFSx) <sup>3</sup> |      | 4.0                                |                   | 3.0                  | ns   |
| t <sub>HOFSI</sub>  | TFSx/RFSx Hold After TSCLKx/RSCLKx (Internally Generated TFSx/RFSx) <sup>3</sup>  | -2.0 |                                    | -1.0              |                      | ns   |
| t <sub>DDTI</sub>   | Transmit Data Delay After TSCLKx <sup>3</sup>                                     |      | 4.0                                |                   | 3.0                  | ns   |
| t <sub>HDTI</sub>   | Transmit Data Hold After TSCLKx <sup>3</sup>                                      | -1.8 |                                    | -1.5              |                      | ns   |

 $<sup>^{\</sup>rm 1}$  Referenced to sample edge.

<sup>&</sup>lt;sup>2</sup>When SPORT is used in conjunction with the ACM, refer to the timing requirements in Table 41 (ACM Timing).

<sup>&</sup>lt;sup>3</sup> Referenced to drive edge.

<sup>&</sup>lt;sup>2</sup>When SPORT is used in conjunction with the ACM, refer to the timing requirements in Table 41 (ACM Timing).

 $<sup>^{\</sup>rm 3}\,\text{Referenced}$  to drive edge.

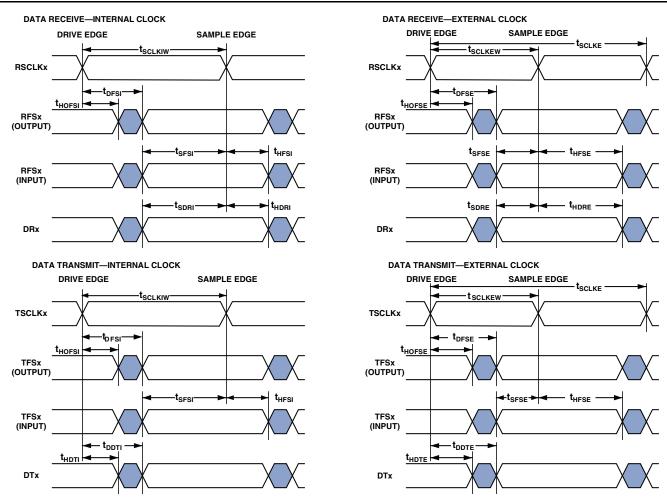


Figure 20. Serial Ports

Table 32. Serial Ports—Enable and Three-State

|                    |  |      | <sub>DDEXT</sub> = <b>1.8 V</b> | <b>V</b> <sub>DDEX</sub> | $V_{DDEXT} = 2.5 \text{ V}/3.3 \text{ V}$ |      |
|--------------------|--|------|---------------------------------|--------------------------|---|------|
| Paramet            | er   | Min  | Max                             | Min                      | Max                                       | Unit |
| Switching          | Characteristics                                      |      |                                 |                          |   |      |
| t <sub>DTENE</sub> | Data Enable Delay from External TSCLKx <sup>1</sup>  | 0.0  |                                 | 0.0                      |   | ns   |
| t <sub>DDTTE</sub> | Data Disable Delay from External TSCLKx <sup>1</sup> |      | $t_{SCLK} + 1$                  |                          | $t_{SCLK} + 1$                            | ns   |
| t <sub>DTENI</sub> | Data Enable Delay from Internal TSCLKx1              | -2.0 |                                 | -2.0                     |   | ns   |
| t <sub>DDTTI</sub> | Data Disable Delay from Internal TSCLKx1             |      | $t_{SCLK} + 1$                  |                          | $t_{SCLK} + 1$                            | ns   |

 $<sup>^{\</sup>rm 1}\,\mathrm{Referenced}$  to drive edge.

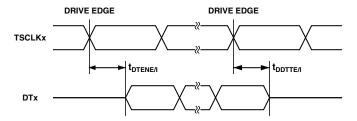


Figure 21. Serial Ports — Enable and Three-State

Table 33. Serial Ports — External Late Frame Sync

|                       |  | \   | / <sub>DDEXT</sub> = 1.8 V | <b>V</b> <sub>DDEX</sub> | <sub>cτ</sub> = 2.5 V/3.3 V |      |
|-----------------------|--|-----|----------------------------|--------------------------|-----------------------------|------|
| Parameter             |  | Min | Max                        | Min                      | Max                         | Unit |
| Switching             | Characteristics  |     |                            |                          |                             |      |
| t <sub>DDTLFSE</sub>  | Data Delay from Late External TFSx or External RFSx in Multi-channel Mode With MFD = $0^{1,2}$ |     | 12.0                       |                          | 10.0                        | ns   |
| t <sub>DTENLFSE</sub> | Data Enable from External RFSx in Multi-channel Mode With $MFD = 0^{1,2}$                      | 0.0 |                            | 0.0                      |                             | ns   |

 $<sup>^{1}\,\</sup>text{When}$  in multi-channel mode, TFSx enable and TFSx valid follow  $t_{\text{DTENLFSE}}$  and  $t_{\text{DDTLFSE}}$ 

 $<sup>^2</sup> If \ external \ RFSx/TFSx \ setup \ to \ RSCLKx/TSCLKx > t_{SCLKE}/2 \ then \ t_{DDTTE/I} \ and \ t_{DTENE/I} \ apply, \ otherwise \ t_{DDTLFSE} \ and \ t_{DTENLFSE} \ apply.$ 

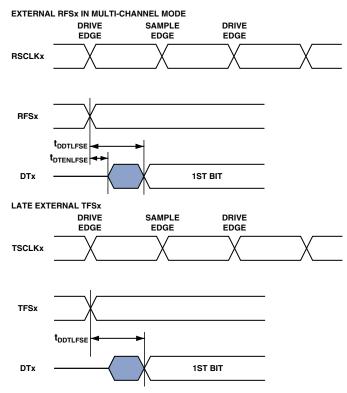


Figure 22. Serial Ports — External Late Frame Sync

### Serial Peripheral Interface (SPI) Port—Master Timing

Table 34 and Figure 23 describe SPI port master operations.

Table 34. Serial Peripheral Interface (SPI) Port—Master Timing

|                      |   | $V_{\text{DDEXT}} = 1.8 \text{ V}$ |      | $\mathbf{V}_{	exttt{DDE}}$ | $V_{DDEXT} = 2.5 \text{ V}/3.3 \text{ V}$ |      |
|----------------------|---|------------------------------------|------|----------------------------|---|------|
| Paramete             | r   | Min                                | Max  | Min                        | Max                                       | Unit |
| Timing Red           | quirements                                      |                                    |      |                            |   |      |
| t <sub>SSPIDM</sub>  | Data Input Valid to SCK Edge (Data Input Setup) | 11.6                               |      | 9.6                        |   | ns   |
| $t_{HSPIDM}$         | SCK Sampling Edge to Data Input Invalid         | -1.5                               |      | -1.5                       |   | ns   |
| Switching            | Characteristics                                 |                                    |      |                            |   |      |
| $t_{\text{SDSCIM}}$  | SPISELx low to First SCK Edge                   | $2 \times t_{SCLK}$                | -1.5 | $2 \times t_{SCLK}$        | -1.5                                      | ns   |
| $t_{\text{SPICHM}}$  | Serial Clock High Period                        | $2 \times t_{SCLK}$                | -1.5 | $2 \times t_{SCLK}$        | -1.5                                      | ns   |
| t <sub>SPICLM</sub>  | Serial Clock Low Period                         | $2 \times t_{SCLK}$                | -1.5 | $2 \times t_{SCLK}$        | -1.5                                      | ns   |
| $t_{\text{SPICLK}}$  | Serial Clock Period                             | $4 \times t_{SCLK}$                | -1.5 | $4 \times t_{SCLK}$        | -1.5                                      | ns   |
| $t_{HDSM}$           | Last SCK Edge to SPISELx High                   | $2 \times t_{SCLK}$                | -2.0 | $2 \times t_{SCLK}$        | -1.5                                      | ns   |
| $t_{\text{SPITDM}}$  | Sequential Transfer Delay                       | $2 \times t_{SCLK}$                | -1.5 | $2 \times t_{SCLK}$        | -1.5                                      | ns   |
| t <sub>DDSPIDM</sub> | SCK Edge to Data Out Valid (Data Out Delay)     | 0                                  | 6    | 0                          | 6   | ns   |
| t <sub>HDSPIDM</sub> | SCK Edge to Data Out Invalid (Data Out Hold)    | -1.0                               |      | -1.0                       |   | ns   |

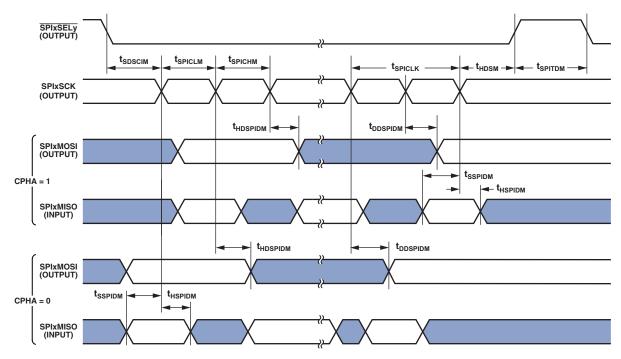


Figure 23. Serial Peripheral Interface (SPI) Port—Master Timing

## Serial Peripheral Interface (SPI) Port—Slave Timing

Table 35 and Figure 24 describe SPI port slave operations.

Table 35. Serial Peripheral Interface (SPI) Port—Slave Timing

|                     |   | ,                   | V <sub>DDEXT</sub> = 1.8 V | V <sub>DE</sub>     | DEXT = 2.5 V/3.3 V |      |
|---------------------|---|---------------------|----------------------------|---------------------|--------------------|------|
| Paramete            | er  | Min                 | Max                        | Min                 | Max                | Unit |
| Timing Re           | quirements                                      |                     |                            |                     |                    |      |
| t <sub>SPICHS</sub> | Serial Clock High Period                        | $2 \times t_{SCLK}$ | -1.5                       | $2 \times t_{SCLk}$ | <sub>(</sub> – 1.5 | ns   |
| $t_{\text{SPICLS}}$ | Serial Clock Low Period                         | $2 \times t_{SCLK}$ | -1.5                       | $2 \times t_{SCLk}$ | <sub>(</sub> – 1.5 | ns   |
| $t_{\text{SPICLK}}$ | Serial Clock Period                             | $4 \times t_{SCLK}$ |                            | $4 \times t_{SCLK}$ | (                  | ns   |
| $t_{HDS}$           | Last SCK Edge to SPISS Not Asserted             | $2 \times t_{SCLK}$ | -1.5                       | $2 \times t_{SCLK}$ | <sub>(</sub> – 1.5 | ns   |
| $t_{\text{SPITDS}}$ | Sequential Transfer Delay                       | $2 \times t_{SCLK}$ | -1.5                       | $2 \times t_{SCLk}$ | <sub>(</sub> – 1.5 | ns   |
| $t_{\text{SDSCI}}$  | SPISS Assertion to First SCK Edge               | $2 \times t_{SCLK}$ | -1.5                       | $2 \times t_{SCLK}$ | <sub>(</sub> –1.5  | ns   |
| t <sub>SSPID</sub>  | Data Input Valid to SCK Edge (Data Input Setup) | 1.6                 |                            | 1.6                 |                    | ns   |
| t <sub>HSPID</sub>  | SCK Sampling Edge to Data Input Invalid         | 2.0                 |                            | 1.6                 |                    | ns   |
| Switching           | Characteristics                                 |                     |                            |                     |                    |      |
| $t_{DSOE}$          | SPISS Assertion to Data Out Active              | 0                   | 12.0                       | 0                   | 10.3               | ns   |
| t <sub>DSDHI</sub>  | SPISS Deassertion to Data High Impedance        | 0                   | 11.0                       | 0                   | 9.0                | ns   |
| t <sub>DDSPID</sub> | SCK Edge to Data Out Valid (Data Out Delay)     |                     | 10                         |                     | 10                 | ns   |
| t <sub>HDSPID</sub> | SCK Edge to Data Out Invalid (Data Out Hold)    | 0                   |                            | 0                   |                    | ns   |

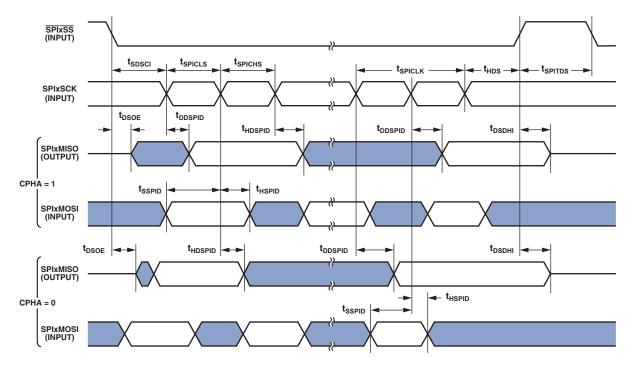


Figure 24. Serial Peripheral Interface (SPI) Port—Slave Timing

# Universal Asynchronous Receiver-Transmitter (UART) Ports—Receive and Transmit Timing

The UART ports receive and transmit operations are described in the *ADSP-BF50x Hardware Reference Manual*.

## **General-Purpose Port Timing**

Table 36 and Figure 25 describe general-purpose port operations.

Table 36. General-Purpose Port Timing

|                  |  | $V_{DDEXT} = 1.8 \text{ V}$ $V_{DDEXT} = 2.5 \text{ V}/3.3$ |      | .5 V/3.3 V            |     |      |
|------------------|--|---|------|-----------------------|-----|------|
| Parameter        |  | Min   | Max  | Min                   | Max | Unit |
| Timing Requi     | rement   |   |      |                       |     |      |
| t <sub>WFI</sub> | General-Purpose Port Pin Input Pulse Width             | t <sub>SCLK</sub> + 1                                       |      | t <sub>SCLK</sub> + 1 |     | ns   |
| Switching Ch     | aracteristic   |   |      |                       |     |      |
| $t_{GPOD}$       | General-Purpose Port Pin Output Delay from CLKOUT High | 0   | 11.0 | 0                     | 8.9 | ns   |

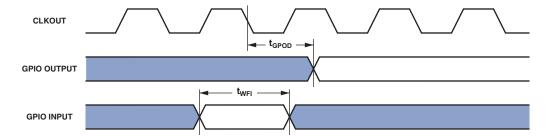


Figure 25. General-Purpose Port Timing

## **Timer Cycle Timing**

Table 37 and Figure 26 describe timer expired operations. The input signal is asynchronous in "width capture mode" and "external clock mode" and has an absolute maximum input frequency of  $(f_{SCLK}/2)$  MHz.

Table 37. Timer Cycle Timing

|                  |  | V <sub>DDEX</sub>         | <sub>ιτ</sub> = 1.8 V       | V <sub>DDEXT</sub> =      | 2.5 V/3.3 V                 |      |
|------------------|--|---------------------------|-----------------------------|---------------------------|-----------------------------|------|
| Paramete         | er   | Min                       | Max                         | Min                       | Max                         | Unit |
| Timing Red       | quirements   |                           |                             |                           |                             |      |
| $t_{WL}$         | Timer Pulse Width Input Low<br>(Measured In SCLK Cycles) <sup>1</sup>  | $1 \times t_{SCLK}$       |                             | $1 \times t_{SCLK}$       |                             | ns   |
| $t_WH$           | Timer Pulse Width Input High<br>(Measured In SCLK Cycles) <sup>1</sup> | $1 \times t_{SCLK}$       |                             | $1 \times t_{SCLK}$       |                             | ns   |
| $t_{TIS}$        | Timer Input Setup Time Before CLKOUT Low <sup>2</sup>                  | 10                        |                             | 8                         |                             | ns   |
| $t_{\text{TIH}}$ | Timer Input Hold Time After CLKOUT Low <sup>2</sup>                    | -2                        |                             | -2                        |                             | ns   |
| Switching        | Characteristics  |                           |                             |                           |                             |      |
| $t_{\text{HTO}}$ | Timer Pulse Width Output<br>(Measured In SCLK Cycles)                  | $1 \times t_{SCLK} - 2.0$ | $(2^{32}-1)\times t_{SCLK}$ | $1 \times t_{SCLK} - 1.5$ | $(2^{32}-1)\times t_{SCLK}$ | ns   |
| t <sub>TOD</sub> | Timer Output Update Delay After CLKOUT High                            |                           | 6                           |                           | 6                           | ns   |

<sup>&</sup>lt;sup>1</sup>The minimum pulse widths apply for TMRx signals in width capture and external clock modes. They also apply to the PG0 or PPI\_CLK signals in PWM output mode.

<sup>&</sup>lt;sup>2</sup> Either a valid setup and hold time or a valid pulse width is sufficient. There is no need to resynchronize programmable flag inputs.

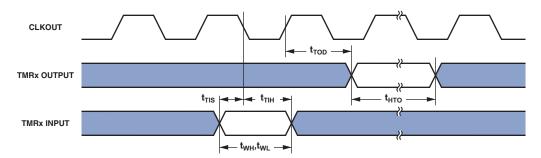


Figure 26. Timer Cycle Timing

## **Timer Clock Timing**

Table 38 and Figure 27 describe timer clock timing.

### Table 38. Timer Clock Timing

|            |  | $V_{DDEXT} = 1.8 V$ $V_{D}$ |      | V <sub>DDE</sub> | $x_T = 2.5 \text{ V}/3.3 \text{ V}$ |      |
|------------|--|-----------------------------|------|------------------|-------------------------------------|------|
| Parame     | eter   | Min                         | Max  | Min              | Max                                 | Unit |
| Switchii   | ng Characteristic                            |                             |      |                  |                                     |      |
| $t_{TODP}$ | Timer Output Update Delay After PPI_CLK High |                             | 12.0 |                  | 12.0                                | ns   |

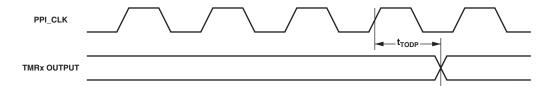


Figure 27. Timer Clock Timing

## **Up/Down Counter/Rotary Encoder Timing**

Table 39. Up/Down Counter/Rotary Encoder Timing

|                     |  | <b>V</b> <sub>DDEXT</sub> = <b>1.8 V</b> |     | $V_{DDEXT} = 2.5 \text{ V}/3.3 \text{ V}$ |     |      |
|---------------------|--|--|-----|---|-----|------|
| Parameter           |  | Min                                      | Max | Min                                       | Max | Unit |
| Timing Requ         | irements   |  |     |   |     |      |
| $t_{\text{WCOUNT}}$ | Up/Down Counter/Rotary Encoder Input Pulse Width         | $t_{SCLK} + 1$                           |     | $t_{SCLK} + 1$                            |     | ns   |
| $t_{CIS}$           | Counter Input Setup Time Before CLKOUT High <sup>1</sup> | 9.0                                      |     | 7.0                                       |     | ns   |
| t <sub>CIH</sub>    | Counter Input Hold Time After CLKOUT High <sup>1</sup>   | 0  |     | 0   |     | ns   |

<sup>&</sup>lt;sup>1</sup> Either a valid setup and hold time or a valid pulse width is sufficient. There is no need to resynchronize counter inputs.

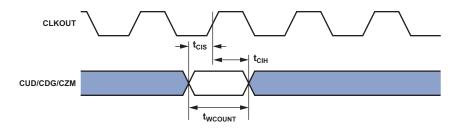


Figure 28. Up/Down Counter/Rotary Encoder Timing

### **Pulse Width Modulator (PWM) Timing**

Table 40 and Figure 29 describe PWM operations.

## Table 40. PWM Timing

| Param              | eter   | Min                     | Max                      | Unit |
|--------------------|--|-------------------------|--------------------------|------|
| Timing             | Requirement  |                         |                          |      |
| t <sub>ES</sub>    | External Sync Pulse Width                                  | $2 \times t_{SCLK} + 1$ |                          | ns   |
| Switch             | ing Characteristics  |                         |                          |      |
| $t_{\text{DODIS}}$ | Output <sup>1</sup> Inactive (OFF) After Trip Input        |                         | 12                       | ns   |
| $t_{DOE}$          | Output <sup>1</sup> Delay After External Sync <sup>2</sup> | $2 \times t_{SCLK}$     | $5 \times t_{SCLK} + 13$ | ns   |
| $t_{OD}$           | Output <sup>1</sup> Delay After Falling Edge of CLKOUT     |                         | 5                        | ns   |

 $<sup>^1\,</sup>PWM\ outputs\ are:\ PWMx\_AH,\ PWMx\_AL,\ PWMx\_BH,\ PWMx\_BL,\ PWMx\_CH,\ and\ PWMx\_CL.$ 

<sup>&</sup>lt;sup>2</sup> When the external sync signal is synchronous to the peripheral clock, it takes fewer clock cycles for the output to appear compared to when the external sync signal is asynchronous to the peripheral clock. For more information, see the ADSP-BF50x Blackfin Processor Hardware Reference.

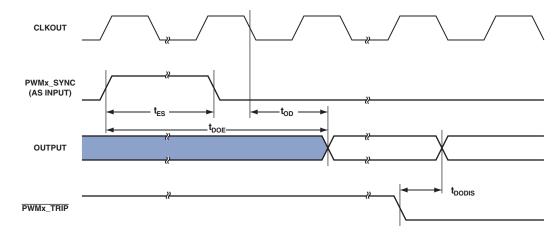


Figure 29. PWM Timing

### **ADC Controller Module (ACM) Timing**

Table 41 and Figure 30 describe ACM operations.

Note that the ACM clock (ACLK) frequency in MHz is set by the following equation (in which ACMCKDIV ranges from 0 to 255).

$$t_{ACLK} = \frac{1}{f_{ACLK}}$$

$$f_{ACLK} = \frac{f_{SCLK}}{(2 \times ACMCKDIV) + 2}$$

Table 41. ACM Timing

|                    |  | \ \                   | / <sub>DDEXT</sub> = 1.8 V | V <sub>DDEX</sub>     | = 2.5 V/3.3 V |      |
|--------------------|--|-----------------------|----------------------------|-----------------------|---------------|------|
| Parar              | neter  | Min                   | Max                        | Min                   | Max           | Unit |
| Timin              | g Requirements   |                       |                            |                       |               |      |
| $t_{\text{SDR}}$   | SPORT DRxPRI/DRxSEC Setup Before ACLK  | 8.0                   |                            | 7.0                   |               | ns   |
| $t_{\text{HDR}}$   | SPORT DRxPRI/DRxSEC Hold After ACLK  | 0                     |                            | 0                     |               | ns   |
| Switc              | hing Characteristics   |                       |                            |                       |               |      |
| $t_{DO}$           | ACM Controls (ACM_A[2:0], ACM_RANGE, ACM_SGLDIFF) Delay After Falling Edge of CLKOUT |                       | 8.4                        |                       | 8.4           | ns   |
| t <sub>DACLK</sub> | ACLK Delay After Falling Edge of CLKOUT  |                       | 4.5                        |                       | 4.5           | ns   |
| $t_{\text{DCS}}$   | CS Active Edge Delay After Falling Edge of CLKOUT                                    |                       | 5.6                        |                       | 5.3           | ns   |
| t <sub>DCSAC</sub> | K The Delay Between the Active Edge of CS and the First Edge of ACLK                 | t <sub>ACLK</sub> – 5 |                            | t <sub>ACLK</sub> – 5 |               | ns   |

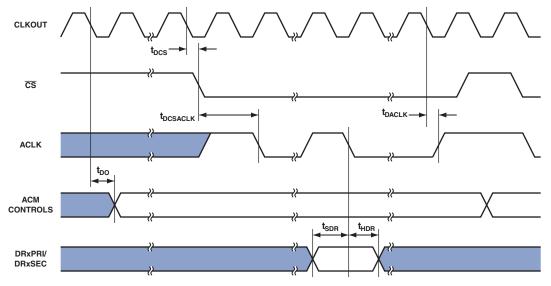


Figure 30. ACM Timing

### **JTAG Test And Emulation Port Timing**

Table 42 and Figure 31 describe JTAG port operations.

**Table 42. JTAG Port Timing** 

|                    |  | \   | / <sub>DDEXT</sub> = 1.8 V | <b>V</b> <sub>DDEX</sub> | <sub>T</sub> = 2.5 V/3.3 V |      |
|--------------------|--|-----|----------------------------|--------------------------|----------------------------|------|
| Paramet            | er   | Min | Max                        | Min                      | Max                        | Unit |
| Timing Re          | equirements  |     |                            |                          |                            |      |
| t <sub>TCK</sub>   | TCK Period   | 20  |                            | 20                       |                            | ns   |
| t <sub>STAP</sub>  | TDI, TMS Setup Before TCK High                         | 4   |                            | 4                        |                            | ns   |
| t <sub>HTAP</sub>  | TDI, TMS Hold After TCK High                           | 4   |                            | 4                        |                            | ns   |
| $t_{\text{SSYS}}$  | System Inputs Setup Before TCK High <sup>1</sup>       | 4   |                            | 4                        |                            | ns   |
| $t_{\text{STWI}}$  | TWI System Inputs Setup Before TCK High <sup>2</sup>   | n/a |                            | 5                        |                            | ns   |
| t <sub>HSYS</sub>  | System Inputs Hold After TCK High <sup>1</sup>         | 5   |                            | 5                        |                            | ns   |
| t <sub>TRSTW</sub> | TRST Pulse Width <sup>3</sup> (measured in TCK cycles) | 4   |                            | 4                        |                            | TCK  |
| Switching          | Characteristics  |     |                            |                          |                            |      |
| $t_{\text{DTDO}}$  | TDO Delay from TCK Low                                 |     | 10                         |                          | 10                         | ns   |
| t <sub>DSYS</sub>  | System Outputs Delay After TCK Low <sup>4</sup>        |     | 12                         |                          | 12                         | ns   |

 $<sup>^{1} \</sup>text{Applies to System Inputs} = \text{PF15-0}, \text{PG15-0}, \text{PH2-0}, \overline{\text{NMI}}, \text{BMODE3-0}, \overline{\text{RESET}}.$ 

 $<sup>^4</sup>$  System Outputs = EXTCLK, SCL, SDA, PF15–0, PG15–0, PH2–0.

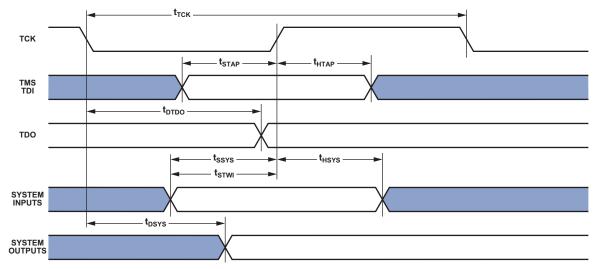


Figure 31. JTAG Port Timing

<sup>&</sup>lt;sup>2</sup> Applies to TWI System Inputs = SCL, SDA. For SDA and SCL system inputs, the system design must comply with V<sub>DDEXT</sub> and VBUSTWI voltages specified for the default TWI\_DT (000) setting in Table 13.

<sup>&</sup>lt;sup>3</sup> 50 MHz Maximum.

#### PROCESSOR—OUTPUT DRIVE CURRENTS

Figure 32 through Figure 40 show typical current-voltage characteristics for the output drivers of the ADSP-BF50xF processors.

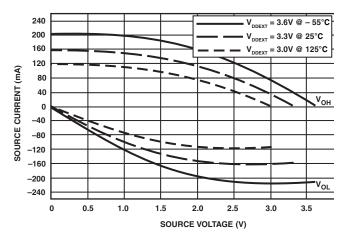


Figure 32. Driver Type B Current (3.3 V V<sub>DDEXT</sub>)

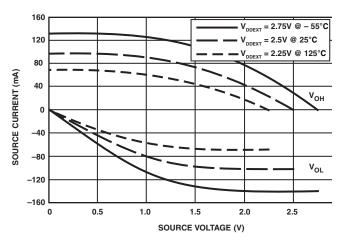


Figure 33. Driver Type B Current (2.5 V VDDEXT)

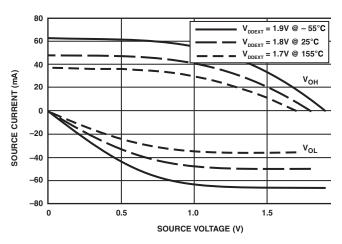


Figure 34. Driver Type B Current (1.8 V V<sub>DDEXT</sub>)

The curves represent the current drive capability of the output drivers. See Table 11 on Page 22 for information about which driver type corresponds to a particular pin.

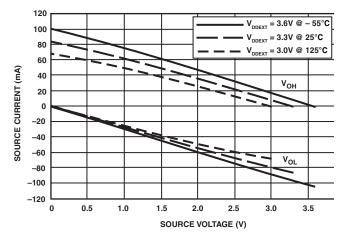


Figure 35. Driver Type C Current (3.3 V V<sub>DDEXT</sub>)

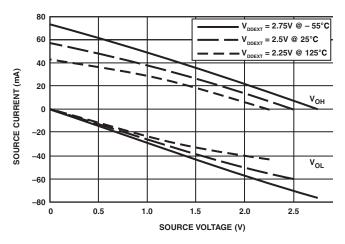


Figure 36. Drive Type C Current (2.5 V V<sub>DDEXT</sub>)

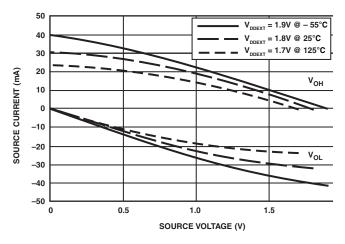


Figure 37. Driver Type C Current (1.8 V V<sub>DDEXT</sub>)

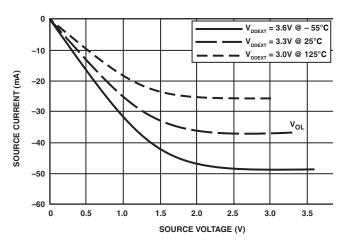


Figure 38. Driver Type D Current (3.3 V V<sub>DDEXT</sub>)

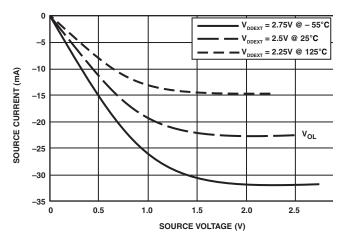


Figure 39. Driver Type D Current (2.5 V V<sub>DDEXT</sub>)

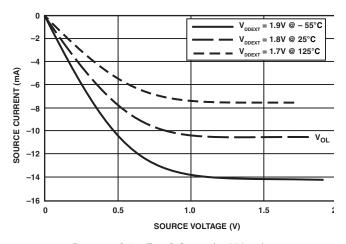


Figure 40. Driver Type D Current (1.8  $VV_{DDEXT}$ )

#### PROCESSOR—TEST CONDITIONS

All timing parameters appearing in this data sheet were measured under the conditions described in this section. Figure 41 shows the measurement point for AC measurements (except output enable/disable). The measurement point  $V_{\text{MEAS}}$  is  $V_{\text{DDEXT}}/2$  for  $V_{\text{DDEXT}}$  (nominal) = 1.8 V/2.5 V/3.3 V.



Figure 41. Voltage Reference Levels for AC Measurements (Except Output Enable/Disable)

### **Output Enable Time Measurement**

Output pins are considered to be enabled when they have made a transition from a high impedance state to the point when they start driving.

The output enable time  $t_{\text{ENA}}$  is the interval from the point when a reference signal reaches a high or low voltage level to the point when the output starts driving as shown on the right side of Figure 42.

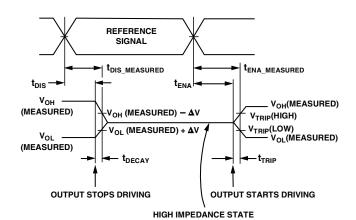


Figure 42. Output Enable/Disable

The time  $t_{\text{ENA\_MEASURED}}$  is the interval, from when the reference signal switches, to when the output voltage reaches  $V_{\text{TRIP}}(\text{high})$  or  $V_{\text{TRIP}}(\text{low})$ . For  $V_{\text{DDEXT}}$  (nominal) = 1.8 V,  $V_{\text{TRIP}}$  (high) is 1.05 V, and  $V_{\text{TRIP}}$  (low) is 0.75 V. For  $V_{\text{DDEXT}}$  (nominal) = 2.5 V,  $V_{\text{TRIP}}$  (high) is 1.5 V and  $V_{\text{TRIP}}$  (low) is 1.0 V. For  $V_{\text{DDEXT}}$  (nominal) = 3.3 V,  $V_{\text{TRIP}}$  (high) is 1.9 V, and  $V_{\text{TRIP}}$  (low) is 1.4 V. Time  $t_{\text{TRIP}}$  is the interval from when the output starts driving to when the output reaches the  $V_{\text{TRIP}}$ (high) or  $V_{\text{TRIP}}$ (low) trip voltage.

Time  $t_{\text{ENA}}$  is calculated as shown in the equation:

$$t_{ENA} = t_{ENA\_MEASURED} - t_{TRIP}$$

If multiple pins are enabled, the measurement value is that of the first pin to start driving.

### **Output Disable Time Measurement**

Output pins are considered to be disabled when they stop driving, go into a high impedance state, and start to decay from their output high or low voltage. The output disable time  $t_{\text{DIS}}$  is the difference between  $t_{\text{DIS\_MEASURED}}$  and  $t_{\text{DECAY}}$  as shown on the left side of Figure 42.

 $t_{DIS} = t_{DIS\ MEASURED} - t_{DECAY}$ 

The time for the voltage on the bus to decay by  $\Delta V$  is dependent on the capacitive load  $C_L$  and the load current  $I_L$ . This decay time can be approximated by the equation:

$$t_{DECAY} = (C_L \Delta V) / I_L$$

The time  $t_{\text{DECAY}}$  is calculated with test loads  $C_{\text{L}}$  and  $I_{\text{L}}$ , and with  $\Delta V$  equal to 0.25 V for  $V_{\text{DDEXT}}$  (nominal) = 2.5 V/3.3 V and 0.15 V for  $V_{\text{DDEXT}}$  (nominal) = 1.8 V.

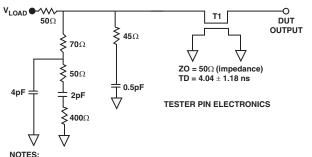
The time  $t_{\text{DIS\_MEASURED}}$  is the interval from when the reference signal switches, to when the output voltage decays  $\Delta V$  from the measured output high or output low voltage.

### **Example System Hold Time Calculation**

To determine the data output hold time in a particular system, first calculate  $t_{\text{DECAY}}$  using the equation given above. Choose  $\Delta V$  to be the difference between the processor's output voltage and the input threshold for the device requiring the hold time.  $C_L$  is the total bus capacitance (per data line), and  $I_L$  is the total leakage or three-state current (per data line). The hold time will be  $t_{\text{DECAY}}$  plus the various output disable times as specified in the Processor—Timing Specifications on Page 33.

## **Capacitive Loading**

Output delays and holds are based on standard capacitive loads of an average of 6 pF on all pins (see Figure 43).  $V_{LOAD}$  is equal to  $(V_{DDEXT})$  /2. The graphs of Figure 44 through Figure 49 show how output rise time varies with capacitance. The delay and hold specifications given should be derated by a factor derived from these figures. The graphs in these figures may not be linear outside the ranges shown.



THE WORST CASE TRANSMISSION LINE DELAY IS SHOWN AND CAN BE USED FOR THE OUTPUT TIMING ANALYSIS TO REFELECT THE TRANSMISSION LINE EFFECT AND MUST BE CONSIDERED. THE TRANSMISSION LINE (TD), IS FOR LOAD ONLY AND DOES NOT AFFECT THE DATA SHEET TIMING SPECIFICATIONS.

ANALOG DEVICES RECOMMENDS USING THE IBIS MODEL TIMING FOR A GIVEN SYSTEM REQUIREMENT. IF NECESSARY, A SYSTEM MAY INCORPORATE EXTERNAL DRIVERS TO COMPENSATE FOR ANY TIMING DIFFERENCES.

Figure 43. Equivalent Device Loading for AC Measurements (Includes All Fixtures)

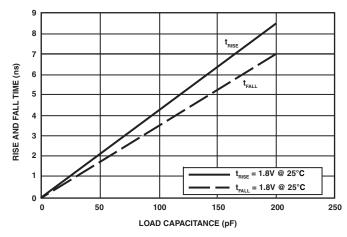


Figure 44. Driver Type B Typical Rise and Fall Times (10%–90%) vs. Load Capacitance (1.8 V V<sub>DDEXT</sub>)

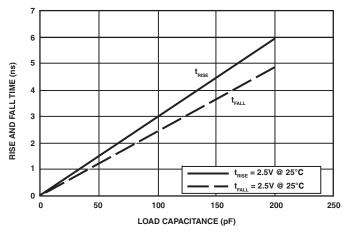


Figure 45. Driver Type B Typical Rise and Fall Times (10%–90%) vs. Load Capacitance (2.5 V V<sub>DDEXT</sub>)

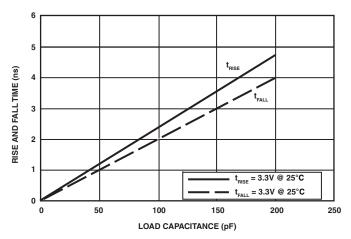


Figure 46. Driver Type B Typical Rise and Fall Times (10%–90%) vs. Load Capacitance (3.3 V  $V_{\rm DDEXT}$ )

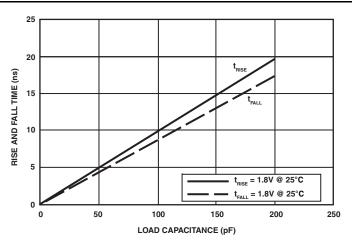


Figure 47. Driver Type C Typical Rise and Fall Times (10%–90%) vs. Load Capacitance (1.8 V V<sub>DDEXT</sub>)

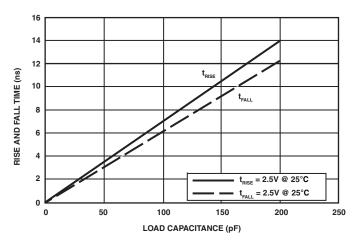


Figure 48. Driver Type C Typical Rise and Fall Times (10%–90%) vs. Load Capacitance (2.5 V V<sub>DDEXT</sub>)

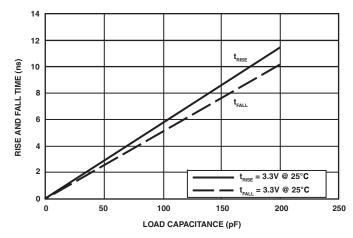


Figure 49. Driver Type C Typical Rise and Fall Times (10%–90%) vs. Load Capacitance (3.3 V V<sub>DDEXT</sub>)

### PROCESSOR—ENVIRONMENTAL CONDITIONS

To determine the junction temperature on the application printed circuit board use:

$$T_I = T_{CASE} + (\Psi_{IT} \times P_D)$$

where:  $T_I$  = junction temperature (°C).

 $T_{CASE}$  = case temperature (°C) measured by customer at top center of package.

 $\Psi_{TT}$  = from Table 43 and Table 44.

 $P_D$  = power dissipation (see Total Power Dissipation on Page 30 for the method to calculate  $P_D$ ).

Values of  $\theta_{JA}$  are provided for package comparison and printed circuit board design considerations.  $\theta_{JA}$  can be used for a first order approximation of  $T_I$  by the equation:

$$T_I = T_A + (\theta_{IA} \times P_D)$$

where  $T_A$  = ambient temperature (°C).

Values of  $\theta_{\text{JC}}$  are provided for package comparison and printed circuit board design considerations when an external heat sink is required.

Values of  $\theta_{JB}$  are provided for package comparison and printed circuit board design considerations.

In Table 43 and Table 44, airflow measurements comply with JEDEC standards JESD51-2 and JESD51-6, and the junction-to-board measurement complies with JESD51-8. The junction-to-case measurement complies with MIL-STD-883 (Method 1012.1). All measurements use a 2S2P JEDEC test board.

Table 43. Thermal Characteristics (88-Lead LFCSP)

| Parameter           | Condition             | Typical | Unit |
|---------------------|-----------------------|---------|------|
| $\theta_{JA}$       | 0 linear m/s air flow | 26.2    | °C/W |
| $\theta_{JMA}$      | 1 linear m/s air flow | 23.7    | °C/W |
| $\theta_{JMA}$      | 2 linear m/s air flow | 22.9    | °C/W |
| $\theta_{JB}$       |                       | 16.0    | °C/W |
| $\theta_{JC}$       |                       | 9.8     | °C/W |
| $\Psi_{	extsf{JT}}$ | 0 linear m/s air flow | 0.21    | °C/W |
| $\Psi_{	extsf{JT}}$ | 1 linear m/s air flow | 0.36    | °C/W |
| $\Psi_{	extsf{JT}}$ | 2 linear m/s air flow | 0.43    | °C/W |

Table 44. Thermal Characteristics (120-Lead LQFP)

| Parameter            | Condition             | Typical | Unit |
|----------------------|-----------------------|---------|------|
| $\theta_{JA}$        | 0 linear m/s air flow | 26.9    | °C/W |
| $\Theta_{JMA}$       | 1 linear m/s air flow | 24.2    | °C/W |
| $\theta_{JMA}$       | 2 linear m/s air flow | 23.3    | °C/W |
| $\theta_{\text{JB}}$ |                       | 16.4    | °C/W |
| $\theta_{JC}$        |                       | 12.7    | °C/W |
| $\Psi_{	extsf{JT}}$  | 0 linear m/s air flow | 0.50    | °C/W |
| $\Psi_{	extsf{JT}}$  | 1 linear m/s air flow | 0.77    | °C/W |
| $\Psi_{	extsf{JT}}$  | 2 linear m/s air flow | 1.02    | °C/W |

## FLASH—SPECIFICATIONS

Specifications subject to change without notice.

### FLASH—PROGRAM AND ERASE TIMES AND ENDURANCE CYCLES

The program and erase times and the number of program/ erase cycles per block are shown in Table 45. Exact erase times may change depending on the memory array condition. The best case is when all the bits in the block or bank are at '0' (pre programmed). The worst case is when all the bits in the block or bank are at '1' (not pre programmed). Usually, the system overhead is negligible with respect to the erase time.

Table 45. Program/Erase Times and Endurance Cycles

|                                  |   |         | Typical<br>After 100k |         |        |
|----------------------------------|---|---------|-----------------------|---------|--------|
| Parameter                        | Condition                               | Typical | Write/Erase<br>Cycles | Max     | Unit   |
| Erase                            | Parameter Block (4K word) <sup>1</sup>  | 0.3     | 1                     | 2.5     | s      |
| Erase                            | Main Block (32K word)—preprogrammed     | 0.8     | 3                     | 4       | s      |
| Erase                            | Main Block (32K word)—not preprogrammed | 1       |                       | 4       | s      |
| Program <sup>2</sup>             | Word                                    | 12      | 12                    | 100     | μs     |
| Program <sup>2</sup>             | Parameter Block (4K word)               | 40      |                       |         | ms     |
| Program <sup>2</sup>             | Main Block (32K word)                   | 300     |                       |         | ms     |
| Suspend Latency                  | Program                                 | 5       |                       | 10      | μs     |
| Suspend Latency                  | Erase                                   | 5       |                       | 20      | μs     |
| Program/Erase Cycles (per Block) | Main Blocks                             |         |                       | 100,000 | Cycles |
| Program/Erase Cycles (per Block) | Parameter Blocks                        |         |                       | 100,000 | Cycles |

<sup>&</sup>lt;sup>1</sup>The difference between pre programmed and not pre programmed is not significant (< 30 ms).

### FLASH—ABSOLUTE MAXIMUM RATINGS

Table 46 shows the ADC absolute maximum ratings.

**Table 46. Flash Absolute Maximum Ratings** 

| Parameter   | Rating            |
|---|-------------------|
| Junction Temperature While Biased                   | See Table 20 on   |
|   | Page 31           |
| Storage Temperature Range                           | See Table 20 on   |
|   | Page 31           |
| Flash Memory Supply Voltage (V <sub>DDFLASH</sub> ) | -0.2 V to +2.45 V |

<sup>&</sup>lt;sup>2</sup> Values are liable to change with the external system-level overhead (command sequence and Status Register polling execution).

## **ADC**—SPECIFICATIONS

Specifications are subject to change without notice.

## **ADC—OPERATING CONDITIONS**

| Parameter   | Conditions   | Min  | Nominal           | Max   | Unit   |
|---|--|--|-------------------|---|--------|
| $V_{DD}^{-1}$ (AV <sub>DD</sub> , DV <sub>DD</sub> , V <sub>DRIVE</sub> ) | $f_{ADSCLK}$ = 24 MHz, $f_s$ up to 1.5 MSPS, internal or external reference = 2.5 V $\pm$ 1% unless otherwise noted    | 2.7  |                   | 3.6   | V      |
|   | $f_{ADSCLK}$ = 25 MHz, $f_{S}$ up to 1.56 MSPS, internal or external reference = 2.5 V $\pm$ 1% unless otherwise noted | 3.0  |                   | 3.6   | V      |
|   | $f_{ADSCLK}$ = 32 MHz, $f_s$ up to 2.0 MSPS, internal or external reference = 2.5 V $\pm$ 1% unless otherwise noted    | 4.75 (AV <sub>DD</sub> , DV<br>2.7 (V <sub>DRIVE</sub> ) | / <sub>DD</sub> ) | 5.25 (AV <sub>DD</sub> , DV <sub>DD</sub> )<br>5.25 (V <sub>DRIVE</sub> ) | V<br>V |
| T <sub>J</sub> Junction Temperature                                       | 120-Lead LQFP @ T <sub>AMBIENT</sub> = -40°C to +85°C  | -40  |                   | +105  | °C     |

 $<sup>^1</sup>$  Throughout the ADC sections of this data sheet,  $V_{DD}$  refers to both  $AV_{DD}$  and  $DV_{DD}.$ 

Table 47. Operating Conditions (Analog, Voltage Reference, and Logic I/O)

| Parameter   | Specification             | Unit         | Test Conditions/Comments                                   |
|---|---------------------------|--------------|--|
| ANALOG INPUT <sup>1</sup>   |                           |              |  |
| Single-Ended Input Range  | 0 V to V <sub>REF</sub>   | V            | RANGE= low   |
|   | 0 V to $2 \times V_{REF}$ | V            | RANGE = high   |
| Pseudo Differential Input Range: $V_{IN+} - V_{IN-}^{2}$              | 0 V to V <sub>REF</sub>   | V            | RANGE = low  |
|   | $2 \times V_{REF}$        | V            | RANGE = high   |
| Fully Differential Input Range: $V_{\text{IN+}}$ and $V_{\text{IN-}}$ | $V_{CM} \pm V_{REF}/2$    | V            | $V_{CM} = common-mode voltage^3 = V_{REF}/2$ , RANGE = low |
|   | $V_{CM} \pm V_{REF}$      | V            | $V_{CM} = V_{REF}$ , RANGE = high                          |
| DC Leakage Current  | ±1                        | μA max       | $V_{A1}$ to $V_{A6}$ , $V_{B1}$ to $V_{B6}$                |
| Input Capacitance <sup>4</sup>  | 45                        | pF typ       | When in track  |
|   | 10                        | pF typ       | When in hold   |
| INTERNAL VOLTAGE REFERENCE (OUTPUT) <sup>5</sup>                      |                           |              |  |
| Reference Output Voltage  | 2.5 ± 0.4%                | V            | @ 25°C, AV <sub>DD</sub> = 2.7 V to 5.25 V                 |
| Long-Term Stability <sup>4</sup>                                      | 150                       | ppm typ      | For 1000 hours   |
| Output Voltage Thermal Hysteresis <sup>6</sup>                        | 50                        | ppm typ      |  |
| D <sub>CAP</sub> A, D <sub>CAP</sub> B Output Impedance <sup>4</sup>  | 10                        | $\Omega$ typ |  |
| Reference Temperature Coefficient <sup>4</sup>                        | 60 max, 20 typ            | ppm/°C       |  |
| V <sub>REF</sub> Noise <sup>4</sup>                                   | 20                        | μV rms typ   |  |
| EXTERNAL VOLTAGE REFERENCE (INPUT) <sup>5</sup>                       |                           |              |  |
| Reference Input Voltage Range <sup>7</sup>                            | 0.1 to AV <sub>DD</sub>   | V            | See ADC—Typical Performance Characteristics                |
| DC Leakage Current <sup>7</sup>                                       | ±2                        | μA max       |  |
| Input Capacitance <sup>4</sup>  | 25                        | pF typ       |  |
| DIGITAL LOGIC INPUTS  |                           |              |  |
| Input High Voltage, V <sub>INH</sub>                                  | 2.8                       | V min        |  |
| Input Low Voltage, V <sub>INL</sub>                                   | 0.4                       | V max        |  |
| Input Current, I <sub>IN</sub>  | ±15                       | nA typ       | $V_{IN} = 0 \text{ V or } V_{DRIVE}$                       |
| Input Capacitance, C <sub>IN</sub> <sup>4</sup>                       | 5                         | pF typ       |  |

Table 47. Operating Conditions (Analog, Voltage Reference, and Logic I/O) (Continued)

| Parameter                                      | Specification             | Unit   | Test Conditions/Comments             |
|--|---------------------------|--------|--------------------------------------|
| DIGITAL LOGIC OUTPUTS                          |                           |        |                                      |
| Output High Voltage, V <sub>OH</sub>           | $V_{DRIVE} - 0.2$         | V min  | No DC load $(I_{OH} = 0 \text{ mA})$ |
| Output Low Voltage, V <sub>OL</sub>            | 0.4                       | V max  | No DC load $(I_{OL} = 0 \text{ mA})$ |
| Floating State Leakage Current                 | ±1                        | μA max | $V_{IN} = 0 \text{ V or } V_{DRIVE}$ |
| Floating State Output Capacitance <sup>4</sup> | 7                         | pF typ |                                      |
| Output Coding <sup>8</sup>                     | Straight (natural) binary |        |                                      |
|  | twos complement           |        |                                      |

 $<sup>^1\,</sup>V_{\rm IN\text{-}}$  or  $V_{\rm IN\text{+}}$  must remain within GND/V  $_{DD}$  .

Table 48. Operating Conditions (ADC Performance/Accuracy)

| Parameter   | Specification | Unit    | Test Conditions/Comments  |
|---|---------------|---------|---|
| DYNAMIC PERFORMANCE                                       |               |         |   |
| Signal-to-Noise Ratio (SNR)                               | 71            | dB min  | f <sub>IN</sub> = 14 kHz sine wave; differential mode                   |
|   | 69            | dB min  | $f_{IN}$ = 14 kHz sine wave; single-ended and pseudo differential modes |
| Signal-to-(Noise + Distortion) Ratio (SINAD) <sup>1</sup> | 70            | dB min  | $f_{IN} = 14$ kHz sine wave; differential mode                          |
|   | 68            | dB min  | $f_{IN}$ = 14 kHz sine wave; single-ended and pseudo differential modes |
| Total Harmonic Distortion (THD) <sup>1</sup>              | -77           | dB max  | $f_{IN} = 14$ kHz sine wave; differential mode                          |
|   | -73           | dB max  | $f_{IN}$ = 14 kHz sine wave; single-ended and pseudo differential modes |
| Spurious-Free Dynamic Range (SFDR) <sup>1</sup>           | -75           | dB max  | f <sub>IN</sub> = 50 kHz sine wave                                      |
| Intermodulation Distortion (IMD) <sup>1,2</sup>           |               |         | $f_a = 30 \text{ kHz}$ , $fb = 50 \text{ kHz}$                          |
| Second-Order Terms  | -88           | dB typ  |   |
| Third-Order Terms   | -88           | dB typ  |   |
| Channel-to-Channel Isolation                              | -88           | dB typ  |   |
| SAMPLE AND HOLD   |               |         |   |
| Aperture Delay <sup>2</sup>                               | 11            | ns max  |   |
| Aperture Jitter <sup>2</sup>                              | 50            | ps typ  |   |
| Aperture Delay Matching <sup>2</sup>                      | 200           | ps max  |   |
| Full Power Bandwidth                                      | 33/26         | MHz typ | @ 3 dB, $AV_{DD}$ , $DV_{DD} = 5 V/AV_{DD}$ , $DV_{DD} = 3 V$           |
|   | 3.5/3         | MHz typ | @ 0.1 dB, $AV_{DD}$ , $DV_{DD} = 5 V/AV_{DD}$ , $DV_{DD} = 3 V$         |

 $<sup>^2\,</sup>V_{\rm IN-}$  = 0 V for specified performance. For full input range on  $V_{\rm IN-}$  pin, see Figure 74 and Figure 75.

<sup>&</sup>lt;sup>3</sup> For full common-mode range, see Figure 70 and Figure 71.

<sup>&</sup>lt;sup>4</sup> Sample tested during initial release to ensure compliance.

 $<sup>^5</sup>$  Relates to Pin  $D_{\text{CAP}}A$  or Pin  $D_{\text{CAP}}B$  (V  $_{\text{REF}}$  ).

<sup>&</sup>lt;sup>6</sup>See ADC—Terminology on Page 61.

 $<sup>^{7}</sup>$  External voltage reference applied to Pins  $D_{CAP}A$ , Pin  $D_{CAP}B$  ( $V_{REF}$ ).

<sup>&</sup>lt;sup>8</sup> See Table 52 and Table 53.

Table 48. Operating Conditions (ADC Performance/Accuracy) (Continued)

| Parameter                                       | Specification | Unit          | Test Conditions/Comments                                 |
|---|---------------|---------------|--|
| DC ACCURACY                                     |               |               |  |
| Resolution                                      | 12            | Bits          |  |
| Integral Nonlinearity (INL) <sup>1</sup>        | ±1            | LSB max       | ±0.7 LSB typ; differential mode                          |
|   | ±1.5          | LSB max       | ±0.9 LSB typ; single-ended and pseudo differential modes |
| Differential Nonlinearity (DNL) <sup>1, 3</sup> | ±0.99         | LSB max       | Differential mode  |
|   | -0.99/+1.5    | LSB max       | Single-ended and pseudo differential modes               |
| Straight Natural Binary Output Coding           |               |               |  |
| Offset Error <sup>1,2</sup>                     | ±7            | LSB max       |  |
| Offset Error Match <sup>1,2</sup>               | ±2            | LSB typ       |  |
| Gain Error <sup>1,2</sup>                       | ±2.5          | LSB max       |  |
| Gain Error Match <sup>1,2</sup>                 | ±0.5          | LSB typ       |  |
| Twos Complement Output Coding                   |               |               |  |
| Positive Gain Error <sup>1,2</sup>              | ±2            | LSB max       |  |
| Positive Gain Error Match <sup>1,2</sup>        | ±0.5          | LSB typ       |  |
| Zero Code Error <sup>1,2</sup>                  | ±5            | LSB max       |  |
| Zero Code Error Match <sup>1,2</sup>            | ±1            | LSB typ       |  |
| Negative Gain Error <sup>1,2</sup>              | ±2            | LSB max       |  |
| Negative Gain Error Match <sup>1,2</sup>        | ±0.5          | LSB typ       |  |
| CONVERSION RATE                                 |               |               |  |
| Conversion Time                                 | 14            | ADSCLK cycles | 437.5 ns with ADSCLK = 32 MHz                            |
| Track-and-Hold Acquisition Time <sup>2</sup>    | 90            | ns max        | Full-scale step input; $AV_{DD}$ , $DV_{DD} = 5 V$       |
|   | 110           | ns max        | Full-scale step input; $AV_{DD}$ , $DV_{DD} = 3 V$       |
| Throughput Rate                                 | 2             | MSPS max      |  |

Table 49. Operating Conditions (Power<sup>1</sup>)

| Parameter                               | Specification | Unit        | Test Conditions/Comments                         |  |  |  |
|---|---------------|-------------|--|--|--|--|
| POWER SUPPLY REQUIREMENTS               |               |             |  |  |  |  |
| $V_{DD}$                                | 2.7/5.25      | V min/V max |  |  |  |  |
| $V_{DRIVE}$                             | 2.7/5.25      | V min/V max |  |  |  |  |
| I <sub>DD</sub>                         |               |             | Digital Logic Inputs = 0 V or V <sub>DRIVE</sub> |  |  |  |
| Normal Mode (Static)                    | 2.3           | mA max      | $V_{DD} = 5.25 \text{ V}$                        |  |  |  |
| Operational                             |               |             |  |  |  |  |
| $f_S = 2 MSPS$                          | 6.4           | mA max      | $V_{DD} = 5.25 \text{ V}; 5.7 \text{ mA typ}$    |  |  |  |
| $f_S = 1.5 MSPS$                        | 4             | mA max      | $V_{DD} = 3.6 \text{ V}; 3.4 \text{ mA typ}$     |  |  |  |
| Partial Power-Down Mode                 | 500           | μA max      | Static   |  |  |  |
| Full Power-Down Mode (V <sub>DD</sub> ) | 2.8           | μA max      | Static   |  |  |  |
| POWER DISSIPATION                       |               |             |  |  |  |  |
| Normal Mode (Operational)               | 33.6          | mW max      | $V_{DD} = 5.25 \text{ V}$                        |  |  |  |
| Partial Power-Down (Static)             | 2.625         | mW max      | $V_{DD} = 5.25 \text{ V}$                        |  |  |  |
| Full Power-Down (Static)                | 14.7          | μW max      | $V_{DD} = 5.25 \text{ V}$                        |  |  |  |

 $<sup>^1</sup>$  In this table,  $V_{DD}$  refers to both  $AV_{DD}$  and  $DV_{DD}.$ 

See ADC—Terminology on Page 61.
 Sample tested during initial release to ensure compliance.

<sup>&</sup>lt;sup>3</sup> Guaranteed no missed codes to 12 bits.

### **ADC—TIMING SPECIFICATIONS**

Table 50. Serial Data Interface<sup>1</sup>

| Parameter Specification          |                          | Unit        | Test Conditions / Comments   |  |  |  |
|----------------------------------|--------------------------|-------------|--|--|--|--|
| f <sub>ADSCLK</sub> <sup>2</sup> | 1/32                     | MHz min/max |  |  |  |  |
| $t_{CONVERT}$ 14 × $t_{ADSCLK}$  |                          | ns max      | $t_{ADSCLK} = 1/f_{ADSCLK}$  |  |  |  |
|                                  | 437.5                    | ns max      | $f_{ADSCLK} = 32 \text{ MHz}, f_{SAMPLE} = 2 \text{ MSPS}; AV_{DD}, DV_{DD} = 5 \text{ V}$     |  |  |  |
|                                  | 560.0                    | ns max      | $f_{ADSCLK} = 25 \text{ MHz}, f_{SAMPLE} = 1.56 \text{ MSPS}; AV_{DD}, DV_{DD} = 3 \text{ V}$  |  |  |  |
|                                  | 583.3                    | ns max      | $f_{ADSCLK} = 24 \text{ MHz}, f_{SAMPLE} = 1.5 \text{ MSPS}; AV_{DD}, DV_{DD} = 2.7 \text{ V}$ |  |  |  |
| t <sub>QUIET</sub>               | 30                       | ns min      | Minimum time between end of serial read and next falling edge of $\overline{CS}$               |  |  |  |
| $t_2$                            | 18/23                    | ns min      | $\overline{\text{CS}}$ to ADSCLK setup time; $V_{DD} = 5 \text{ V/3 V}$                        |  |  |  |
| $t_3$                            | 15                       | ns max      | Delay from CS until D <sub>OUT</sub> A and D <sub>OUT</sub> B are three-state disabled         |  |  |  |
| $t_4^3$                          | 27/36                    | ns max      | Data access time after ADSCLK falling edge, $V_{DD} = 5 \text{ V/3 V}$                         |  |  |  |
| $t_5$                            | 0.45 t <sub>ADSCLK</sub> | ns min      | ADSCLK low pulse width   |  |  |  |
| t <sub>6</sub>                   | 0.45 t <sub>ADSCLK</sub> | ns min      | ADSCLK high pulse width  |  |  |  |
| t <sub>7</sub>                   | 5/10                     | ns min      | ADSCLK to data valid hold time, $V_{DD} = 5 \text{ V/3 V}$                                     |  |  |  |
| t <sub>8</sub>                   | 15                       | ns max      | CS rising edge to D <sub>OUT</sub> A, D <sub>OUT</sub> B, high impedance                       |  |  |  |
| t <sub>9</sub>                   | 30                       | ns min      | CS rising edge to falling edge pulse width   |  |  |  |
| t <sub>10</sub>                  | 5/35                     | ns min/max  | ADSCLK falling edge to D <sub>OUT</sub> A, D <sub>OUT</sub> B, high impedance                  |  |  |  |

<sup>&</sup>lt;sup>1</sup>See Figure 87 on Page 72 and Figure 88 on Page 72.

### **ADC—ABSOLUTE MAXIMUM RATINGS**

Stresses above those listed in Table 51 may cause permanent damage to the device. This is a stress rating only; functional operation of the device at these or any other conditions above those indicated in the operational section of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

Table 51. Absolute Maximum Ratings

| Parameter                                   | Rating   |  |  |
|---|--|--|--|
| AV <sub>DD</sub> , DV <sub>DD</sub> to AGND | -0.3 V to +7 V                                       |  |  |
| DV <sub>DD</sub> to DGND                    | –0.3 V to +7 V                                       |  |  |
| V <sub>DRIVE</sub> to DGND                  | $-0.3~V~to~DV_{DD}$                                  |  |  |
| V <sub>DRIVE</sub> to AGND                  | –0.3 V to $AV_{DD}$                                  |  |  |
| $AV_{DD}$ to $DV_{DD}$                      | -0.3 V to +0.3 V                                     |  |  |
| AGND to DGND                                | -0.3 V to +0.3 V                                     |  |  |
| Analog Input Voltage to AGND                | $-0.3 \text{ V to AV}_{DD} + 0.3 \text{ V}$          |  |  |
| Digital Input Voltage to DGND               | -0.3 V to +7 V                                       |  |  |
| Digital Output Voltage to GND               | $-0.3 \text{ V to V}_{\text{DRIVE}} + 0.3 \text{ V}$ |  |  |
| V <sub>REF</sub> to AGND                    | $-0.3 \text{ V to AV}_{DD} + 0.3 \text{ V}$          |  |  |
| Input Current to Any ADC Pin                | ±10 mA   |  |  |
| Except Supplies <sup>1</sup>                |  |  |  |
| Storage Temperature Range                   | See Table 20 on Page 31                              |  |  |
| Junction Temperature Under Bias             | See Table 20 on Page 31                              |  |  |

<sup>&</sup>lt;sup>1</sup> Transient currents of up to 100 mA will not cause latch up.

<sup>&</sup>lt;sup>2</sup> Minimum ADSCLK for specified performance; with slower ADSCLK frequencies, performance specifications apply typically.

 $<sup>^3</sup>$  The time required for the output to cross 0.4 V or 2.4 V.

### **ADC—TYPICAL PERFORMANCE CHARACTERISTICS**

 $T_A = 25$ °C, unless otherwise noted.

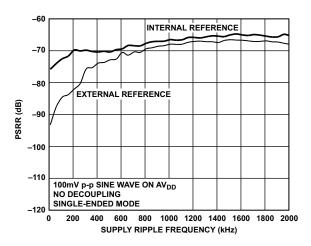


Figure 50. PSRR vs. Supply Ripple Frequency Without Supply Decoupling

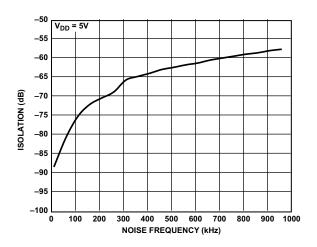


Figure 51. Channel-to-Channel Isolation

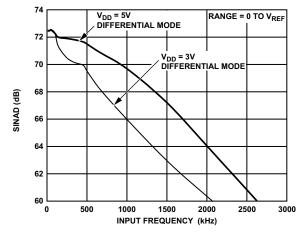


Figure 52. SINAD vs. Analog Input Frequency for Various Supply Voltages

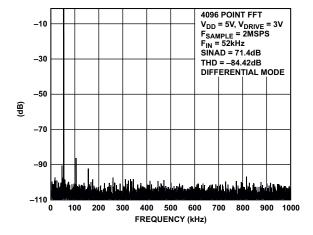


Figure 53. Typical FFT

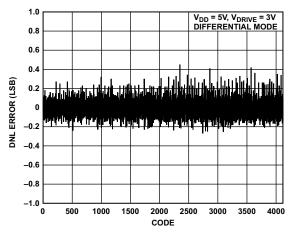


Figure 54. Typical DNL

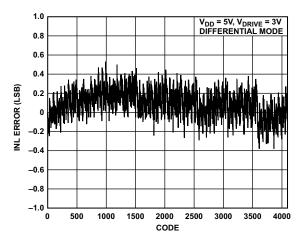


Figure 55. Typical INL

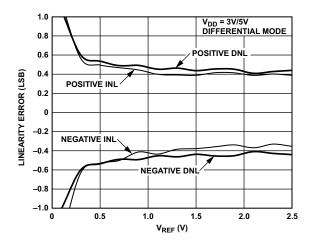


Figure 56. Linearity Error vs. V<sub>REF</sub>

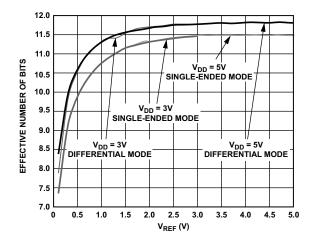


Figure 57. Effective Number of Bits vs. V<sub>REF</sub>

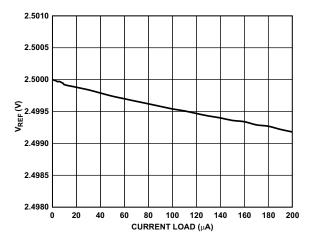


Figure 58. V<sub>REF</sub> vs. Reference Output Current Drive

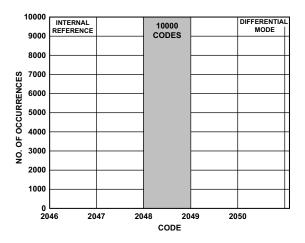


Figure 59. Histogram of Codes for 10k Samples in Differential Mode

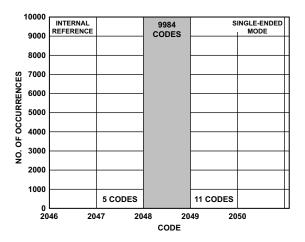


Figure 60. Histogram of Codes for 10k Samples in Single-Ended Mode

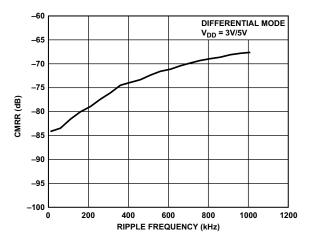


Figure 61. CMRR vs. Common-Mode Ripple Frequency

#### ADC—TERMINOLOGY

#### Differential Nonlinearity (DNL)

Differential nonlinearity is the difference between the measured and the ideal 1 LSB change between any two adjacent codes in the ADC.

#### **Integral Nonlinearity (INL)**

Integral nonlinearity is the maximum deviation from a straight line passing through the endpoints of the ADC transfer function. The endpoints of the transfer function are zero scale with a single (1) LSB point below the first code transition, and full scale with a 1 LSB point above the last code transition.

#### **Offset Error**

Offset error applies to straight binary output coding. It is the deviation of the first code transition (00...000) to (00...001) from the ideal (AGND + 1 LSB).

#### Offset Error Match

Offset error match is the difference in offset error across all 12 channels.

#### **Gain Error**

Gain error applies to straight binary output coding. It is the deviation of the last code transition (111 . . . 110) to (111 . . . 111) from the ideal ( $V_{REF}$  1 LSB) after the offset error is adjusted out. Gain error does not include reference error.

#### **Gain Error Match**

Gain error match is the difference in gain error across all 12 channels.

### **Positive Gain Error**

This applies when using twos complement output coding with, for example, the  $2\times V_{REF}$  input range as  $-V_{REF}$  to  $+V_{REF}$  biased about the  $V_{REF}$  point. It is the deviation of the last code transition (011...110) to (011...111) from the ideal (+ $V_{REF}$  – 1 LSB) after the zero code error is adjusted out.

### **Positive Gain Error Match**

This is the difference in positive gain error across all 12 channels.

#### **Zero Code Error**

Zero code error applies when using twos complement output coding with, for example, the  $2\times V_{REF}$  input range as  $-V_{REF}$  to  $+V_{REF}$  biased about the  $V_{REF}$  point. It is the deviation of the mid-scale transition (all 0s to all 1s) from the ideal  $V_{IN}$  voltage  $(V_{REF}).$ 

#### **Zero Code Error Match**

Zero code error match refers to the difference in zero code error across all 12 channels.

#### **Negative Gain Error**

This applies when using twos complement output coding option, in particular the  $2\times V_{REF}$  input range as  $-V_{REF}$  to  $+V_{REF}$  biased about the  $V_{REF}$  point. It is the deviation of the first code transition (100...000) to (100...001) from the ideal (that is,  $-V_{REF}+1$  LSB) after the zero code error is adjusted out.

#### **Negative Gain Error Match**

This is the difference in negative gain error across all 12 channels.

#### Track-and-Hold Acquisition Time

The track-and-hold amplifier returns to track mode after the end of conversion. Track-and-hold acquisition time is the time required for the output of the track-and-hold amplifier to reach its final value, within  $\pm 1/2$  LSB, after the end of conversion.

### Signal-to-(Noise + Distortion) Ratio (SINAD)

This ratio is the measured ratio of signal-to-(noise + distortion) at the output of the ADC. The signal is the rms amplitude of the fundamental. Noise is the sum of all nonfundamental signals up to half the sampling frequency ( $f_{\rm S}/2$ ), excluding dc. The ratio is dependent on the number of quantization levels in the digitalization process; the more levels, the smaller the quantization noise. The theoretical signal-to-(noise + distortion) ratio for an ideal N-bit converter with a sine wave input is given by:

Signal-to-(Noise + Distortion) = (6.02N + 1.76) dB

Therefore, for a 12-bit converter, theoretical SINAD is 74 dB.

### **Total Harmonic Distortion (THD)**

Total harmonic distortion is the ratio of the rms sum of harmonics to the fundamental. For the ADC, it is defined as:

$$THD(dB) = 20 \log \frac{\sqrt{V_2^2 + V_3^2 + V_4^2 + V_5^2 + V_6^2}}{V_1}$$

where:

 $V_1$  is the rms amplitude of the fundamental.

 $V_2$ ,  $V_3$ ,  $V_4$ ,  $V_5$ , and  $V_6$  are the rms amplitudes of the second through the sixth harmonics.

#### **Effective Number of Bits (ENOB)**

This is a figure of merit which characterizes the dynamic performance of the ADC at a specified input frequency and sampling rate. ENOB is expressed in bits. For a full scale sinusoidal input, ENOB is defined as:

$$ENOB = (SINAD - 1.76)/6.02$$

#### Peak Harmonic or Spurious Noise (SFDR)

Peak harmonic, or spurious noise, is defined as the ratio of the rms value of the next largest component in the ADC output spectrum (up to  $f_S/2$ , excluding dc) to the rms value of the fundamental. Normally, the value of this specification is determined by the largest harmonic in the spectrum, but for ADCs where the harmonics are buried in the noise floor, it is a noise peak.

#### Channel-to-Channel Isolation

Channel-to-channel isolation is a measure of the level of crosstalk between channels. It is measured by applying a full-scale (2  $\times$  V<sub>REF</sub> when V<sub>DD</sub> = 5 V, V<sub>REF</sub> when V<sub>DD</sub> = 3 V), 10 kHz sine wave signal to all un-selected input channels and

determining how much that signal is attenuated in the selected channel with a 50 kHz signal (0 V to  $V_{REF}$ ). The result obtained is the worst-case across all 12 channels for the ADC.

#### Intermodulation Distortion (IMD)

With inputs consisting of sine waves at two frequencies, fa and fb, any active device with non-linearities create distortion products at sum, and difference frequencies of mfa  $\pm$  nfb where m, n = 0, 1, 2, 3, and so on. Intermodulation distortion terms are those for which neither m nor n are equal to zero. For example, the second-order terms include (fa + fb) and (fa fb), while the third-order terms include (2fa + fb), (2fa fb), (fa + 2fb), and (fa 2fb).

The ADC is tested using the CCIF standard where two input frequencies near the top end of the input bandwidth are used. In this case, the second-order terms are usually distanced in frequency from the original sine waves, while the third-order terms are usually at a frequency close to the input frequencies. As a result, the second-order and third-order terms are specified separately. The calculation of the inter-modulation distortion is as per the THD specification, where it is the ratio of the rms sum of the individual distortion products to the rms amplitude of the sum of the fundamentals expressed in dBs.

#### Common-Mode Rejection Ratio (CMRR)

CMRR is defined as the ratio of the power in the ADC output at full-scale frequency, f, to the power of a 100 mV p-p sine wave applied to the common-mode voltage of  $V_{\rm IN+}$  and  $V_{\rm IN}$  of frequency  $f_S$  as:

$$CMRR (dB) = 10 \log(Pf/Pf_S)$$

where:

*Pf* is the power at frequency *f* in the ADC output.

 $Pf_S$  is the power at frequency  $f_S$  in the ADC output.

### Power Supply Rejection Ratio (PSRR)

Variations in power supply affect the full-scale transition but not the converter's linearity. PSRR is the maximum change in the full-scale transition point due to a change in power supply voltage from the nominal value (see Figure 50 (PSRR vs. Supply Ripple Frequency Without Supply Decoupling).

#### Thermal Hysteresis

Thermal hysteresis is defined as the absolute maximum change of reference output voltage ( $V_{REF}$ ) after the device is cycled through temperature from either:

$$T_HYS$$
+ = +25°C to  $T_{MAX}$  to +25°C

or

$$T_HYS = +25$$
°C to  $T_{MIN}$  to  $+25$ °C

It is expressed in ppm by:

$$V_{HYS}(ppm) = \left| \frac{V_{REF}(25^{\circ}\text{C}) - V_{REF}(T_{HYS})}{V_{REF}(25^{\circ}\text{C})} \right| \times 10^{6}$$

where:

 $V_{\rm REF}$  (25°C) is  $V_{\rm REF}$  at 25°C.

 $V_{\text{REF}}$  ( $T\_HYS$ ) is the maximum change of  $V_{\text{REF}}$  at  $T\_HYS+$  or  $T\_HYS$ .

#### **ADC—THEORY OF OPERATION**

The following sections describe the ADC theory of operation.

#### **Circuit Information**

The ADC is a fast, micropower, dual, 12-bit, single-supply, ADC that operates from a 2.7 V to a 5.25 V supply. When operated from a 5 V supply, the ADC is capable of throughput rates of up to 2 MSPS when provided with a 32 MHz clock, and a throughput rate of up to 1.5 MSPS at 3 V.

The ADC contains two on-chip, differential track-and-hold amplifiers, two successive approximation ADCs, and a serial interface with two separate data output pins.

The serial clock input accesses data from the part but also provides the clock source for each successive approximation ADC. The analog input range for the part can be selected to be a 0 V to  $V_{\text{REF}}$  input or a  $2\times V_{\text{REF}}$  input, configured with either single-ended or differential analog inputs. The ADC has an on-chip 2.5 V reference that can be overdriven when an external reference is preferred. If the internal reference is to be used elsewhere in a system, then the output needs to buffered first.

The ADC also features power-down options to allow power saving between conversions. The power-down feature is implemented via the standard serial interface, as described in the ADC—Modes of Operation section.

#### **Converter Operation**

The ADC has two successive approximation ADCs, each based around two capacitive DACs. Figure 62 (ADC Acquisition Phase) and Figure 63 (ADC Conversion Phase) show simplified schematics of one of these ADCs in acquisition and conversion phase, respectively. The ADC is comprised of control logic, a SAR, and two capacitive DACs. In Figure 62 (ADC Acquisition Phase) (the acquisition phase), SW3 is closed, SW1 and SW2 are in Position A, the comparator is held in a balanced condition, and the sampling capacitor arrays acquire the differential signal on the input.

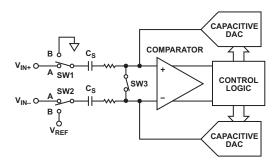


Figure 62. ADC Acquisition Phase

When the ADC starts a conversion (see Figure 63 (ADC Conversion Phase)), SW3 opens and SW1 and SW2 move to Position B, causing the comparator to become unbalanced. Both inputs are disconnected once the conversion begins. The control logic and the charge redistribution DACs are used to add and subtract fixed amounts of charge from the sampling capacitor arrays to bring the comparator back into a balanced condition. When the comparator is rebalanced, the conversion is complete. The control logic generates the ADC output code. The output impedances of the sources driving the  $V_{\rm IN+}$  and  $V_{\rm IN-}$  pins must be matched; otherwise, the two inputs will have different settling times, resulting in errors.

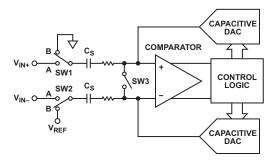


Figure 63. ADC Conversion Phase

### **Analog Input Structure**

Figure 64 (Equivalent Analog Input Circuit, Conversion Phase—Switches Open, Track Phase—Switches Closed) shows the equivalent circuit of the analog input structure of the ADC in differential/pseudo differential mode. In single-ended mode,  $V_{\rm IN}$  is internally tied to AGND. The four diodes provide ESD protection for the analog inputs. Care must be taken to ensure that the analog input signals never exceed the supply rails by more than 300 mV. This causes these diodes to become forward-biased and starts conducting into the substrate. These diodes can conduct up to 10 mA without causing irreversible damage to the part.

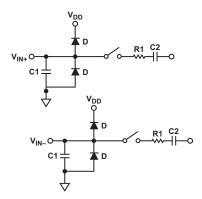


Figure 64. Equivalent Analog Input Circuit, Conversion Phase—Switches Open, Track Phase—Switches Closed

The C1 capacitors in Figure 64 (Equivalent Analog Input Circuit, Conversion Phase—Switches Open, Track Phase—Switches Closed) are typically 4 pF and can primarily be attributed to pin capacitance. The resistors are lumped components made up of the on resistance of the switches. The value of these resistors is typically about  $100~\Omega$ . The C2 capacitors are the ADC's sampling capacitors with a capacitance of 45 pF typically.

For ac applications, removing high frequency components from the analog input signal is recommended by the use of an RC low-pass filter on the relevant analog input pins with optimum values of 47  $\Omega$  and 10 pF. In applications where harmonic distortion and signal-to-noise ratio are critical, the analog input should be driven from a low impedance source. Large source impedances significantly affect the ac performance of the ADC and may necessitate the use of an input buffer amplifier. The choice of the op amp is a function of the particular application.

When no amplifier is used to drive the analog input, the source impedance should be limited to low values. The maximum source impedance depends on the amount of THD that can be tolerated.

The THD increases as the source impedance increases and performance degrades. Figure 65 (THD vs. Analog Input Frequency for Various Source Impedances, Single-Ended Mode shows a graph of the THD vs. the analog input signal frequency for different source impedances in single-ended mode, while Figure 66 (THD vs. Analog Input Frequency for Various Source Impedances, Differential Mode) shows the THD vs. the analog input signal frequency for different source impedances in differential mode.

Figure 67 (THD vs. Analog Input Frequency for Various Supply Voltages) shows a graph of the THD vs. the analog input frequency for various supplies while sampling at 2 MSPS. In this case, the source impedance is  $47~\Omega$ .

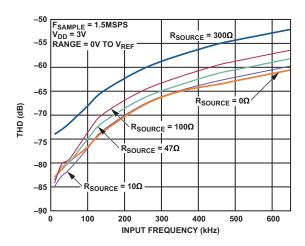


Figure 65. THD vs. Analog Input Frequency for Various Source Impedances, Single-Ended Mode

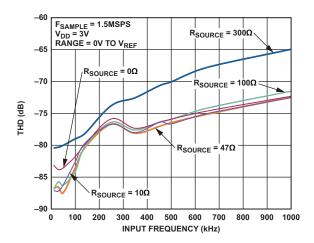


Figure 66. THD vs. Analog Input Frequency for Various Source Impedances, Differential Mode

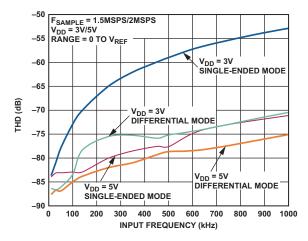


Figure 67. THD vs. Analog Input Frequency for Various Supply Voltages

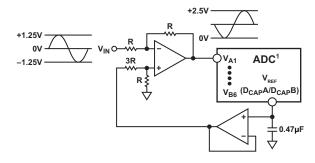
#### **Analog Inputs**

The ADC has a total of 12 analog inputs. Each on-board ADC has six analog inputs that can be configured as six single-ended channels, three pseudo differential channels, or three fully differential channels. These may be selected as described in the Analog Input Selection section.

## **Single-Ended Mode**

The ADC can have a total of 12 single-ended analog input channels. In applications where the signal source has high impedance, it is recommended to buffer the analog input before applying it to the ADC. The analog input range can be programmed to be either 0 to  $V_{\text{REF}}$  or 0 to  $2\times V_{\text{REF}}$ .

If the analog input signal to be sampled is bipolar, the internal reference of the ADC can be used to externally bias up this signal to make it correctly formatted for the ADC. Figure 68 shows a typical connection diagram when operating the ADC in single-ended mode.



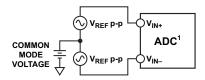
<sup>1</sup>ADDITIONAL PINS OMITTED FOR CLARITY.

Figure 68. Single-Ended Mode Connection Diagram

#### **Differential Mode**

The ADC can have a total of six differential analog input pairs.

Differential signals have some benefits over single-ended signals, including noise immunity based on the device's common-mode rejection and improvements in distortion performance. Figure 69 (Differential Input Definition) defines the fully differential analog input of the ADC.



<sup>1</sup>ADDITIONAL PINS OMITTED FOR CLARITY.

Figure 69. Differential Input Definition

The amplitude of the differential signal is the difference between the signals applied to the  $V_{\rm IN_+}$  and  $V_{\rm IN_-}$  pins in each differential pair  $(V_{\rm IN_+}\,V_{\rm IN_-}).\,V_{\rm IN_+}$  and  $V_{\rm IN_-}$  should be simultaneously driven by two signals each of amplitude  $V_{\rm REF}$  (or  $2\times V_{\rm REF}$ , depending on the range chosen) that are 180° out of phase. The amplitude of the differential signal is, therefore (assuming the 0 to  $V_{\rm REF}$  range is selected)  $-V_{\rm REF}$  to  $+V_{\rm REF}$  peak-to-peak  $(2\times V_{\rm REF})$ , regardless of the common mode (CM).

The common mode is the average of the two signals

$$(V_{IN+} + V_{IN-})/2$$

and is, therefore, the voltage on which the two inputs are centered.

This results in the span of each input being CM  $\pm$  V<sub>REF</sub>/2. This voltage has to be set up externally and its range varies with the reference value, V<sub>REF</sub>. As the value of V<sub>REF</sub> increases, the common-mode range decreases. When driving the inputs with an amplifier, the actual common-mode range is determined by the amplifier's output voltage swing.

Figure 70 (Input Common-Mode Range vs. VREF (0 to VREF Range, VDD = 5 V)) and Figure 71 (Input Common-Mode Range vs. VREF ( $2 \times VREF$  Range, VDD = 5 V)) show how the common-mode range typically varies with  $V_{REF}$  for a 5 V power

supply using the 0 to  $V_{\text{REF}}$  range or  $2 \times V_{\text{REF}}$  range, respectively. The common mode must be in this range to guarantee the functionality of the ADC.

When a conversion takes place, the common mode is rejected, resulting in a virtually noise free signal of amplitude  $-V_{REF}$  to  $+V_{REF}$  corresponding to the digital codes of 0 to 4096. If the  $2\times V_{REF}$  range is used, then the input signal amplitude extends from  $-2\ V_{REF}$  to  $+2\ V_{REF}$  after conversion.

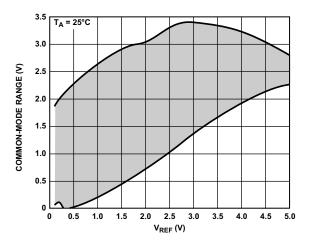


Figure 70. Input Common-Mode Range vs.  $V_{REF}$  (0 to  $V_{REF}$  Range,  $V_{DD} = 5 V$ )

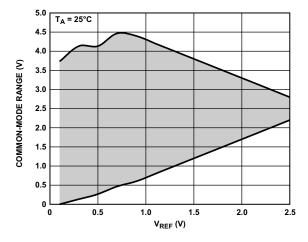


Figure 71. Input Common-Mode Range vs.  $V_{REF}$  (2 ×  $V_{REF}$  Range,  $V_{DD}$  = 5 V)

### **Driving Differential Inputs**

Differential operation requires that  $V_{\rm IN+}$  and  $V_{\rm IN-}$  be simultaneously driven with two equal signals that are 180° out of phase. The common mode must be set up externally. The common-mode range is determined by  $V_{\rm REF}$ , the power supply, and the particular amplifier used to drive the analog inputs. Differential modes of operation with either an ac or dc input provide the best THD performance over a wide frequency range. Because not all applications have a signal preconditioned for differential operation, there is often a need to perform single-ended-to-differential conversion.

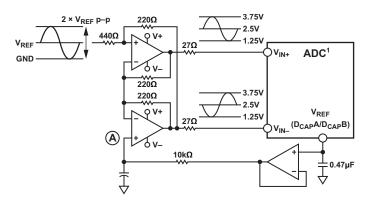
#### Using an Op Amp Pair

An op amp pair can be used to directly couple a differential signal to one of the analog input pairs of the ADC. The circuit configurations illustrated in Figure 72 (Dual Op Amp Circuit to Convert a Single-Ended Unipolar Signal Into a Differential Signal) and Figure 73 (Dual Op Amp Circuit to Convert a Single-Ended Bipolar Signal into a Differential Unipolar Signal) show how a dual op amp can be used to convert a single-ended signal into a differential signal for both a bipolar and unipolar input signal, respectively.

The voltage applied to Point A sets up the common-mode voltage. In both diagrams, it is connected in some way to the reference, but any value in the common-mode range can be input here to set up the common mode. The AD8022 is a suitable dual op amp that can be used in this configuration to provide differential drive to the ADC.

Take care when choosing the op amp; the selection depends on the required power supply and system performance objectives. The driver circuits in Figure 72 (Dual Op Amp Circuit to Convert a Single-Ended Unipolar Signal Into a Differential Signal) and Figure 73 (Dual Op Amp Circuit to Convert a Single-Ended Bipolar Signal into a Differential Unipolar Signal) are optimized for dc coupling applications requiring best distortion performance.

The circuit configuration shown in Figure 72 (Dual Op Amp Circuit to Convert a Single-Ended Unipolar Signal Into a Differential Signal) converts a unipolar, single-ended signal into a differential signal.



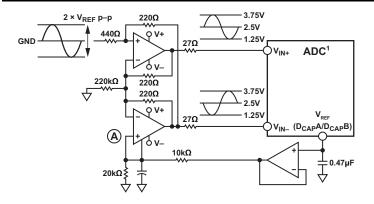
<sup>1</sup>ADDITIONAL PINS OMITTED FOR CLARITY.

Figure 72. Dual Op Amp Circuit to Convert a Single-Ended Unipolar Signal Into a Differential Signal

The differential op amp driver circuit shown in Figure 73 (Dual Op Amp Circuit to Convert a Single-Ended Bipolar Signal into a Differential Unipolar Signal) is configured to convert and level shift a single-ended, ground-referenced (bipolar) signal to a differential signal centered at the  $V_{\rm REF}$  level of the ADC.

#### Pseudo Differential Mode

The ADC can have a total of six pseudo differential pairs. In this mode,  $V_{\text{IN+}}$  is connected to the signal source that must have an amplitude of  $V_{\text{REF}}$  (or  $2\times V_{\text{REF}}$ , depending on the range chosen)



<sup>1</sup>ADDITIONAL PINS OMITTED FOR CLARITY.

Figure 73. Dual Op Amp Circuit to Convert a Single-Ended Bipolar Signal into a Differential Unipolar Signal

to make use of the full dynamic range of the part. A dc input is applied to the  $V_{\rm IN\_}$  pin. The voltage applied to this input provides an offset from ground or a pseudo ground for the  $V_{\rm IN+}$  input. The benefit of pseudo differential inputs is that they separate the analog input signal ground from the ADC's ground allowing dc common-mode voltages to be cancelled.

The typical voltage range for the  $V_{\rm IN-}$  pin, while in pseudo differential mode, is shown in Figure 74 ( $V_{\rm IN-}$  Input Voltage Range vs.  $V_{\rm REF}$  in Pseudo Differential Mode with  $V_{\rm DD}$  = 3 V) and Figure 75 ( $V_{\rm IN-}$  Input Voltage Range vs.  $V_{\rm REF}$  in Pseudo Differential Mode with  $V_{\rm DD}$  = 5 V). Figure 76 (Pseudo Differential Mode Connection Diagram) shows a connection diagram for pseudo differential mode.

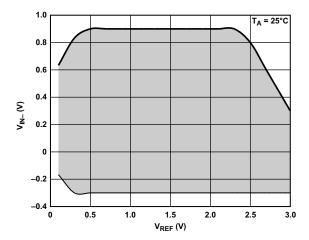


Figure 74.  $V_{IN-}$  Input Voltage Range vs.  $V_{REF}$  in Pseudo Differential Mode with  $V_{DD} = 3 V$ 

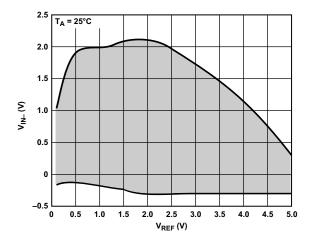
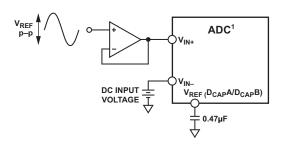


Figure 75.  $V_{IN-}$  Input Voltage Range vs.  $V_{REF}$  in Pseudo Differential Mode with  $V_{DD} = 5 \text{ V}$ 



<sup>1</sup>ADDITIONAL PINS OMITTED FOR CLARITY.

Figure 76. Pseudo Differential Mode Connection Diagram

## **Analog Input Selection**

The analog inputs of the ADC can be configured as singleended or true differential via the SGL/DIFF logic pin, as shown in Figure 77 (Selecting Differential or Single-Ended Configuration). If this pin is tied to a logic low, the analog input channels to each on-chip ADC are set up as three true differential pairs. If this pin is at logic high, the analog input channels to each onchip ADC are set up as six single-ended analog inputs. The required logic level on this pin needs to be established prior to the acquisition time and remain unchanged during the conversion time until the track-and-hold has returned to track. The track-and-hold returns to track on the 13th rising edge of ADSCLK after the CS falling edge (see Figure 87 (Serial Interface Timing Diagram)). If the level on this pin is changed, it will be recognized by the ADC; therefore, it is necessary to keep the same logic level during acquisition and conversion to avoid corrupting the conversion in progress.

For example, in Figure 77 (Selecting Differential or Single-Ended Configuration) the SGL/DIFF pin is set at logic high for the duration of both the acquisition and conversion times so the analog inputs are configured as single ended for that conversion (Sampling Point A). The logic level of the SGL/DIFF changed to low after the track-and-hold returned to track and prior to the

required acquisition time for the next sampling instant at Point B; therefore, the analog inputs are configured as differential for that conversion.

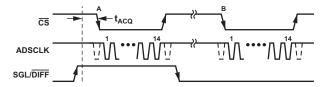


Figure 77. Selecting Differential or Single-Ended Configuration

The channels used for simultaneous conversions are selected via the multiplexer address input pins, A0 to A2. The logic states of these pins also need to be established prior to the acquisition time; however, they may change during the conversion time provided the mode is not changed. If the mode is changed from fully differential to pseudo differential, for example, then the acquisition time would start again from this point. The selected input channels are decoded as shown in Table 53 (Analog Input Type and Channel Selection).

The analog input range of the ADC can be selected as 0 V to  $V_{REF}$  or 0 V to 2 ×  $V_{REF}$  via the RANGE pin. This selection is made in a similar fashion to that of the SGL/DIFF pin by setting the logic state of the RANGE pin a time  $t_{acq}$  prior to the falling edge of  $\overline{CS}$ . Subsequent to this, the logic level on this pin can be

altered after the third falling edge of ADSCLK. If this pin is tied to a logic low, the analog input range selected is 0 V to  $V_{\text{REF}}.$  If this pin is tied to a logic high, the analog input range selected is 0 V to 2  $\times$   $V_{\text{RFF}}.$ 

#### **Output Coding**

The ADC output coding is set to either twos complement or straight binary, depending on which analog input configuration is selected for a conversion. Table 52 (ADC Output Coding) shows which output coding scheme is used for each possible analog input configuration.

#### **Transfer Functions**

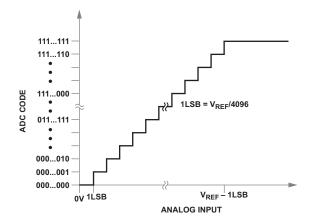
The designed code transitions occur at successive integer LSB values (1 LSB, 2 LSB, and so on). In single-ended mode, the LSB size is  $V_{\text{REF}}/4096$  when the 0 V to  $V_{\text{REF}}$  range is used, and the LSB size is  $2\times V_{\text{REF}}/4096$  when the 0 V to  $2\times V_{\text{REF}}$  range is used. In differential mode, the LSB size is  $2\times V_{\text{REF}}/4096$  when the 0 V to  $V_{\text{REF}}$  range is used, and the LSB size is  $4\times V_{\text{REF}}/4096$  when the 0 V to  $2\times V_{\text{REF}}$  range is used. The ideal transfer characteristic for the ADC when straight binary coding is output is shown in Figure 78 (Straight Binary Transfer Characteristic), and the ideal transfer characteristic for the ADC when twos complement coding is output is shown in Figure 79 (Twos Complement Transfer Characteristic with VREF  $\pm$  VREF Input Range) (this is shown with the  $2\times V_{\text{REF}}$  range).

Table 52. ADC Output Coding

| SGL/DIF | F                           | RANGE |  | Output Coding   |
|---------|-----------------------------|-------|--|-----------------|
| 0       | (Differential Input)        | 0     | (0 V to V <sub>REF</sub> )                         | Twos complement |
| 0       | (Differential Input)        | 1     | $(0 \text{ V to } 2 \times V_{REF})$               | Twos complement |
| 1       | (Single-Ended Input)        | 0     | $(0 \text{ V to V}_{REF})$                         | Straight binary |
| 1       | (Single-Ended Input)        | 1     | $(0 \text{ V to 2} \times \text{ V}_{\text{REF}})$ | Twos complement |
| 0       | (Pseudo-Differential Input) | 0     | (0 V to V <sub>REF</sub> )                         | Straight binary |
| 0       | (Pseudo-Differential Input) | 1     | (0 V to 2 $\times$ V <sub>REF</sub> )              | Twos complement |

Table 53. Analog Input Type and Channel Selection

|          |    |    |    | ADC A     |                  |           | ADC B            |                     |
|----------|----|----|----|-----------|------------------|-----------|------------------|---------------------|
| SGL/DIFF | A2 | A1 | AO | $V_{IN+}$ | $V_{\text{IN-}}$ | $V_{IN+}$ | $V_{\text{IN-}}$ | Comment             |
| 1        | 0  | 0  | 0  | $V_{A1}$  | AGND             | $V_{B1}$  | AGND             | Single ended        |
| 1        | 0  | 0  | 1  | $V_{A2}$  | AGND             | $V_{B2}$  | AGND             | Single ended        |
| 1        | 0  | 1  | 0  | $V_{A3}$  | AGND             | $V_{B3}$  | AGND             | Single ended        |
| 1        | 0  | 1  | 1  | $V_{A4}$  | AGND             | $V_{B4}$  | AGND             | Single ended        |
| 1        | 1  | 0  | 0  | $V_{A5}$  | AGND             | $V_{B5}$  | AGND             | Single ended        |
| 1        | 1  | 0  | 1  | $V_{A6}$  | AGND             | $V_{B6}$  | AGND             | Single ended        |
| 0        | 0  | 0  | 0  | $V_{A1}$  | $V_{A2}$         | $V_{B1}$  | $V_{B2}$         | Fully differential  |
| 0        | 0  | 0  | 1  | $V_{A1}$  | $V_{A2}$         | $V_{B1}$  | $V_{B2}$         | Pseudo differential |
| 0        | 0  | 1  | 0  | $V_{A3}$  | $V_{A4}$         | $V_{B3}$  | $V_{B4}$         | Fully differential  |
| 0        | 0  | 1  | 1  | $V_{A3}$  | $V_{A4}$         | $V_{B3}$  | $V_{B4}$         | Pseudo differential |
| 0        | 1  | 0  | 0  | $V_{A5}$  | $V_{A6}$         | $V_{B5}$  | $V_{B6}$         | Fully differential  |
| 0        | 1  | 0  | 1  | $V_{A5}$  | $V_{A6}$         | $V_{B5}$  | $V_{B6}$         | Pseudo differential |



NOTE 1. V<sub>REF</sub> IS EITHER V<sub>REF</sub> OR 2 × V<sub>REF</sub>.

Figure 78. Straight Binary Transfer Characteristic

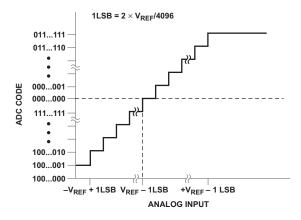


Figure 79. Twos Complement Transfer Characteristic with  $V_{\rm RFE} \pm V_{\rm RFE}$  Input Range

#### Serial Interface Voltage Drive

The ADC also has a  $V_{DRIVE}$  feature to control the voltage at which the serial interface operates.  $V_{DRIVE}$  allows the ADC to easily interface to both 3 V and 5 V processors. For example, if the ADC was operated with a  $AV_{DD}/DV_{DD}$  of 5 V, the  $V_{DRIVE}$  pin could be powered from a 3 V supply, best ADC performance low voltage digital processors. Therefore, the ADC could be used with the  $2\times V_{REF}$  input range, with a  $AV_{DD}/DV_{DD}$  of 5 V while still being able to serial interface to 3 V digital I/O parts.

### **ADC—MODES OF OPERATION**

The mode of operation of the ADC is selected by controlling the (logic) state of the  $\overline{\text{CS}}$  signal during a conversion. There are three possible modes of operation: normal mode, partial powerdown mode, and full power-down mode. After a conversion is initiated, the point at which  $\overline{\text{CS}}$  is pulled high determines which power-down mode, if any, the device enters. Similarly, if already in a power-down mode,  $\overline{\text{CS}}$  can control whether the device returns to normal operation or remains in power-down. These modes of operation are designed to provide flexible power man-

agement options. These options can be chosen to optimize the power dissipation/throughput rate ratio for differing application requirements.

#### Normal Mode

This mode is intended for applications needing fastest throughput rates because the user does not have to worry about any power-up times with the ADC remaining fully powered at all times. Figure 80 (Normal Mode Operation) shows the general diagram of the operation of the ADC in this mode.

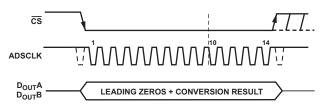


Figure 80. Normal Mode Operation

The conversion is initiated on the falling edge of  $\overline{CS}$ , as described in the ADC—Serial Interface section. To ensure that the part remains fully powered up at all times,  $\overline{\text{CS}}$  must remain low until at least 10 ADSCLK falling edges have elapsed after the falling edge of  $\overline{CS}$ . If  $\overline{CS}$  is brought high any time after the  $10^{th}$ ADSCLK falling edge but before the 14th ADSCLK falling edge, the part remains powered up, but the conversion is terminated and  $D_{\text{OUT}}A$  and  $D_{\text{OUT}}B$  go back into three-state. Fourteen serial clock cycles are required to complete the conversion and access the conversion result. The  $D_{\text{OUT}}$  line does not return to threestate after 14 ADSCLK cycles have elapsed, but instead does so when CS is brought high again. If CS is left low for another 2 ADSCLK cycles (for example, if only a 16 ADSCLK burst is available), two trailing zeros are clocked out after the data. If  $\overline{\text{CS}}$ is left low for a further 14 (or16) ADSCLK cycles, the result from the other ADC on board is also accessed on the same  $D_{\text{OUT}}$ line, as shown in Figure 88 (Reading Data from Both ADCs on One DOUT Line with 32 ADSCLKs). See the ADC—Serial Interface section.

Once 32 ADSCLK cycles have elapsed, the  $D_{OUT}$  line returns to three-state on the  $32^{nd}$  ADSCLK falling edge. If  $\overline{CS}$  is brought high prior to this, the  $D_{OUT}$  line returns to three-state at that point. Therefore,  $\overline{CS}$  may idle low after 32 ADSCLK cycles until it is brought high again sometime prior to the next conversion (effectively idling  $\overline{CS}$  low), if so desired, because the bus still returns to three-state upon completion of the dual result read.

Once a data transfer is complete and  $D_{OUT}A$  and  $D_{OUT}B$  have returned to three-state, another conversion can be initiated after the quiet time,  $t_{QUIET}$ , has elapsed by bringing  $\overline{CS}$  low again (assuming the required acquisition time is allowed).

#### Partial Power-Down Mode

This mode is intended for use in applications where slower throughput rates are required. Either the ADC is powered down between each conversion, or a series of conversions may be performed at a high throughput rate, and the ADC is then powered

down for a relatively long duration between these bursts of several conversions. When the ADC is in partial power-down, all analog circuitry is powered down except for the on-chip reference and reference buffer.

To enter partial power-down mode, the conversion process must be interrupted by bringing  $\overline{CS}$  high anywhere after the second falling edge of ADSCLK and before the  $10^{th}$  falling edge of ADSCLK, as shown in Figure 81 (Entering Partial Power-Down Mode). Once  $\overline{CS}$  is brought high in this window of ADSCLKs, the part enters partial power-down, the conversion that was initiated by the falling edge of  $\overline{CS}$  is terminated, and  $D_{OUT}A$  and  $D_{OUT}B$  go back into three-state. If  $\overline{CS}$  is brought high before the second ADSCLK falling edge, the part remains in normal mode and does not power down. This avoids accidental power-down due to glitches on the  $\overline{CS}$  line.

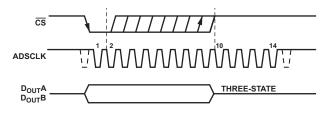


Figure 81. Entering Partial Power-Down Mode

To exit this mode of operation and power up the ADC again, a dummy conversion is performed. On the falling edge of  $\overline{CS}$ , the device begins to power up and continues to power up as long as  $\overline{CS}$  is held low until after the falling edge of the  $10^{th}$  ADSCLK. The device is fully powered up after approximately 1  $\mu$ s has elapsed, and valid data results from the next conversion, as shown in Figure 82 (Exiting Partial Power-Down Mode). If  $\overline{CS}$  is brought high before the second falling edge of ADSCLK, the ADC again goes into partial power-down. This avoids accidental power-up due to glitches on the  $\overline{CS}$  line. Although the device may begin to power up on the falling edge of  $\overline{CS}$ , it powers down

again on the rising edge of  $\overline{\text{CS}}$ . If the ADC is already in partial power-down mode and  $\overline{\text{CS}}$  is brought high between the second and 10<sup>th</sup> falling edges of ADSCLK, the device enters full power-down mode.

#### Full Power-Down Mode

This mode is intended for use in applications where throughput rates slower than those in the partial power-down mode are required, as power-up from a full power-down takes substantially longer than that from partial power-down. This mode is more suited to applications where a series of conversions performed at a relatively high throughput rate are followed by a long period of inactivity and thus power-down. When the ADC is in full power-down, all analog circuitry is powered down. Full power-down is entered in a similar way as partial power-down, except the timing sequence shown in Figure 81 (Entering Partial Power-Down Mode) must be executed twice. The conversion process must be interrupted in a similar fashion by bringing  $\overline{CS}$ high anywhere after the second falling edge of ADSCLK and before the 10<sup>th</sup> falling edge of ADSCLK. The device enters partial power-down at this point. To reach full power-down, the next conversion cycle must be interrupted in the same way, as shown in Figure 83 (Entering Full Power-Down Mode). Once CS is brought high in this window of ADSCLKs, the part completely powers down.

Note that it is not necessary to complete the 14 ADSCLKs once  $\overline{CS}$  is brought high to enter a power-down mode.

To exit full power-down and power up the ADC, a dummy conversion is performed, as when powering up from partial power-down. On the falling edge of  $\overline{CS}$ , the device begins to power up and continues to power up, as long as  $\overline{CS}$  is held low until after the falling edge of the  $10^{th}$  ADSCLK. The required power-up time must elapse before a conversion can be initiated, as shown in Figure 84 (Exiting Full Power-Down Mode). See the Power-Up Times section for the power-up times associated with the ADC.

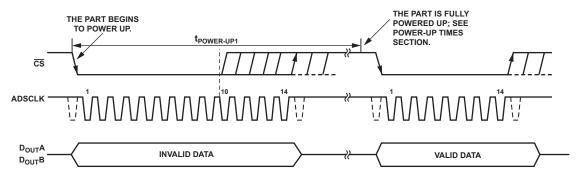


Figure 82. Exiting Partial Power-Down Mode

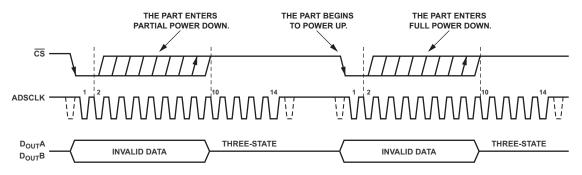


Figure 83. Entering Full Power-Down Mode

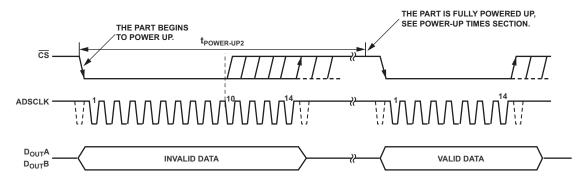


Figure 84. Exiting Full Power-Down Mode

#### **Power-Up Times**

As described in detail, the ADC has two power-down modes, partial power-down and full power-down. This section deals with the power-up time required when coming out of either of these modes. It should be noted that the power-up times, as explained in this section, apply with the recommended capacitors in place on the  $D_{\text{CAP}}A$  and  $D_{\text{CAP}}B$  pins.

To power up from full power-down, approximately 1.5 ms should be allowed from the falling edge of  $\overline{\text{CS}}$ , shown as tpower-up? in Figure 84 (Exiting Full Power-Down Mode). Powering up from partial power-down requires much less time. The power-up time from partial power-down is typically 1  $\mu\text{s}$ ; however, if using the internal reference, then the ADC must be in partial power-down for at least 67  $\mu\text{s}$  in order for this power-up time to apply.

When power supplies are first applied to the ADC, the ADC may power up in either of the power-down modes or normal mode. Because of this, it is best to allow a dummy cycle to elapse to ensure the part is fully powered up before attempting a valid conversion. Likewise, if it is intended to keep the part in the partial power-down mode immediately after the supplies are applied, then two dummy cycles must be initiated. The first dummy cycle must hold  $\overline{CS}$  low until after the  $10^{th}$  ADSCLK falling edge (see Figure 80 (Normal Mode Operation)); in the second cycle,  $\overline{CS}$  must be brought high before the  $10^{th}$  ADSCLK edge but after the second ADSCLK falling edge (see Figure 81 (Entering Partial Power-Down Mode)). Alternatively, if it is intended to place the part in full power-down mode when the supplies are applied, then three dummy cycles must be initiated.

The first dummy cycle must hold  $\overline{\text{CS}}$  low until after the 10<sup>th</sup> ADSCLK falling edge (see Figure 80 (Normal Mode Operation)); the second and third dummy cycles place the part in full power-down (see Figure 83 (Entering Full Power-Down Mode)).

Once supplies are applied to the ADC, enough time must be allowed for any external reference to power up and charge the various reference buffer decoupling capacitors to their final values.

#### **Power vs. Throughput Rate**

The power consumption of the ADC varies with the throughput rate. When using very slow throughput rates and as fast an ADSCLK frequency as possible, the various power-down options can be used to make significant power savings. However, the ADC quiescent current is low enough that even without using the power-down options, there is a noticeable variation in power consumption with sampling rate. This is true whether a fixed ADSCLK value is used or if it is scaled with the sampling rate. Figure 85 (Power vs. Throughput in Normal Mode with VDD = 3 V) and Figure 86 (Power vs. Throughput in Normal Mode with VDD = 5 V) show plots of power vs. the throughput rate when operating in normal mode for a fixed

maximum ADSCLK frequency and an ADSCLK frequency that scales with the sampling rate with  $V_{\rm DD}=3~V$  and  $V_{\rm DD}=5~V$ , respectively. In all cases, the internal reference was used.

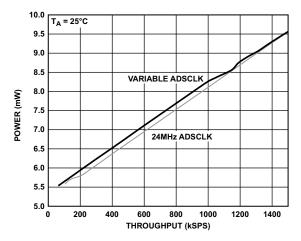


Figure 85. Power vs. Throughput in Normal Mode with  $V_{DD} = 3 V$ 

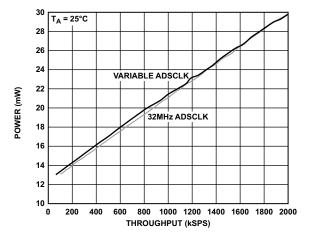


Figure 86. Power vs. Throughput in Normal Mode with  $V_{DD} = 5 V$ 

#### **ADC—SERIAL INTERFACE**

Figure 87 (Serial Interface Timing Diagram) shows the detailed timing diagram for serial interfacing to the ADC. The serial clock provides the conversion clock and controls the transfer of information from the ADC during conversion.

The  $\overline{\text{CS}}$  signal initiates the data transfer and conversion process. The falling edge of  $\overline{\text{CS}}$  puts the track-and-hold into hold mode, at which point the analog input is sampled and the bus is taken out of three-state. The conversion is also initiated at this point and requires a minimum of 14 ADSCLKs to complete. Once 13 ADSCLK falling edges have elapsed, the track-and-hold goes back into track on the next ADSCLK rising edge, as shown in Figure 87 (Serial Interface Timing Diagram) at Point B. If a 16 ADSCLK transfer is used, then two trailing zeros appear after the final LSB. On the rising edge of  $\overline{\text{CS}}$ , the conversion is terminated and  $D_{\text{OUT}}A$  and  $D_{\text{OUT}}B$  go back into three-state. If  $\overline{\text{CS}}$  is

not brought high but is instead held low for a further 14 (or 16) ADSCLK cycles on  $D_{OUT}A$ , the data from Conversion B is output on  $D_{OUT}A$  (followed by two trailing zeros).

Likewise, if  $\overline{\text{CS}}$  is held low for a further 14 (or 16) ADSCLK cycles on  $D_{\text{OUT}}B$ , the data from Conversion A is output on  $D_{\text{OUT}}B$ .

This is illustrated in Figure 88 (Reading Data from Both ADCs on One DOUT Line with 32 ADSCLKs) where the case for  $D_{OUT}A$  is shown. In this case, the  $D_{OUT}$  line in use goes back into three-state on the  $32^{nd}$  ADSCLK falling edge or the rising edge of  $\overline{CS}$ , whichever occurs first.

A minimum of 14 serial clock cycles are required to perform the conversion process and to access data from one conversion on either data line of the ADC.  $\overline{\text{CS}}$  going low provides the leading zero to be read in by the microcontroller or DSP. The remaining data is then clocked out by subsequent ADSCLK falling edges, beginning with a second leading zero. Thus, the first falling clock edge on the serial clock has the leading zero provided and also clocks out the second leading zero. The 12-bit result then follows with the final bit in the data transfer valid on the 14th falling edge, having being clocked out on the previous (13<sup>th</sup>) falling edge. In applications with a slower ADSCLK, it may be possible to read in data on each ADSCLK rising edge depending on the ADSCLK frequency. The first rising edge of ADSCLK after the  $\overline{CS}$  falling edge would have the second leading zero provided, and the 13<sup>th</sup> rising ADSCLK edge would have DB0 provided.

Note that with fast ADSCLK values, and thus short ADSCLK periods, in order to allow adequately for  $t_2$ , an ADSCLK rising edge may occur before the first ADSCLK falling edge. This rising edge of ADSCLK may be ignored for the purposes of the timing descriptions in this section. If a falling edge of ADSCLK is coincident with the falling edge of  $\overline{\text{CS}}$ , then this falling edge of ADSCLK is not acknowledged by the ADC, and the next falling edge of ADSCLK will be the first registered after the falling edge of  $\overline{\text{CS}}$ .

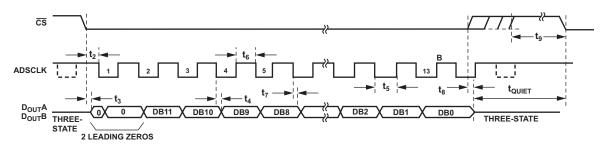


Figure 87. Serial Interface Timing Diagram

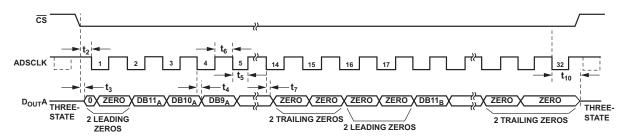


Figure 88. Reading Data from Both ADCs on One  $D_{\rm OUT}$  Line with 32 ADSCLKs

#### 120-LEAD LQFP LEAD ASSIGNMENT

Table 54 lists the LQFP leads by signal mnemonic. Table 55 on Page 74 lists the LQFP leads by lead number.

Table 54. 120-Lead LQFP Lead Assignment (Alphabetical by Signal)

| Signal             | Lead No. | Signal | Lead No. | Signal     | Lead No. | Signal             | Lead No. |
|--------------------|----------|--------|----------|------------|----------|--------------------|----------|
| A0                 | 100      | NC     | 72       | PG11       | 46       | $V_{B5}$           | 88       |
| A1                 | 98       | NMI    | 11       | PG12       | 47       | $V_{B6}$           | 87       |
| A2                 | 97       | PF0    | 118      | PG13       | 48       | $V_{DDEXT}$        | 1        |
| AGND               | 73       | PF1    | 119      | PG14       | 49       | $V_{DDEXT}$        | 6        |
| AGND               | 78       | PF2    | 2        | PG15       | 50       | $V_{DDEXT}$        | 15       |
| AGND               | 79       | PF3    | 4        | PH0        | 113      | $V_{DDEXT}$        | 20       |
| AGND               | 82       | PF4    | 3        | PH1        | 115      | $V_{DDEXT}$        | 23       |
| AGND               | 93       | PF5    | 5        | PH2        | 114      | $V_{DDEXT}$        | 26       |
| AGND               | 99       | PF6    | 7        | RANGE      | 95       | $V_{DDEXT}$        | 30       |
| $AV_DD$            | 76       | PF7    | 8        | REF_SELECT | 75       | $V_{DDEXT}$        | 41       |
| BMODE0             | 58       | PF8    | 9        | RESET      | 12       | $V_{DDEXT}$        | 51       |
| BMODE1             | 57       | PF9    | 10       | SCL        | 55       | $V_{DDEXT}$        | 59       |
| BMODE2             | 56       | PF10   | 14       | ADSCLK     | 102      | $V_{DDEXT}$        | 62       |
| CLKIN              | 110      | PF11   | 16       | SDA        | 54       | $V_{DDEXT}$        | 64       |
| <u>CS</u>          | 101      | PF12   | 18       | SGL/DIFF   | 96       | $V_{DDEXT}$        | 66       |
| $D_{CAP}A$         | 77       | PF13   | 19       | TCK        | 34       | $V_{DDEXT}$        | 67       |
| $D_CAPB$           | 94       | PF14   | 21       | TDI        | 33       | $V_{DDEXT}$        | 112      |
| DGND               | 74       | PF15   | 22       | TDO        | 36       | $V_{DDEXT}$        | 116      |
| DGND               | 104      | PG     | 71       | TMS        | 35       | $V_{DDFLASH}$      | 25       |
| D <sub>OUT</sub> A | 105      | PG0    | 27       | TRST       | 37       | $V_{DDFLASH}$      | 63       |
| D <sub>OUT</sub> B | 103      | PG1    | 28       | $V_{A1}$   | 80       | $V_{DDFLASH}$      | 69       |
| $DV_DD$            | 107      | PG2    | 29       | $V_{A2}$   | 81       | $V_{DDINT}$        | 24       |
| EMU                | 68       | PG3    | 31       | $V_{A3}$   | 83       | $V_{DDINT}$        | 42       |
| EXT_WAKE           | 70       | PG4    | 32       | $V_{A4}$   | 84       | $V_{\text{DDINT}}$ | 52       |
| EXTCLK             | 120      | PG5    | 38       | $V_{A5}$   | 85       | $V_{\text{DDINT}}$ | 53       |
| GND                | 13       | PG6    | 39       | $V_{A6}$   | 86       | $V_{DDINT}$        | 61       |
| GND                | 17       | PG7    | 40       | $V_{B1}$   | 92       | $V_{DDINT}$        | 65       |
| GND                | 108      | PG8    | 43       | $V_{B2}$   | 91       | $V_{\text{DDINT}}$ | 117      |
| GND                | 109      | PG9    | 44       | $V_{B3}$   | 90       | $V_{DRIVE}$        | 106      |
| NC                 | 60       | PG10   | 45       | $V_{B4}$   | 89       | XTAL               | 111      |
|                    |          |        |          |            |          | GND                | 121*     |
|                    |          |        |          |            |          | AGND               | 122**    |

<sup>\*</sup> Pin no. 121 is the GND supply (see Figure 89 and Figure 90) for the processor (4.6mm × 6.17mm); this pad must connect to GND.

<sup>\*\*</sup> Pin no. 122 is the AGND supply (see Figure 89 and Figure 90) for the ADC (2.81mm  $\times$  2.81mm); this pad **must** connect to AGND.

Table 55. 120-Lead LQFP Lead Assignment (Numerical by Lead Number)

| Lead No. | Signal        | Lead No. | Signal      | Lead No. | Signal        | Lead No. | Signal          |
|----------|---------------|----------|-------------|----------|---------------|----------|-----------------|
| 1        | $V_{DDEXT}$   | 31       | PG3         | 61       | $V_{DDINT}$   | 91       | V <sub>B2</sub> |
| 2        | PF2           | 32       | PG4         | 62       | $V_{DDEXT}$   | 92       | $V_{B1}$        |
| 3        | PF4           | 33       | TDI         | 63       | $V_{DDFLASH}$ | 93       | AGND            |
| 4        | PF3           | 34       | TCK         | 64       | $V_{DDEXT}$   | 94       | $D_CAPB$        |
| 5        | PF5           | 35       | TMS         | 65       | $V_{DDINT}$   | 95       | RANGE           |
| 6        | $V_{DDEXT}$   | 36       | TDO         | 66       | $V_{DDEXT}$   | 96       | SGL/DIFF        |
| 7        | PF6           | 37       | TRST        | 67       | $V_{DDEXT}$   | 97       | A2              |
| 8        | PF7           | 38       | PG5         | 68       | <b>EMU</b>    | 98       | A1              |
| 9        | PF8           | 39       | PG6         | 69       | $V_{DDFLASH}$ | 99       | AGND            |
| 10       | PF9           | 40       | PG7         | 70       | EXT_WAKE      | 100      | A0              |
| 11       | NMI           | 41       | $V_{DDEXT}$ | 71       | PG            | 101      | <del>CS</del>   |
| 12       | RESET         | 42       | $V_{DDINT}$ | 72       | NC            | 102      | ADSCLK          |
| 13       | GND           | 43       | PG8         | 73       | AGND          | 103      | $D_{OUT}B$      |
| 14       | PF10          | 44       | PG9         | 74       | DGND          | 104      | DGND            |
| 15       | $V_{DDEXT}$   | 45       | PG10        | 75       | REF_SELECT    | 105      | $D_OUTA$        |
| 16       | PF11          | 46       | PG11        | 76       | $AV_DD$       | 106      | $V_{DRIVE}$     |
| 17       | GND           | 47       | PG12        | 77       | $D_{CAP}A$    | 107      | $DV_DD$         |
| 18       | PF12          | 48       | PG13        | 78       | AGND          | 108      | GND             |
| 19       | PF13          | 49       | PG14        | 79       | AGND          | 109      | GND             |
| 20       | $V_{DDEXT}$   | 50       | PG15        | 80       | $V_{A1}$      | 110      | CLKIN           |
| 21       | PF14          | 51       | $V_{DDEXT}$ | 81       | $V_{A2}$      | 111      | XTAL            |
| 22       | PF15          | 52       | $V_{DDINT}$ | 82       | AGND          | 112      | $V_{DDEXT}$     |
| 23       | $V_{DDEXT}$   | 53       | $V_{DDINT}$ | 83       | $V_{A3}$      | 113      | PH0             |
| 24       | $V_{DDINT}$   | 54       | SDA         | 84       | $V_{A4}$      | 114      | PH2             |
| 25       | $V_{DDFLASH}$ | 55       | SCL         | 85       | $V_{A5}$      | 115      | PH1             |
| 26       | $V_{DDEXT}$   | 56       | BMODE2      | 86       | $V_{A6}$      | 116      | $V_{DDEXT}$     |
| 27       | PG0           | 57       | BMODE1      | 87       | $V_{B6}$      | 117      | $V_{DDINT}$     |
| 28       | PG1           | 58       | BMODE0      | 88       | $V_{B5}$      | 118      | PF0             |
| 29       | PG2           | 59       | $V_{DDEXT}$ | 89       | $V_{B4}$      | 119      | PF1             |
| 30       | $V_{DDEXT}$   | 60       | NC          | 90       | $V_{B3}$      | 120      | EXTCLK          |
|          |               |          |             |          |               | 121*     | GND             |
|          |               |          |             |          |               | 122**    | AGND            |

<sup>\*</sup> Pin no. 121 is the GND supply (see Figure 89 and Figure 90) for the processor (4.6mm × 6.17mm); this pad **must** connect to GND.

<sup>\*\*</sup> Pin no. 122 is the AGND supply (see Figure 89 and Figure 90) for the ADC (2.81mm × 2.81mm); this pad **must** connect to AGND.

Figure 89 shows the top view of the 120-lead LQFP package lead configuration.

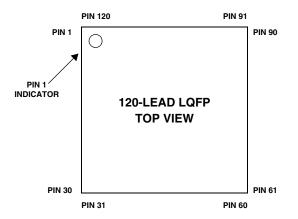


Figure 89. 120-Lead LQFP Package Lead Configuration (Top View)

Figure 90 shows the bottom view of the 120-lead LQFP package lead configuration.

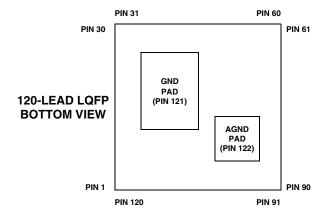


Figure 90. 120-Lead LQFP Package Lead Configuration (Bottom View)

#### 88-LEAD LFCSP LEAD ASSIGNMENT

Table 56 lists the LFCSP leads by signal mnemonic. Table 57 on Page 77 lists the LFCSP by lead number.

Table 56. 88-Lead LFCSP Lead Assignment (Alphabetical by Signal)

| Signal     | Lead No. | Signal | Lead No. | Signal             | Lead No. | Signal        | Lead No.        |
|------------|----------|--------|----------|--------------------|----------|---------------|-----------------|
| BMODE0     | 51       | PF4    | 82       | PG9                | 34       | $V_{DDEXT}$   | 20              |
| BMODE1     | 50       | PF5    | 83       | PG10               | 35       | $V_{DDEXT}$   | 31              |
| BMODE2     | 49       | PF6    | 85       | PG11               | 36       | $V_{DDEXT}$   | 41              |
| CLKIN      | 68       | PF7    | 86       | PG12               | 37       | $V_{DDEXT}$   | 52              |
| <b>EMU</b> | 60       | PF8    | 87       | PG13               | 38       | $V_{DDEXT}$   | 54              |
| EXT_WAKE   | 62       | PF9    | 88       | PG14               | 39       | $V_{DDEXT}$   | 56              |
| EXTCLK     | 78       | PF10   | 4        | PG15               | 40       | $V_{DDEXT}$   | 58              |
| GND        | 3        | PF11   | 6        | PH0                | 71       | $V_{DDEXT}$   | 59              |
| GND        | 7        | PF12   | 8        | PH1                | 72       | $V_{DDEXT}$   | 70              |
| GND        | 67       | PF13   | 9        | PH2                | 73       | $V_{DDEXT}$   | 74              |
| NC         | 45       | PF14   | 11       | RESET              | 2        | $V_{DDEXT}$   | 79              |
| NC         | 46       | PF15   | 12       | SCL                | 44       | $V_{DDEXT}$   | 84              |
| NC         | 47       | PG     | 63       | SDA                | 43       | $V_{DDFLASH}$ | 15              |
| NC         | 48       | PG0    | 17       | TCK                | 24       | $V_{DDFLASH}$ | 55              |
| NC         | 64       | PG1    | 18       | TDI                | 23       | $V_{DDFLASH}$ | 61              |
| NC         | 65       | PG2    | 19       | TDO                | 27       | $V_{DDINT}$   | 14              |
| NC         | 66       | PG3    | 21       | TMS                | 25       | $V_{DDINT}$   | 32              |
| NMI        | 1        | PG4    | 22       | TRST               | 26       | $V_{DDINT}$   | 42              |
| PF0        | 76       | PG5    | 28       | $V_{DDEXT}$        | 5        | $V_{DDINT}$   | 53              |
| PF1        | 77       | PG6    | 29       | $V_{DDEXT}$        | 10       | $V_{DDINT}$   | 57              |
| PF2        | 80       | PG7    | 30       | V <sub>DDEXT</sub> | 13       | $V_{DDINT}$   | 75              |
| PF3        | 81       | PG8    | 33       | V <sub>DDEXT</sub> | 16       | XTAL          | 69              |
|            |          |        |          |                    |          | GND           | 89 <sup>*</sup> |

<sup>\*</sup> Pin no. 89 is the GND supply (see Figure 92) for the processor; this pad must connect to GND.

Table 57. 88-Lead LFCSP Lead Assignment (Numerical by Lead Number)

| Lead No. | Signal        | Lead No. | Signal      | Lead No. | Signal             | Lead No.        | Signal      |
|----------|---------------|----------|-------------|----------|--------------------|-----------------|-------------|
| 1        | NMI           | 23       | TDI         | 45       | NC                 | 67              | GND         |
| 2        | RESET         | 24       | TCK         | 46       | NC                 | 68              | CLKIN       |
| 3        | GND           | 25       | TMS         | 47       | NC                 | 69              | XTAL        |
| 4        | PF10          | 26       | TRST        | 48       | NC                 | 70              | $V_{DDEXT}$ |
| 5        | $V_{DDEXT}$   | 27       | TDO         | 49       | BMODE2             | 71              | PH0         |
| 6        | PF11          | 28       | PG5         | 50       | BMODE1             | 72              | PH1         |
| 7        | GND           | 29       | PG6         | 51       | BMODE0             | 73              | PH2         |
| 8        | PF12          | 30       | PG7         | 52       | $V_{DDEXT}$        | 74              | $V_{DDEXT}$ |
| 9        | PF13          | 31       | $V_{DDEXT}$ | 53       | $V_{\text{DDINT}}$ | 75              | $V_{DDINT}$ |
| 10       | $V_{DDEXT}$   | 32       | $V_{DDINT}$ | 54       | $V_{DDEXT}$        | 76              | PF0         |
| 11       | PF14          | 33       | PG8         | 55       | $V_{DDFLASH}$      | 77              | PF1         |
| 12       | PF15          | 34       | PG9         | 56       | $V_{DDEXT}$        | 78              | EXTCLK      |
| 13       | $V_{DDEXT}$   | 35       | PG10        | 57       | $V_{DDINT}$        | 79              | $V_{DDEXT}$ |
| 14       | $V_{DDINT}$   | 36       | PG11        | 58       | $V_{DDEXT}$        | 80              | PF2         |
| 15       | $V_{DDFLASH}$ | 37       | PG12        | 59       | $V_{DDEXT}$        | 81              | PF3         |
| 16       | $V_{DDEXT}$   | 38       | PG13        | 60       | <b>EMU</b>         | 82              | PF4         |
| 17       | PG0           | 39       | PG14        | 61       | $V_{DDFLASH}$      | 83              | PF5         |
| 18       | PG1           | 40       | PG15        | 62       | EXT_WAKE           | 84              | $V_{DDEXT}$ |
| 19       | PG2           | 41       | $V_{DDEXT}$ | 63       | PG                 | 85              | PF6         |
| 20       | $V_{DDEXT}$   | 42       | $V_{DDINT}$ | 64       | NC                 | 86              | PF7         |
| 21       | PG3           | 43       | SDA         | 65       | NC                 | 87              | PF8         |
| 22       | PG4           | 44       | SCL         | 66       | NC                 | 88              | PF9         |
|          |               |          |             |          |                    | 89 <sup>*</sup> | GND         |

<sup>\*</sup> Pin no. 89 is the GND supply (see Figure 92) for the processor; this pad **must** connect to GND.

Figure 91 shows the top view of the LFCSP pin configuration.

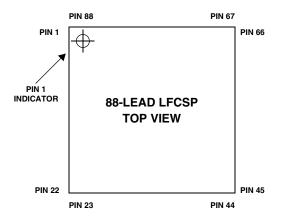


Figure 91. 88-Lead LFCSP Lead Configuration (Top View)

Figure 92 shows the bottom view of the LFCSP lead configuration.

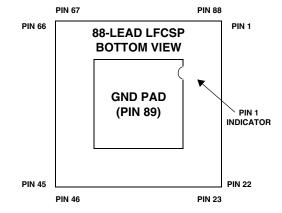


Figure 92. 88-Lead LFCSP Lead Configuration (Bottom View)

#### **OUTLINE DIMENSIONS**

Dimensions in Figure 93 (for the 120-lead LQFP) and in Figure 94 (for the 88-lead LFCSP) are shown in millimeters.

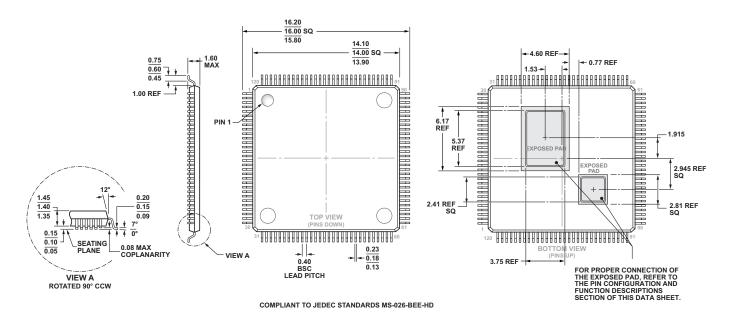
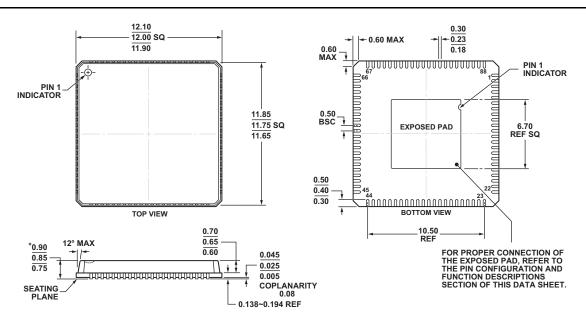


Figure 93. 120-Lead Low Profile Quad Flat Package, Exposed Pad [LQFP\_EP]<sup>1</sup> (SW-120-2)

Dimensions shown in millimeters

<sup>&</sup>lt;sup>1</sup> For information relating to the SW-120-2 package's exposed pad, see the table endnote on Page 74.



\*COMPLIANT TO JEDEC STANDARDS MO-220-VRRD EXCEPT FOR MINIMUM THICKNESS AND LEAD COUNT.

Figure 94. 88-Lead Lead Frame Chip Scale Package [LFCSP\_VQ]<sup>1</sup>
12 x 12 mm Body, Very Thin Quad
(CP-88-5)

Dimensions shown in millimeters

<sup>&</sup>lt;sup>1</sup> For information relating to the CP-88-5 package's exposed pad, see the table endnote on Page 76.

#### **AUTOMOTIVE PRODUCTS**

The ADBF504W model is available with controlled manufacturing to support the quality and reliability requirements of automotive applications. Note that these automotive models may have specifications that differ from the commercial models and designers should review the Specifications section of this

data sheet carefully. Only the automotive grade products shown in Table 58 are available for use in automotive applications. Contact your local ADI account representative for specific product ordering information and to obtain the specific Automotive Reliability reports for these models.

**Table 58. Automotive Products** 

| Automotive Models <sup>1,2</sup> | Temperature<br>Range <sup>3</sup> | Processor Instruction Rate (Maximum) |     | , <b>.</b> .     | Package<br>Option |
|----------------------------------|-----------------------------------|--------------------------------------|-----|------------------|-------------------|
| ADBF504WYCPZ4XX                  | -40°C to +105°C                   | 400 MHz                              | N/A | 88-Lead LFCSP_VQ | CP-88-5           |

 $<sup>^{1}</sup>$  Z = RoHS compliant part.

#### **ORDERING GUIDE**

| Model <sup>1,2</sup> | Temperature<br>Range <sup>3,4</sup> | Processor Instruction Rate (Maximum) | Flash<br>Memory | Package<br>Description | Package<br>Option |
|----------------------|-------------------------------------|--------------------------------------|-----------------|------------------------|-------------------|
| ADSP-BF504BCPZ-3F    | -40°C to +85°C                      | 300 MHz                              | 32M bit         | 88-Lead LFCSP VQ       | CP-88-5           |
| ADSP-BF504BCPZ-4     | -40°C to +85°C                      | 400 MHz                              | N/A             | 88-Lead LFCSP_VQ       | CP-88-5           |
| ADSP-BF504BCPZ-4F    | -40°C to +85°C                      | 400 MHz                              | 32M bit         | 88-Lead LFCSP_VQ       | CP-88-5           |
| ADSP-BF504KCPZ-3F    | 0°C to +70°C                        | 300 MHz                              | 32M bit         | 88-Lead LFCSP_VQ       | CP-88-5           |
| ADSP-BF504KCPZ-4     | 0°C to +70°C                        | 400 MHz                              | N/A             | 88-Lead LFCSP_VQ       | CP-88-5           |
| ADSP-BF504KCPZ-4F    | 0°C to +70°C                        | 400 MHz                              | 32M bit         | 88-Lead LFCSP_VQ       | CP-88-5           |
| ADSP-BF506BSWZ-3F    | -40°C to +85°C                      | 300 MHz                              | 32M bit         | 120-Lead LQFP_EP       | SW-120-2          |
| ADSP-BF506BSWZ-4F    | -40°C to +85°C                      | 400 MHz                              | 32M bit         | 120-Lead LQFP_EP       | SW-120-2          |
| ADSP-BF506KSWZ-3F    | 0°C to +70°C                        | 300 MHz                              | 32M bit         | 120-Lead LQFP_EP       | SW-120-2          |
| ADSP-BF506KSWZ-4F    | 0°C to +70°C                        | 400 MHz                              | 32M bit         | 120-Lead LQFP_EP       | SW-120-2          |

 $<sup>^{1}</sup>Z = RoHS$  compliant part.

<sup>&</sup>lt;sup>2</sup>The use of xx designates silicon revision.

<sup>&</sup>lt;sup>3</sup> Referenced temperature is ambient temperature. The ambient temperature is not a specification. Please see Operating Conditions on Page 26 for junction temperature (T<sub>j</sub>) specification which is the only temperature specification.

<sup>&</sup>lt;sup>2</sup> For feature comparison between ADSP-BF504, ADSP-BF504F, and ADSP-BF506F processors, see the Processor Comparison in Table 1 on Page 3.

<sup>&</sup>lt;sup>3</sup> Referenced temperature is ambient temperature. The ambient temperature is not a specification. Please see Operating Conditions on Page 26 for junction temperature (T<sub>j</sub>) specification which is the only temperature specification.

 $<sup>^4</sup>$ Temperature range  $0^{\circ}$ C to  $+70^{\circ}$ C is classified as commercial, and temperature range  $-40^{\circ}$ C to  $+85^{\circ}$ C is classified as industrial.



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4F ADSP-BF504BCPZ-4 ADSP-BF504KCPZ-4 ADSP-BF504KCPZ-3F ADSP-BF504BCPZ-3F ADSP-BF504BCPZ-4F